

AN ASYNCHRONOUS SYSTEM DESIGN  
AND  
IMPLEMENTATION ON AN FPGA

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## ABSTRACT

### AN ASYNCHRONOUS SYSTEM DESIGN AND IMPLEMENTATION ON AN FPGA

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Field Programmable Gate Arrays (FPGAs) are widely used in prototyping digital circuits. However commercial FPGAs are not very suitable for asynchronous design. Both the architecture of the FPGAs and the synthesis tools are mostly tailored to synchronous design. Therefore potential advantages of the asynchronous circuits could not be observed when they are implemented on commercial FPGAs. This is shown by designing an asynchronous arithmetic logic unit (ALU), implemented in the style of micropipelines, on the Xilinx Virtex XCV300 FPGA family. The hazard characteristics of the target FPGA have been analyzed and a methodology for self-timed asynchronous circuits has been proposed. The design methodology proposes first designing a hazard-free cell set, and then using relationally placed macros (RPMs) to keep the hazard-free behavior, and incremental design technique to combine modules in upper levels without disturbing their timing characteristics. The performance of the asynchronous ALU has been evaluated in terms of the logic slices occupied in the FPGA and data latencies, and a comparison is made with a synchronous ALU designed on the same FPGA.

**Keywords:** Asynchronous, self-timed, micropipeline, FPGA, incremental design

## ÖZ

### FPGA ÜZERİNDE BİR ASENKRON SİSTEM TASARIMI VE YAPIMI

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Alan programlamalı kapı dizinleri (FPGA) sayısal devre prototip tasarımlarında yaygın olarak kullanılmaktadır. Ancak ticari FPGA'ler asenkron tasarım için çok uygun değildir. FPGA'lerin mimari yapıları ve sentez araçları daha çok senkron tasarımlara uygundur. Bu yüzden asenkron devrelerin potansiyel avantajları ticari FPGA'ler üzerinde gerçekleştirildiklerinde görülememektedir. Bu çalışmada mikro ardışık düzen tarzında gerçekleştirilmiş bir asenkron aritmetik ve mantık biriminin (AMB) Xilinx Virtex XCV300 FPGA ailesi üzerinde tasarlanmasıyla gösterilmiştir. Hedef FPGA'in zamanlama karakteristiği incelenmiş ve kendinden zamanlı asenkron devre tasarımı için bir yöntem öne sürülmüştür. Yöntem, ilk olarak zaman-hasarsız bir hücre kümesi tasarlamayı, daha sonra ilişkisel yerleşimli makrolar (RPM) kullanarak zaman-hasarsız özellikleri korumayı, ve artımsal tasarım tekniğiyle modüllerin üst seviyede zamanlama karakteristikleri kaybolmadan birleştirilmesini ileri sürmektedir. Asenkron AMB'nin performansı FPGA içerisinde kapladığı mantık parçaları ve veri gecikmesi bakımından değerlendirilmiş ve aynı FPGA üzerinde gerçekleştirilen senkron bir AMB'yle karşılaştırılmıştır.

**Anahtar Kelimeler:** Asenkron, kendinden-zamanlı, mikro ardışık düzen, FPGA, artımsal tasarım

*To my family, Cem Boran and Asya*

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## LIST OF ABBREVIATIONS

<b>ACK</b>	: Acknowledge
<b>ALU</b>	: Arithmetic Logic Unit
<b>ASIC</b>	: Application Specific Integrated Circuit
<b>CLB</b>	: Configurable Logic Block
<b>EDIF</b>	: Electronic Design Interchange Format
<b>FPGA</b>	: Field Programmable Gate Array
<b>IOB</b>	: Input/Output Block
<b>LC</b>	: Logic Cell
<b>LUT</b>	: Look-up Table
<b>MIC</b>	: Multiple Input Change
<b>PAR</b>	: Place and Route
<b>PCB</b>	: Printed Circuit Board
<b>REQ</b>	: Request
<b>RPM</b>	: Relationally Placed Macro
<b>SIC</b>	: Single Input Change
<b>SOP</b>	: Sum of Products
<b>STG</b>	: State Transition Graph
<b>UCF</b>	: User Constraints File
<b>VHDL</b>	: Very High Speed Integrated Circuit Hardware Description Language
<b>VLSI</b>	: Very Large Scale Integrated Circuit
<b>XST</b>	: Xilinx Synthesis Technology

## CHAPTER 1

### INTRODUCTION

The main points considered in digital circuit design are speed, the space occupied by the circuit, the power consumption, reliability, adaptivity, modularity and finally the cost. Circuit designers have searched for many years whether the synchronous or asynchronous design methodology is more advantageous in fulfilling these requirements.

Asynchronous circuits, in which the synchronization of the system components is done without a global clock, can offer significant advantages over their synchronous counterparts, which can be listed as *elimination of clock skew problems, average case performance instead of worst case performance, adaptivity to processing and different environment variations, component modularity and reuse, lower system power requirements, and reduced noise* [1]. Main disadvantage of the asynchronous circuits, however, is the design complexity. Eliminating hazards, critical races and metastable states [2] in asynchronous circuits is a challenging task, especially in large designs, and hence discourages the designers. The ease of synchronous design attracts the designers also, since the time spent in design process is very crucial in today's industrial competition circumstances. As a result, asynchronous design is not much preferred and the commercial devices and tools for circuit design and simulation environments have been mostly tailored to synchronous circuits. However, the potential advantages of the asynchronous circuits listed above have always kept the interest of many researchers alive, who have been searching for an alternative design technique.

## 1.1. ASYNCHRONOUS DESIGN METHODOLOGIES

Huffman and Muller are two pioneers who have established the base of the asynchronous design methodologies in 1950s [1]. Huffman introduced a design methodology, for what is known today as *fundamental mode* circuits [3], and Muller developed the theoretical basics of the *speed-independent* circuits [4]. Any asynchronous design methodology developed afterwards was inspired from one of these two methodologies [1]. The study of Scott Hauck summarizes *some of the more notable* asynchronous design methodologies [5].

### 1.1.1. BOUNDED DELAY MODELS

In Huffman's methodology the circuits are designed under the *bounded delay model*, that is, it is assumed that the delay in all circuit elements and wires is known [3]. The circuits designed under this model are guaranteed to work regardless of the gate and wire delays as long as the delay bound is known [1]. However, there are some constraints to be met, which are; the input change is not allowed before the circuit reaches stable state, and only single input change at a time is allowed [3].

The method, described by Hollaar [6] is an extension of Huffman circuits to non-fundamental mode [5]. In that method the arrivals of new transitions are allowed to be earlier than that allowed in fundamental mode assumptions.

Another design methodology, referred to as *burst-mode* was developed by Nowick, Yun and Dill [7-10] allows multiple input changes as a burst in any order, but only after the system has completely reacted to the previous input burst [5].

### 1.1.2. DELAY-INSENSITIVE CIRCUITS

Unlike the bounded-delay model, *delay insensitive circuits* are based on *unbounded gate delay model*, that is, delays in both circuit elements and wires are assumed to be unbounded [5]. In this model *completion detection* circuitry is required in order the

receiver to inform the sender that it has received the data properly, since there is no guarantee that a wire will reach its proper value at any specific time due to uncertainty in the delays, and hence a communication protocol (*handshaking*) is established between data sender and receiver.

Martin has developed a design methodology for delay insensitive circuits with only single-output gates [11], which is unsuitable for general circuit design [5].

A methodology, which makes delay insensitive circuit design practical for general computations, has been proposed by Molnar et. al. [12]. This methodology is found upon use of an *I-Net*, a model based on *Petri Nets* [13]. Via I-Net descriptions, delay insensitive modules can be constructed, which eases the design of large systems based on delay insensitivity concept. These modules are designed such that, all timing constraints are encapsulated in them, hence the designer should not deal with hazard problems during circuit construction.

The main power of module-based systems, however, is seen when they are coupled with a high level language and automatic translation software, as described by Brunvand and Sproull [14]. In this approach it is necessary to choose a language to describe asynchronous circuits, and then provide delay-insensitive modules for each of the language constructs.

Another methodology for delay-insensitive circuit design, based on *trace theory*, has been proposed by Ebergen [15, 16], which uses a unified model for both module specification and circuit design.

### **1.1.3. SPEED-INDEPENDENT AND QUASI-DELAY-INSENSITIVE CIRCUITS**

As mentioned earlier speed-independent circuits are associated with D. E. Muller for his pioneering work [4] on this model. This model assumes that *while gate delays are unbounded, all wire delays are negligible (less than the minimum gate delay)* [5]. The quasi-delay insensitive circuits are a subclass of delay-insensitive circuits,

assuming both gate and wire delays are unbounded, augmenting this with *isochronic forks* [17]. Isochronic wires are forking wires, where the delays between the branches of this fork are negligible. The speed-independent and quasi-delay-insensitive circuits are identical for all practical purposes [5].

*Signal transition graphs (STGs)* is a design methodology, introduced by Chu et. al. [18, 19]. Like I-Nets, STGs specify asynchronous circuits with Petri-Nets [13] whose transitions are labeled with signal names.

Change diagrams (CDs) [20] is another methodology similar to STGs, but avoid some of the restrictions found in STGs.

The methodology, named as *communicating process compilation technique* [17], developed by Martin, translates the program written in a language into asynchronous circuits.

#### **1.1.4. MICROPIPELINES**

The *micropipelines* introduced by Sutherland offered an easy and simple way of asynchronous design [21]. This work has brought to Sutherland the Turing Award, and popularized the notion of a modular approach to control, focusing attention on pipeline operations with *transition signaling (2-phase handshaking)*. The methodology explained in Sutherland's study offers the opportunity of building up complex systems by hierarchical composition of smaller and simpler pieces.

#### **1.2. IMPLEMENTING ASYNCHRONOUS CIRCUITS USING FPGAS**

With the improvement in VLSI technology, the designers have found the opportunity to build faster, larger and more complex circuits. Field Programmable Gate Arrays (FPGAs) offer an excellent alternative for rapid and inexpensive development of these kinds of designs. While FPGAs can be directly used in the systems, they can

also be replaced by faster and smaller custom VLSI circuits (ASICs) after prototyping has been completed.

While commercial FPGAs are utilized widely in synchronous designs, they are not very suitable for asynchronous designs [22-25]. There are inconveniences for some of the methodologies listed above in applying them in FPGAs. For example, the speed-independent wire delay assumption is unrealistic in FPGAs, since wire delays can often dominate logic delays. Also, the isochronic fork assumption, which is easier to handle than speed independent wires, may not be handled in FPGAs, since the equal delay between fork branches constraint may not be achieved due to automatic routing. In bounded delay models, the feedback delays are very crucial, but in FPGAs a feedback signal is routed like any other signal and it is difficult to ensure that the feedback is fast enough for a changing element to stabilize before another input arrives. Micropipelines are the most appropriate methodology among the methodologies listed, since the implementation of micropipelines is very similar to clocked systems. In micropipelines the control circuits take the place of global clock for data synchronization. However the basic cell set proposed for control circuits by Sutherland [21], is not directly available in conventional FPGAs, and their design must be done first carefully. Also the delay between communicating modules must be carefully handled for proper operation.

There are two types of approaches to utilize FPGAs in asynchronous circuit design. The first one is developing specific circuit library in commercial FPGAs, and constraining the place and route phase in order to avoid timing problems. And the other one is offering a new type of FPGA architecture, which is suitable for asynchronous design needs.

Brunvand has designed a library of circuit primitives for building *self-timed* (term used for asynchronous circuits in which the synchronization is performed by enforcing a simple communication protocol between circuit elements) circuits and systems using Actel FPGAs [22]. The library modules use two-phase handshaking protocol for control signals and bundled protocol for data signals. Brunvand and Richardson have implemented the prototype of a comprehensive general purpose

processor, named as NSR (Non-synchronous RISC) [32], using Actel FPGAs, assembling the two-phase transition control modules and bundled data modules of the processor from that library. The deficiency of the study is that, hazard behavior of the library modules has not been characterized. Moreover Actel FPGAs are not suitable for prototyping, since they cannot be re-programmed, once programmed, since they are based on anti-fuse architecture.

Maheswaran, in his MS. thesis study, implemented a hazard-free cell set for self-timed circuits, based on the macromodules outlined in [21], in LUT (Look Up Table) based Xilinx FPGAs [23]. He showed that, circuits designed using LUTs are logic-hazard free, but could produce function-hazards for multiple-input changes. He also formulated a set of feedback delay constraints for each of the self-timed elements that are necessary to achieve hazard-free behavior. These constraints must be met when placing and routing these modules for proper operation. Maheswaran also proposed a new FPGA architecture, naming PGA-STG (Programmable Gate Array for Implementing Self-Timed Circuits), which involves a logic block architecture that is capable of satisfying all of the asynchronous necessities. The synthesis tool corresponding to this architecture has been given in this study as well.

Moore and Robinson have proposed a solution for equipotential regions and isochronic forks by combining floor and geometry planning tools [24]. With constraining relative placement of the latches in the module to be designed, they have achieved more predictable routing. They also have tackled the design of a reliable arbiter, which is essential for many self-timed systems, by using the technique they have developed. However, commercial floor planning tools are not sufficient to avoid hazards, and automatic timing-driven FPGA implementation cannot ensure hazard-free logic, although timing constraints are well described [25].

Ho et. al. developed a methodology presenting an alternative to enforce the mapping in FPGAs to avoid hazard [25]. They developed a technique based on the use and design of Muller gate library. Their approach is a combination of using standard FPGAs and the TAST (TIMA Asynchronous Synthesis Tool) [26] developed at TIMA (Techniques of Informatics and Microelectronics for Computer Architecture).

Several FPGA families, like Xilinx X4000, Xilinx Virtex, Altera Flex and Altera Apex have been targeted in this study. They implemented a quasi-delay-insensitive dual rail adder automatically, to demonstrate the potential of the methodology they developed.

The FPGA architectures dedicated to asynchronous circuits are MONTAGE [27], PGA-STG [23], GALSA [28], STACC [29], PAPA [30] and finally the architecture, that has not a special name, developed by Huot et. al.[31]. Unfortunately, none of these architectures have reached the chance to be produced commercially, since the synchronous design is still more popular for designers.

### **1.3. SCOPE OF THE THESIS**

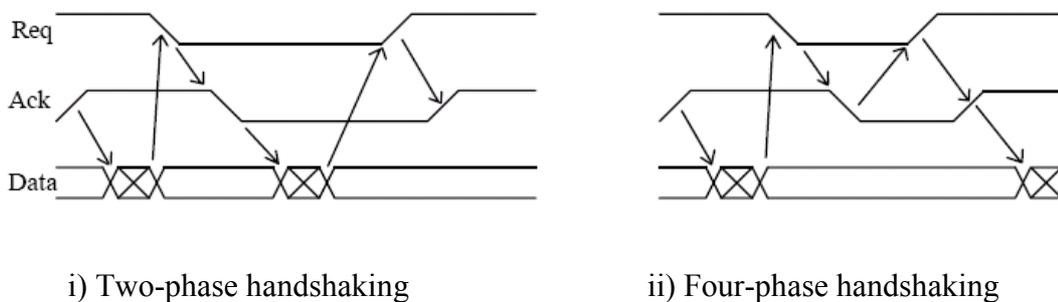
In this thesis, an alternative methodology for implementing self-timed circuits on commercial FPGAs is introduced. The basic asynchronous macromodule set described in Sutherland [21], Brunvand [22] and Maheswaran [23], is re-implemented using Xilinx Virtex XCV300 [33] series FPGAs. An asynchronous ALU (Arithmetic Logic Unit) is constructed using this cell set, in a hierarchical design flow. It is showed how to keep the delay properties of individual modules, when they are instantiated in upper modules. The design is tested under simulation environment (Modelsim) and also a hardware realization is performed on a printed circuit board designed for this purpose.

This thesis consists of six chapters. Chapter 2 gives the principles of the self-timed design and micropipelines, which describe the operation of the circuits constructed in this thesis. In chapter 3 the implementation of the modules is explained in a hierarchical order (from bottom to top). The key points of the design methodology are also given in this chapter. The performance of the implemented modules is evaluated in chapter 4 according to speed and area criteria. A comparison between the asynchronous modules and their synchronous counterparts, implemented in the same FPGA family, is done as well. The details of the printed circuit board are given in chapter 5. Finally in chapter 6 the thesis is concluded and it is discussed what can be done as future work.

## CHAPTER 2

### SELF-TIMED CIRCUITS

Self-timed circuits are asynchronous circuits, in which the data synchronization is done by enforcing a simple communication protocol between circuit elements. Two dominant handshaking protocols are two-phase (transition) and four-phase (level-based) signaling. In two-phase signaling each transition, either rising or falling, on the request (REQ) or acknowledge (ACK) signals represents an event. In four-phase signaling only a positive-going transition on REQ or ACK initiates an event, and each signal must be “restored to zero” before the handshake cycle is completed (Figure 2.1).



i) Two-phase handshaking

ii) Four-phase handshaking

**Figure 2.1** Two-phase and four-phase handshakings

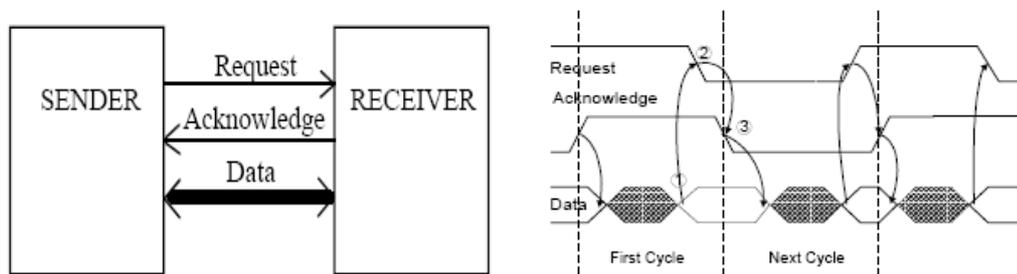
In two-phase handshaking since there is no need to return the control signal to a neutral or low state, transition signaling saves the time and energy costs of the return transitions, as well as design confusion of an unnecessary event [21]. Prosser, Winkel, and Brunvand, who have made a comparison of modular self-timed design styles [33], also showed that two-phase design is faster, easier and more attractive than four-phase.

The coherence of control signals with data signals is also an important point in self-timed circuit design. Data must be valid before the request is done. There are two widely used protocols for data handling:

- i) the dual-rail data convention, in which each data bit is represented by two signals;
- ii) the bundled-data convention, in which each bit is represented by a single signal and delays are inserted in the control paths to assure that data has settled before its use (Figure 2.2).

In the dual-rail convention, a data bit is represented by one of the signal values 00 (meaning invalid data), 01 (bit is a valid 0), and 10 (bit is a valid 1). While this convention has the advantage of providing a definite indication of the status of the bit, its main disadvantage is doubling of the number of signal paths required for each data bit.

In the bundled-data convention, the designer must determine worst-case estimates of each data path for individual bits and groups of bits, and must insert appropriate delays in the handshake control signals to assure that data is stable before a request is asserted (the “bundling constraint”).



i) Bundled Data interface

ii) Bundled Data Convention

**Figure 2.2** Bundled Data Interface and Convention

The bundled data interface is easier to implement and takes less space when compared to dual rail data interface [33].

## 2.1. CONTROL CIRCUITS FOR TRANSITION SIGNALING

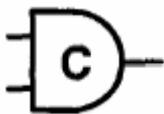
The control circuits for transition signaling are built out of modules that form various combinations of events. Here are the main control units taken from [21]:

XOR:



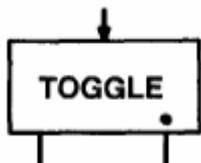
XOR provides the OR function for events. If any one of the inputs changes states then the output also changes states, producing an event.

MULLER-C:



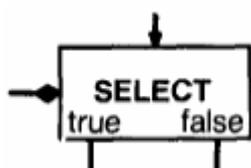
When both inputs of the Muller-C are '0' then the output is also '0', and when both inputs are '1' the output is '1', otherwise the output remains same as previous value. Muller-C elements provide the AND function for events. Assuming initially both inputs are at the same state an event at the output only occurs when both inputs change.

TOGGLE:



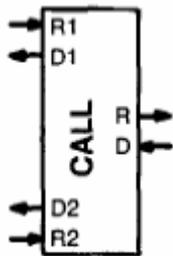
TOGGLE steers events to its outputs alternately starting with the dot. It is used mainly when one event is meaningful for two different purposes, which should occur sequentially.

SELECT:



SELECT steers events according to the Boolean value of its diamond input. It is used when a decision should be made, and according to result different jobs are performed.

CALL:



CALL remembers which client, R1 or R2 called the procedure, R, and after the procedure is done, D, returns a matching done event on D1 or D2. The memory in the CALL element serves the role of subroutine return address.

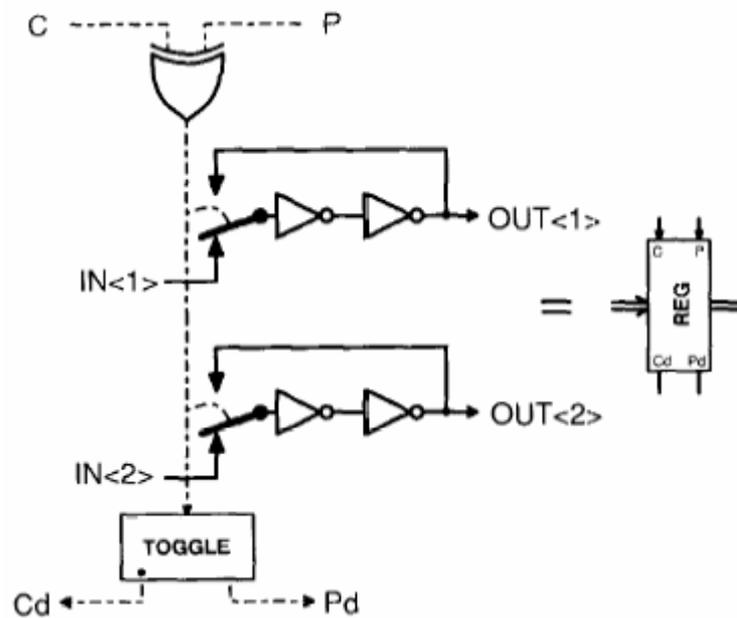
ARBITER:



ARBITER grants service G1 or G2, to only one input request, R1 or R2, at a time, delaying subsequent grants until after the matching event done, D1 or D2.

## 2.2. EVENT-CONTROLLED STORAGE ELEMENT

Sutherland introduced in [21] a storage element suitable for use with a transition signaling control system. An event controlled register made from ordinary latches requires an XOR module and a TOGGLE module for control. A two-bit register is shown in Figure 2.3, taken from [21]. Capture (C) is the event of rising transition in the latch control wire and flips the switch, causing the latches to capture data. Pass (P) is the event of falling transition in the latch control wire and flips the switches back, making the latches transparent again. C and P events arrive alternately at the separate control inputs. XOR merges C and P. The TOGGLE module separates the capture and passes events back into two separate outputs Cd (Capture done) and Pd (Pass done), after the register has done its action.

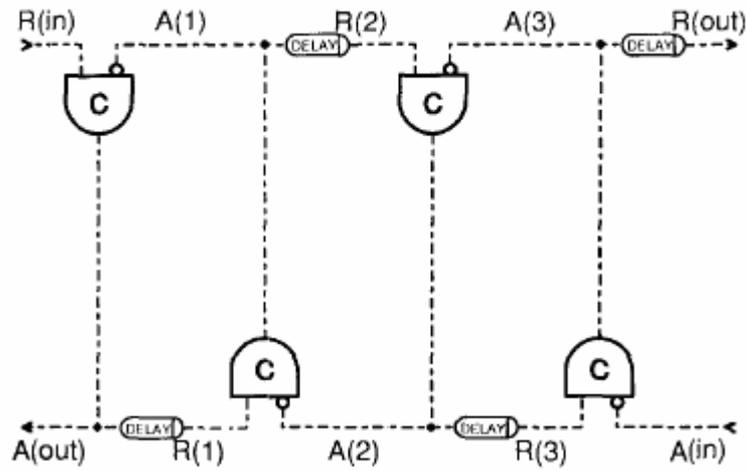


**Figure 2.3** Latches Used as an Event Controlled Storage Register

The implementations of the control circuits and storage element described here are given in chapter 3.

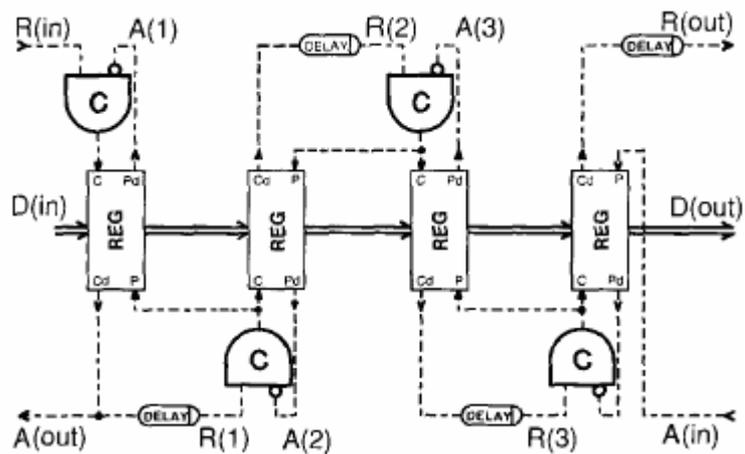
### 2.3. CONSTRUCTION OF MICROPIPELINES

A string of Muller-C elements with inverters inserted between them is the only logic required to control the micropipelines (Figure 2.4) [21]. Request and acknowledge signals pass between adjacent stages, data wires also pass between stages but they are not shown in the figure. For a correct operation all outputs of the Muller Gates must be set to same initial value with the first request signal or a global reset signal.

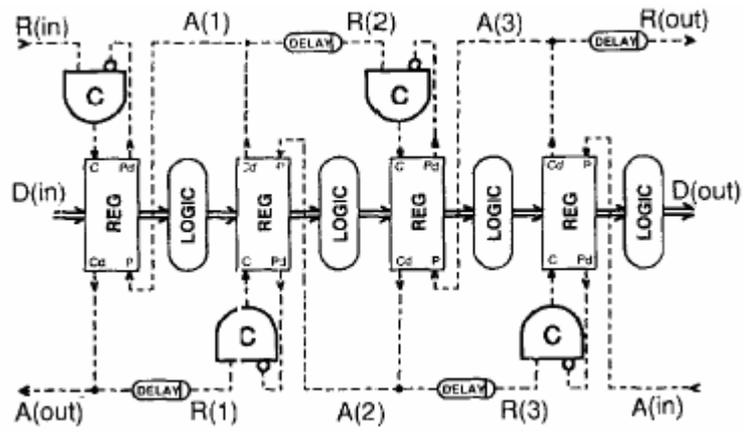


**Figure 2.4** Control Circuit for a Micropipeline

The simplest micropipeline structure can be seen in Figure 2.5. In this configuration there is no processing and it is also simply a FIFO. The length of the FIFO can be increased by adding more basic register blocks. If processing is needed, logic blocks can be inserted between the register blocks (Figure 2.6). In this case the delays between stages must be calculated according to the process time of the combinational logic blocks between the registers.



**Figure 2.5** Micropipeline without Processing



**Figure 2.6** Micropipeline with Processing

## CHAPTER 3

### FPGA IMPLEMENTATION

An asynchronous system must be *hazard-free* for proper operation. Hazard-free asynchronous circuits are assured by implementing them using a hazard-free cell set, which are used according to constraints they enforce on the environment [16, 21, 22, 23, 25]. The design environment in this thesis is Xilinx XCV300 series FPGA which is a member of Xilinx Virtex FPGA family [34].

This chapter consists of 5 sections. Section 3.1 gives a brief background on hazards and hazard elimination techniques. In section 3.2 the characteristics of the target FPGA family are given and it discusses the constraints under which the cell set implemented on this FPGA will be hazard-free. In section 3.3 the basic cell set implemented is presented. In section 3.4 the design of a 4-bit ALU is explained, which is implemented using this cell set. The problems encountered during design process for keeping the hazard-free behavior on the whole system, and how they are handled, are explained in section 3.5.

#### 3.1. HAZARDS AND HAZARD ELIMINATION METHODS

##### 3.1.1. DEFINITIONS

The following definitions are taken from [1].

An incompletely specified Boolean function  $f$  of  $n$  variables  $x_1, x_2, \dots, x_n$  is a mapping:  $f: \{0,1\}^n \rightarrow \{0,1,-\}$ .

Each element  $m$  of  $\{0,1\}^n$  is called a *minterm*.

The *ON-set* of  $f$  is the set of minterms which return 1.

The *OFF-set* of  $f$  is the set of minterms which return 0.

The *don't care (DC)-set* of  $f$  is the set of minterms which return  $-$ .

A *literal* is either the variable,  $x_i$ , or its complement  $x_i'$ . The literal  $x_i$  evaluates to 1 in minterm  $m$  when  $m(i) = 1$ . The literal  $x_i'$  evaluates to 1 when  $m(i) = 0$ .

A *product* is a conjunction (AND) of literals. A product evaluates to 1 for a given minterm if each literal evaluates to 1 in minterm, and the product is said to contain the minterm.

A set of minterms which can be represented with a product is called a *cube*.

The *transition cube* is the smallest cube that contains both  $m_1$  and  $m_2$  where  $m_1$  and  $m_2$  are start and end points of the transition. A transition cube is denoted  $[m_1, m_2]$ .

A product  $Y$  contains another product  $X$  (i.e.,  $X \subseteq Y$ ) if the minterms contained in  $X$  are a subset of those in  $Y$ .

An *implicant* of a function is a product that contains no minterms in the OFF-set of the function.

A *prime implicant* is an implicant which is contained by no other implicant.

A *cover* of a function is a SOP which contains the entire ON-set and none of the OFF-set.

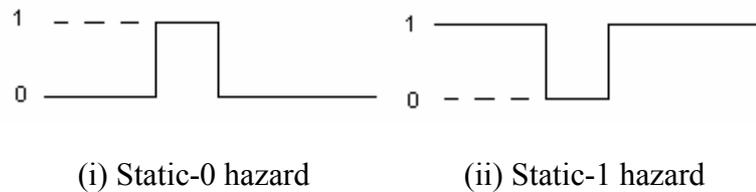
### 3.1.2. HAZARDS

#### 3.1.2.1. COMBINATIONAL HAZARDS

In combinational circuits, due to the relative delay values along various paths, spurious pulses, often termed glitches, may occur after input changes and this situation results in unwanted output waveforms. This behavior is called *combinational hazard* in the design [2]. Combinational hazards are classified as either static or dynamic; depending upon the output is specified to remain constant after the input change.

A circuit has **static-0 hazard** between the adjacent minterms  $m_1$  and  $m_2$  that differ only in  $x_j$  iff  $f(m_1)=f(m_2)=0$ , there is a product term,  $p_i$  in the circuit that includes  $x_j$  and  $x_j'$ , and all other literals in  $p_i$  have value in  $m_1$  and  $m_2$  [35] (Figure 3.1).

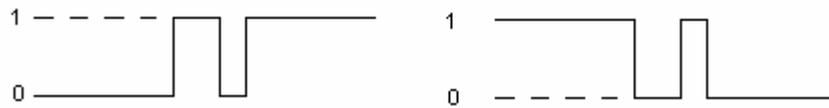
A circuit has **static-1 hazard** between the adjacent minterms  $m_1$  and  $m_2$  where  $f(m_1)=f(m_2)=1$  iff there is no product term that has the value 1 in both  $m_1$  and  $m_2$  [35] (Figure 3.1).



**Figure 3.1** Static hazards

A SOP realization of  $f$  (assuming no product terms with complementary literals) will be free of all static logic hazards iff the realization contains all prime implicants of  $f$ . [36].

A SOP circuit has a **dynamic hazard** between adjacent minterms  $m_1$  and  $m_2$  that differ only in  $x_j$  iff  $f(m_1) \neq f(m_2)$ , the circuit has a product term  $p_i$  that contains  $x_j$  and  $x_j'$ , and all other literals of  $p_i$  have value 1 in  $m_1$  and  $m_2$  [35] (Figure 3.2).



**Figure 3.2** Dynamic hazards

For a multiple-input change (MIC) case, a function  $f$  has **function hazard** during transition from  $m_1$  to  $m_2$  if there exist an  $m_3$  and  $m_4$  such that:

1.  $m_3 \neq m_1$  and  $m_4 \neq m_2$
2.  $m_3 \in [m_1, m_2]$  and  $m_4 \in [m_3, m_2]$
3.  $f(m_1) \neq f(m_3)$  and  $f(m_4) \neq f(m_2)$

If  $f(m_1) = f(m_2)$ , it is a **static function hazard**, and if  $f(m_1) \neq f(m_2)$ , it is a **dynamic function hazard**.

If there is a hazard in the circuit, although it could be implemented without that hazard (i.e., the hazard is *not* a function hazard), then it is the characteristic of the logic design, and is referred to as *logic hazard* [2].

If a Boolean function,  $f$ , contains a function hazard for the input change  $m_1$  to  $m_2$ , it is impossible to construct a logic gate network realizing  $f$  such that the possibility of a hazard pulse occurring for this transmission is eliminated [36].

However, the synthesis method for expanded burst mode (XBM) machines, developed by Yun and Dill [37], never produces a design with a transition that has a function hazard.

### 3.1.2.2. SEQUENTIAL HAZARDS

The violation of the assumption that outputs and state variables stabilize before either new inputs or fed-back state variables arrive at the input to the logic can result in a *sequential hazard*. The presence of a sequential hazard depends on the timing of the environment, circuit and feedback delays.

A flow table has an *essential hazard* if after three changes of some input variable  $x$ , the resulting state is different than the one reached after a single change (Figure 3.3).

	$x$	
	0	1
1	①, 0	2, 0
2	3, 1	②, 0
3	③, 1	k, 1

**Figure 3.3** A flow table with essential hazard

If the resulting malfunction is an output glitch, then it is a *transient essential hazard*. If the system reaches a wrong stable state, then this is a *steady state essential hazard* [2].

Essential hazards can be defeated by fulfilling the *feedback delay requirement*, which can be set conservatively as follows:

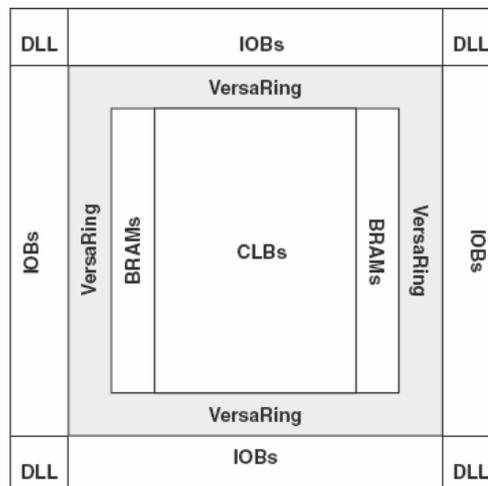
$$D_f \geq d_{\max} - d_{\min}$$

Where  $D_f$  is the feedback delay,  $d_{\max}$  is the maximum delay in the combinational logic, and  $d_{\min}$  is the minimum delay through the combinational logic [1].

Another timing problem in sequential circuits is *critical races*. A race condition occurs when more than one state variables are excited simultaneously and the delays associated with the excited state variables are different. The race is a critical race if the state ultimately reached depends on the outcome of the race [2]. Critical races are considered design defects, and they can always be eliminated by appropriate choices of state assignments [2].

### 3.2. VIRTEX FPGA FAMILY ARCHITECTURE

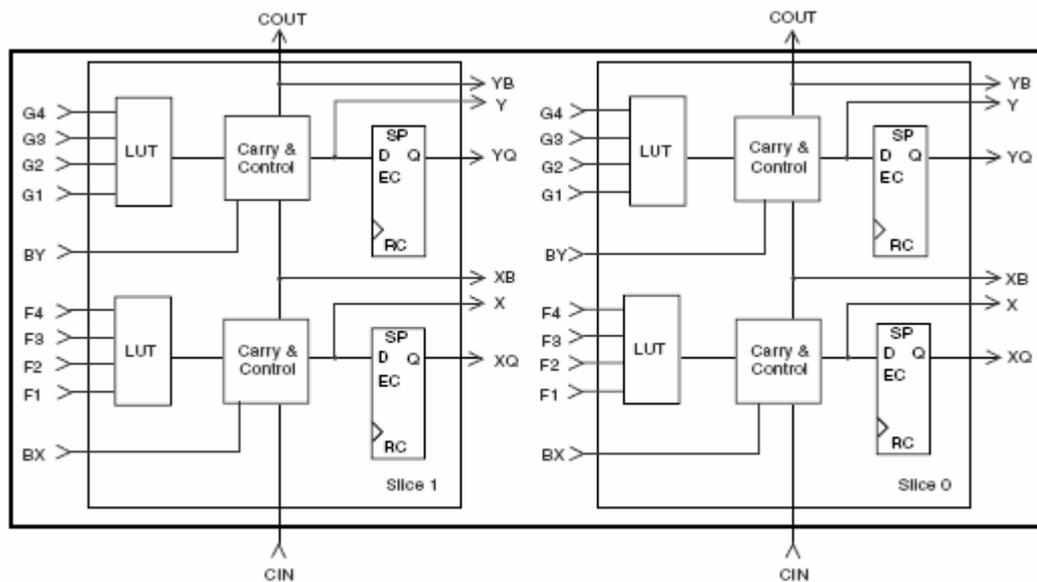
Virtex devices feature a flexible, regular architecture that comprises an array of configurable logic blocks (CLBs) surrounded by programmable input/output blocks (IOBs), all interconnected by a rich hierarchy of fast versatile routing resources (Figure 3.4).



**Figure 3.4** Virtex Architecture Overview

CLBs, which provide the functional elements for constructing logic, interconnect through a general routing matrix (GRM). The GRM comprises an array of routing switches located at the intersections of horizontal and vertical routing channels.

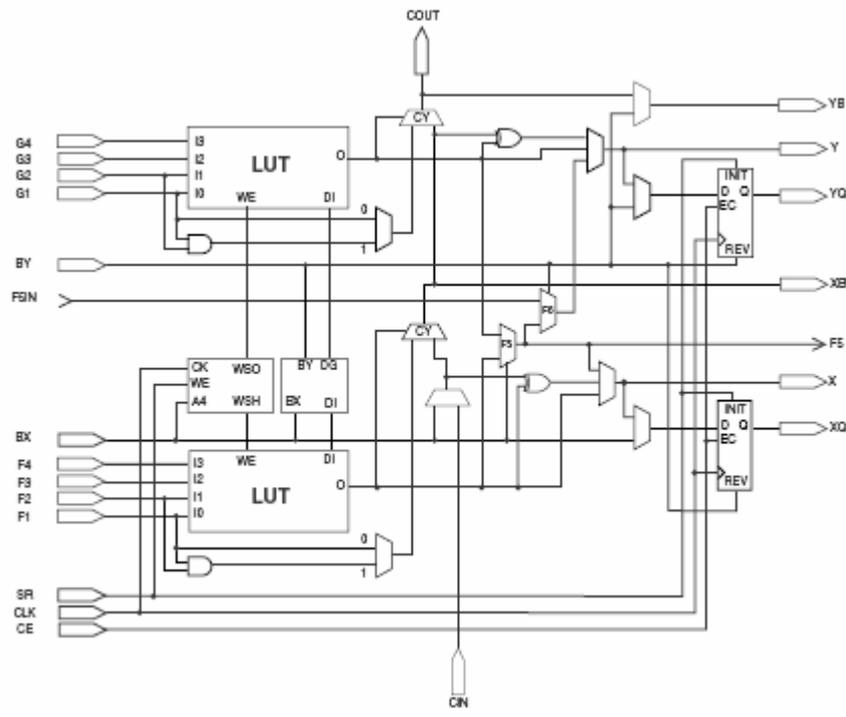
The basic building block of the Virtex CLB is the logic cell (LC). A LC consists of a 4-input function generator, carry logic and a storage element. The output of the function generator in each LC drives both CLB output and D input of the flip-flop. Each Virtex CLB comprises 4 LCs, organized in two similar slices (Figure 3.5). Figure 3.6 shows a more detailed view of a single slice.



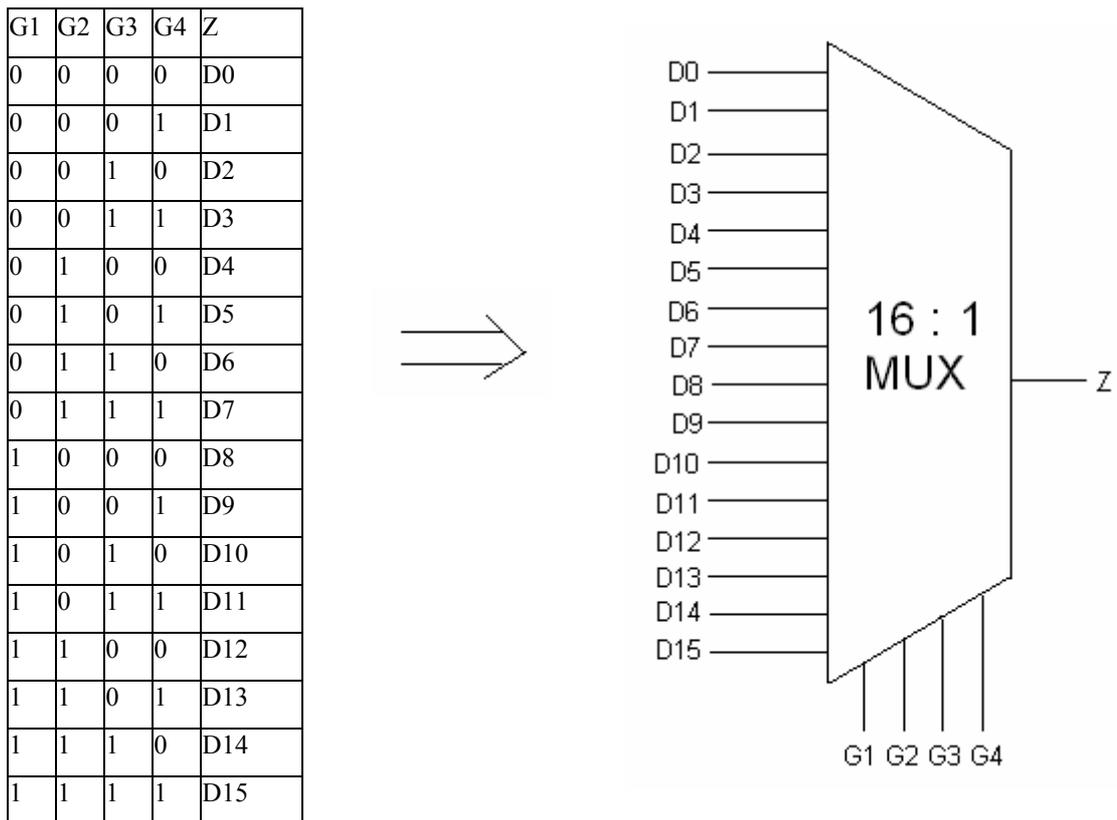
**Figure 3.5** 2-Slice Virtex CLB

Virtex function generators are implemented as 4-input look-up tables (LUTs). An  $n$ -input LUT-based implementation can be modeled as a combination of a memory of  $2^n$  depth, and an  $2^n : 1$  multiplexer (Figure 3.7 shows 4-input LUT case as an example). The content of the memory is the truth table of the function implemented, and the memory content is fed to the data input of the multiplexer, which takes the input of the functions as select inputs to it. Xilinx LUT architecture has a balanced design with almost equal propagation delay from its inputs to its output.

F5 multiplexer in each slice combines the outputs of the function generators. This combination provides either a function generator with 5 inputs, or a 4:1 multiplexer, or selected functions up to 9 inputs. Similarly F6 multiplexer combines the outputs of the F5 multiplexers in a CLB, hence all four outputs of the function generators. As a result a function generator that accepts 6 inputs, or an 8:1 multiplexer or selected functions up to 19 inputs can be implemented in a Virtex CLB.



**Figure 3.6** Detailed view of Virtex slice



**Figure 3.7** LUT-Based Implementation

### 3.2.1. HAZARD BEHAVIOR OF XILINX FPGAS

The hazard elimination methods, which are proposed for gate-level implementations, are not valid for LUT-based implementations. This phenomenon has been investigated comprehensively in Maheswaran’s thesis [23]. The following statements are derived from that study.

If a function  $f$  has a *function hazard* during a transition  $[m_1, m_2]$  and if a set of multiple input changes causes a transition from  $m_1$  to  $m_2$ , then it may produce a glitch at the LUT output. When more than one input changes simultaneously, the presence of any intermediate code that produces a different result may cause a decoding glitch. The glitch might be only a few nanoseconds long, but that is long

enough to upset an asynchronous design, since the delays in the FPGA are pure, not inertial. This can be avoided by using appropriate delay elements, but as there is no user control over the delays inside of a function generator, function hazards cannot be eliminated.

However, a function  $f$  is *logic hazard-free* for any transition for multiple input changes when implemented using a Xilinx LUT. Logic hazards are defined in the absence of function hazards, and therefore the transition should not consist of any intermediate code that produces a different result. Since LUT produces output and holds it steady during transition, the logic hazards are eliminated.

The LUT based asynchronous circuit implementations are *essential hazard-free* as well. The essential hazards are caused by a change in the input reaching different parts of the circuit at different times. These timing problems due to propagation delays are possible in gate-level, but not in LUT-based implementations. In the case of a LUT, a change in the input is detected by the function generator, which implements the entire function at the same time and then the corresponding output is selected from the configuration bits. Therefore, the new output is not feedback until the entire circuit has detected the input change.

According to the findings above, it can safely be said and proven that all functions implemented using a Xilinx LUT are hazard-free for single input changes as well.

The multiplexers in the CLB are also hazard-free, because the select inputs of the multiplexers are hardwired when a function is mapped onto the CLB, which means one of the inputs is transferred to the output, while the other one has no effect on the output. In such a case there cannot be a transition that can produce any kind of hazard.

Since CLB implements any combinational logic in a static, dynamic and essential hazard-free manner, the only effect, which can still cause hazards to occur, is the routing delay. All elements in the cell-set, except XOR, are sequential, and thus have feedback. The feedback has to be available and stable, before new inputs arrive, in

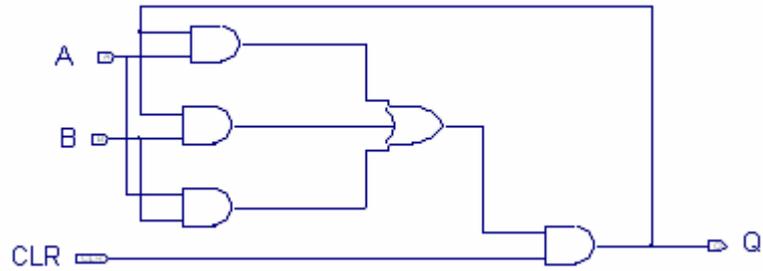
order to preserve the hazard-free behavior. However the inputs are not changed until the output is detected due to input/output mode of behavior, but can be changed immediately after detection. *Therefore the delay in the feedback line has to be less than or equal to the sum of the minimal delay in detecting the output change and producing a new input, and the minimal delay on the input line* [23].

### **3.3. IMPLEMENTED HAZARD-FREE CELL SET**

According to criteria described above, the basic asynchronous macromodule set described in [21] has been implemented on Xilinx Virtex FPGA. The cell-set includes MULLER-C, TOGGLE, SELECT, CALL, and OPAQUE LATCH. As development environment *ISE 6.3* (Xilinx Inc.), and as simulation tool *Modelsim 5.7 SE* (Mentor Graphics) have been utilized. The elements of the cell set have been implemented with default properties of the ISE, the hazard-freeness of the elements has been ensured according to the simulation results trying all possible input configuration and transitions.

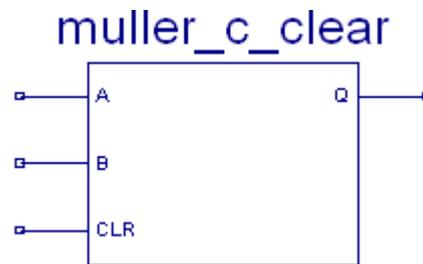
#### **3.3.1. MULLER-C**

Assuming both inputs (A and B) are at same logic level initially, a transition occurs at the Q output only when both inputs change. When both inputs are '1' then the output is also '1', and when both inputs are '0' the output is '0'. In other cases the output remains at previous state. The CLR input is added in order to make determine the initial state of the output. The schematic and truth function can be seen in Figure 3.9. Black box representation of the module is shown also in Figure 3.9.



$$Q = \text{CLR} \cdot (A \cdot Q + B \cdot Q + A \cdot B)$$

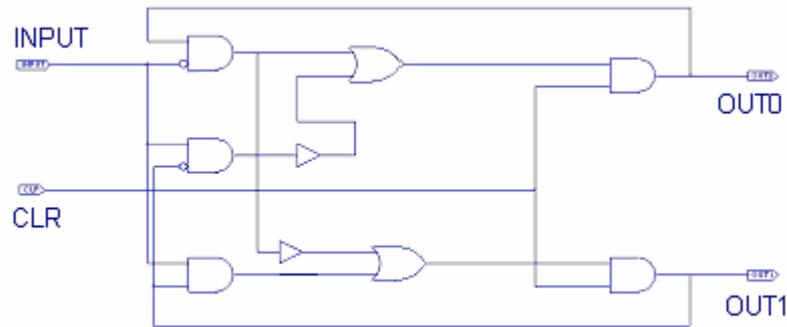
**Figure 3.8** MULLER-C module and its truth function



**Figure 3.9** Black Box Representation of MULLER-C with Clear

### 3.3.2. TOGGLE

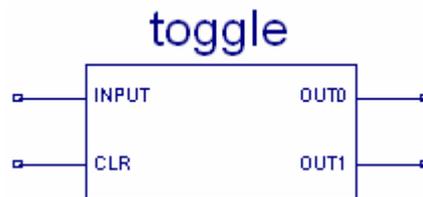
After initialization of the module, the transitions on INPUT cause transitions to occur on OUT0 and OUT1 alternately. If the initial value of INPUT is '1' then the first transition occurs on OUT0. The schematic and truth function can be seen in Figure 3.10. Black box representation of the module is shown also in Figure 3.11.



$$OUT0 = CLR.(INPUT'.OUT0 + INPUT.OUT1')$$

$$OUT1 = CLR.(INPUT'.OUT0 + INPUT.OUT1)$$

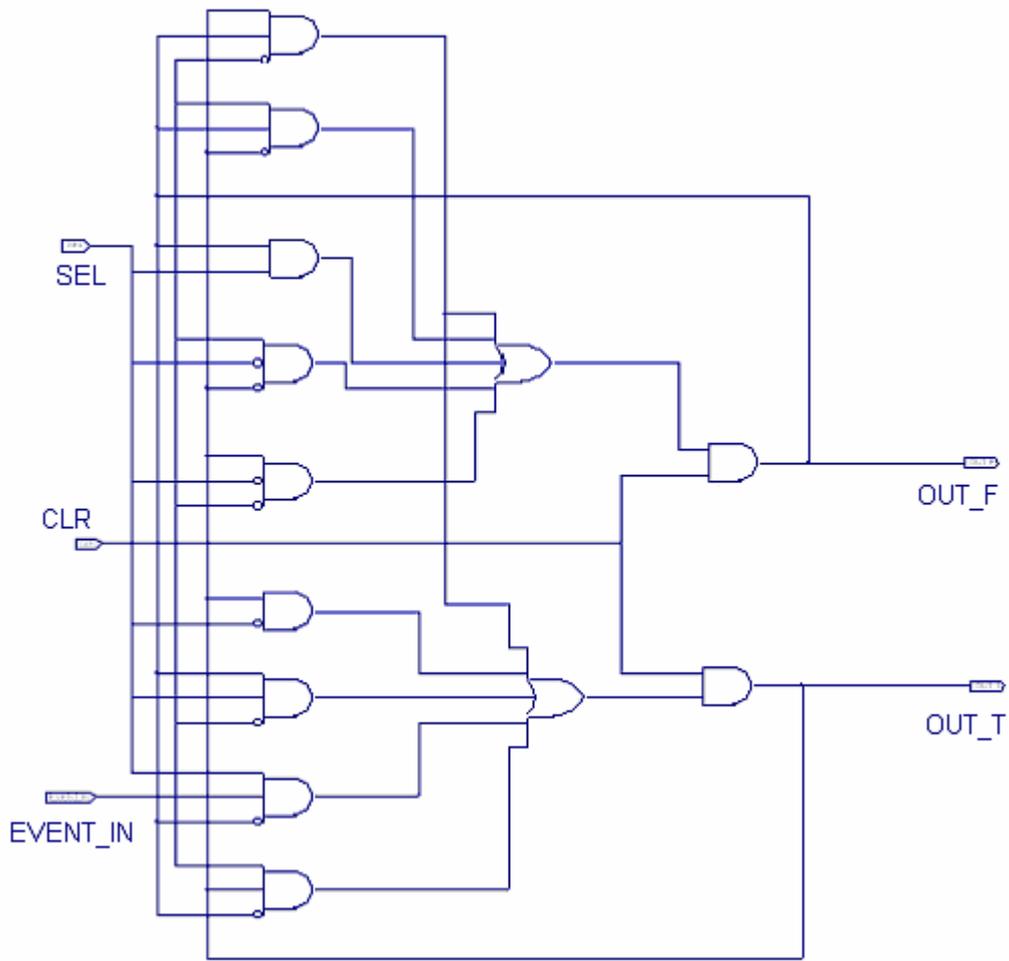
**Figure 3.10** TOGGLE module and its truth function



**Figure 3.11** Black Box Representation of TOGGLE Module

### 3.3.3. SELECT

According to SEL input, the transitions on EVENT\_IN result in a transition on either OUT\_T or OUT\_F. If SEL is '1' then the transition occurs on OUT\_T, and if SEL is '0' the transition occurs on OUT\_F. CLR input is used for initialization purposes. The schematic and truth function can be seen in Figure 3.12. Black box representation of the module is shown also in Figure 3.13.



$$OUT\_F = CLR \cdot (EVENT\_IN' \cdot OUT\_T \cdot OUT\_F + EVENT\_IN \cdot OUT\_F \cdot OUT\_T' + SEL \cdot OUT\_F + EVENT\_IN \cdot SEL' \cdot OUT\_T')$$

$$OUT\_T = CLR \cdot (EVENT\_IN' \cdot OUT\_T \cdot OUT\_F + OUT\_T \cdot SEL' + OUT\_F \cdot SEL \cdot EVENT\_IN' + SEL \cdot EVENT\_IN \cdot OUT\_F' + EVENT\_IN \cdot OUT\_T \cdot OUT\_F')$$

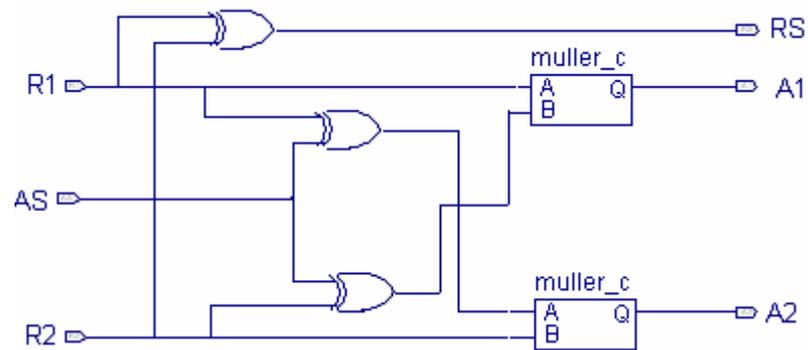
**Figure 3.12** SELECT module and its truth function



**Figure 3.13** Black Box representation of SELECT Element

### 3.3.4. CALL

CALL is used when there are two modules sharing one resource. It acts like a switch between the client, who makes the request, and the shared resource. RS and AS are request and acknowledge ports of the shared module, respectively. If there is an event on R1 or R2 it is routed to RS, and the AS is routed back to A1 or A2, in correspondence with which request has been done. The schematic and truth function can be seen in Figure 3.14. Black box representation of the module is shown also in Figure 3.15.

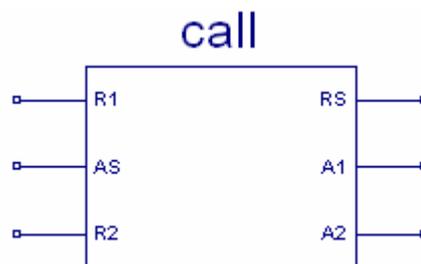


$$RS = R1 \oplus R2$$

$$A1 = ((A1.(R2 \oplus AS) + A1.R1 + R1.(R2 \oplus AS))$$

$$A2 = ((A2.(R1 \oplus AS) + A2.R2 + R2.(R1 \oplus AS))$$

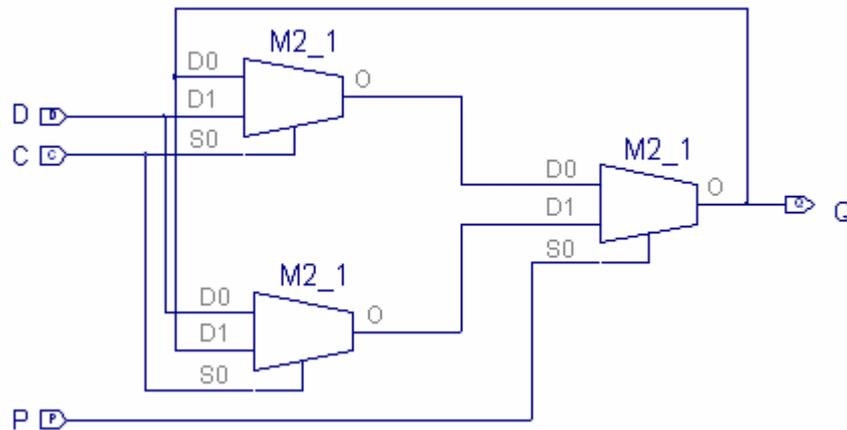
**Figure 3.14** CALL module and its truth function



**Figure 3.15** Black Box Representation of CALL element

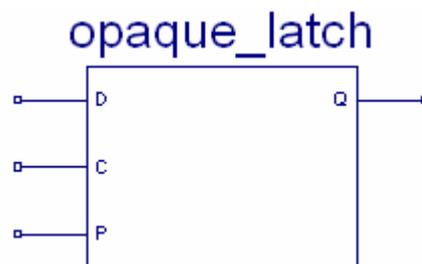
### 3.3.5. OPAQUE LATCH

This module is used for data latching. When C (capture) and P (Pass) are at the same logic level, the output Q is preserved. When they are at different logic levels, the data input D is transferred to the output. Assuming both C and P are at the same logic level initially, consecutive transition on C and P will cause the data to be captured and preserved until next transition on C. The schematic and truth function can be seen in Figure 3.16. Black box representation of the module is shown also in Figure 3.17.



$$Q = (P.(C.Q + C'D) + P'.(C.D + C'.Q))$$

**Figure 3.16** OPAQUE LATCH module and its truth function



**Figure 3.17** Black Box Representation of OPAQUE LATCH Element

### **3.4. FOUR-BIT ASYNCHRONOUS ALU**

A four-bit asynchronous ALU has been constructed, in order to demonstrate how transition signaling and bundled data protocol are handled when designing a self-timed system on an FPGA.

The ALU comprises the following units:

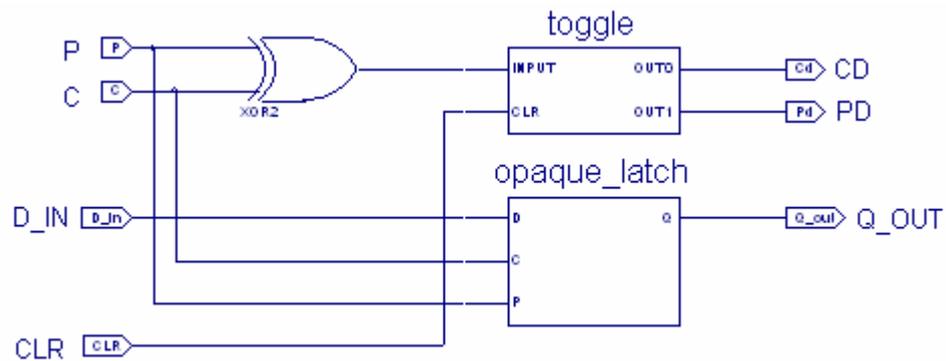
- 4-bit AND
- 4-bit OR
- 4-bit COMPLEMENT
- 4-bit LOADABLE SHIFT REGISTERS
- 4-bit ADDER/SUBTRACTOR
- 4-bit MULTIPLIER
- 8-bit by 4-bit DIVIDER
- additional logic for CONTROL purposes.

When implementing these units a hierarchical design flow has been followed. In the following sections the modules designed in this thesis are explained in an order somehow increasing complexity.

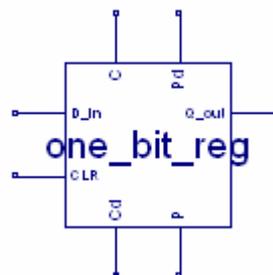
#### **3.4.1. ONE-BIT REGISTER**

It performs the function of event controlled storage element described in chapter 2. When data is available at the input an event (transition) on C (capture) input causes the latch to be transparent, i.e., the data passes to the output. The event, which occurs on P (pass) after the transition on C, causes the data to be stored. The latch is closed to new inputs until a transition occurs again on C. The acknowledgements of C and P events are produced through a TOGGLE element. XOR element in front of the TOGGLE transfers the transition on whichever of its inputs. Since the first transition occurs always on C, the OUT0 output of the TOGGLE produces CD (capture done) and the OUT1 output produces PD (pass done), which is the acknowledgement of second transition. In the applications the CD output is directly connected to P input,

building a self-control mechanism for storing data after capture as quickly as possible. The circuit diagram and black box representation of one-bit register can be seen in Figure 3.18 and Figure 3.19 respectively.



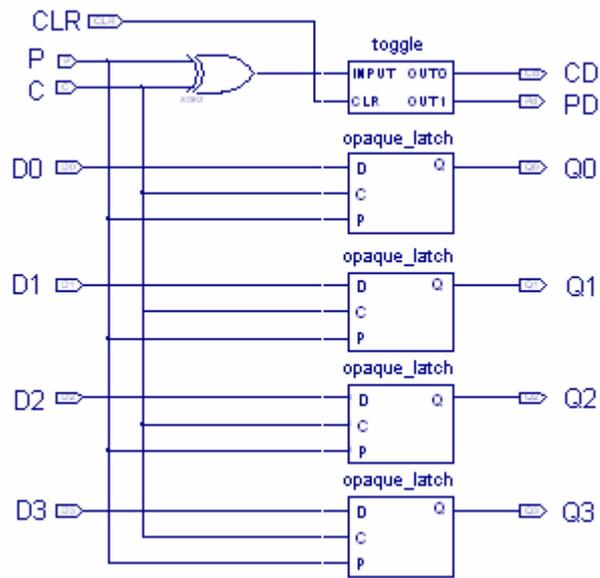
**Figure 3.18** Circuit diagram of one-bit register



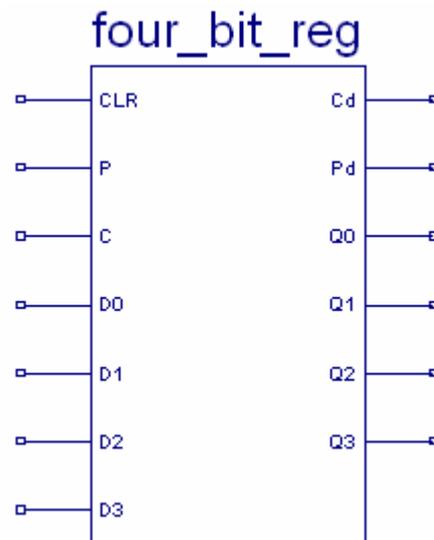
**Figure 3.19** Black Box Representation of one-bit register

### 3.4.2. FOUR-BIT REGISTER

Four-bit register is constructed by simply combining four latches, with the control circuitry the same as in one-bit register. The circuit diagram and black box representation of four-bit register can be seen in Figure 3.20 and Figure 3.21 respectively.



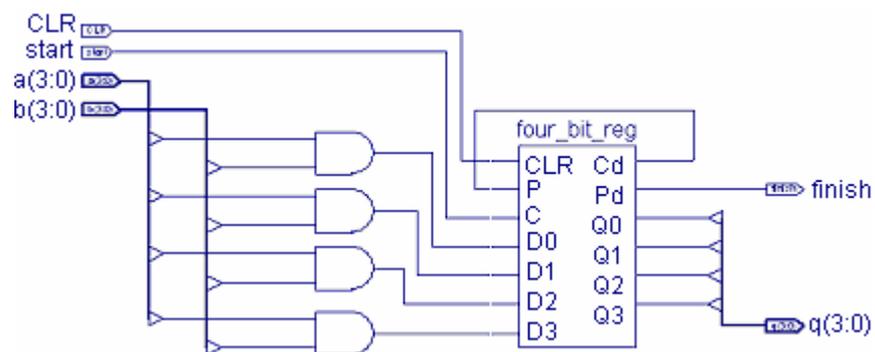
**Figure 3.20** Circuit diagram of four-bit register



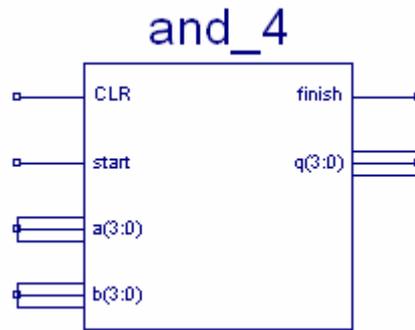
**Figure 3.21** Black Box Representation of four-bit register

### 3.4.3. FOUR-BIT AND

This module performs logical AND of two four-bit inputs. The inputs are ANDed combinatorial and the output of AND gates are registered using a four-bit register. A transition on *start* input is the request for the module, after the data has been available at the inputs. The *start* signal is connected to the *capture (C)* input of the four-bit register. The acknowledge of the capture (Cd) is directly connected to the *pass (P)* input of the register. Hence one transition is sufficient for both capturing and passing the data. By the way there is no need to insert a delay element on the request signal paths, since the transition on AND gates lasts less than the capture acknowledgement generation. The final acknowledgement (Pd) indicates the end of operation, and data is available at the output. The schematic and black box representation of the four-bit AND is shown in Figure 3.22 and Figure 3.23 respectively.



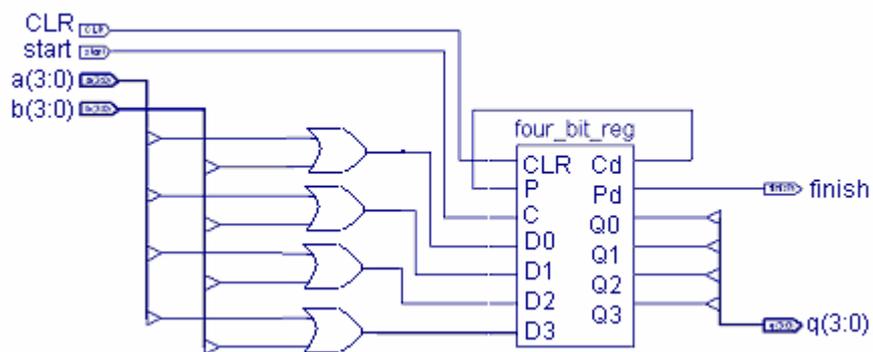
**Figure 3.22** Circuit Diagram of four-bit AND



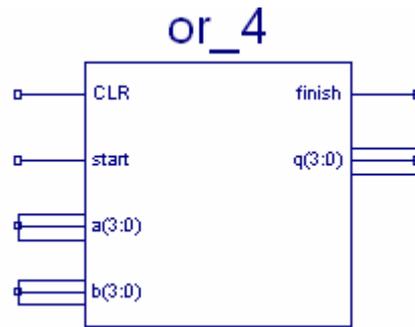
**Figure 3.23** Black Box Representation of four-bit AND

### 3.4.4. FOUR-BIT OR

This module is constructed similar to four-bit AND module except, OR gates are used instead of AND gates. The schematic and black box representation of four-bit OR is shown in Figure 3.24 and Figure 3.25 respectively.



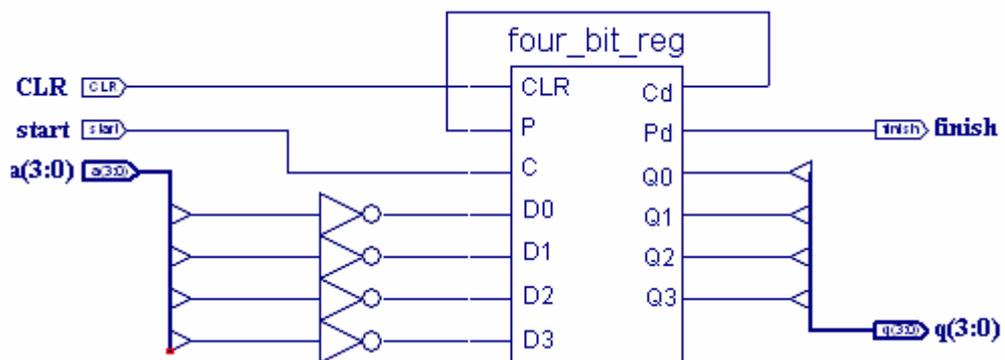
**Figure 3.24** Circuit diagram of four-bit OR



**Figure 3.25** Black Box Representation of four-bit OR

### 3.4.5. FOUR-BIT COMPLEMENT

The concept of this module is not very different than AND and OR modules. The four-bit input is inverted using NOT gates and then the output is registered. The control signals are the same as those in AND and OR modules. The schematic and black box representation of four-bit COMPLEMENT is shown in Figure 3.26 and Figure 3.27 respectively.



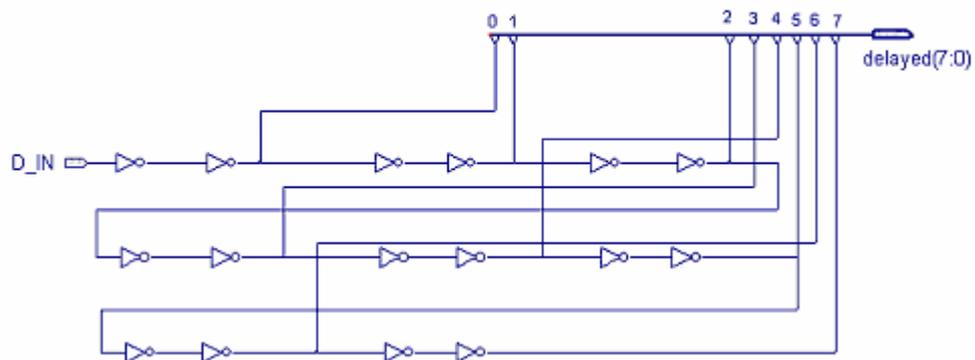
**Figure 3.26** Circuit Diagram of four-bit COMPLEMENT



**Figure 3.27** Black Box Representation of four-bit COMPLEMENT

### 3.4.6. PROGRAMMABLE DELAY ELEMENT (PDE)

It is designed to use for delaying the control signal between processing units, in order to implement bundled-data protocol. This module is simply serially connected inverter chain. Each second inverter's output is taken out of the module. There are totally 16 inverters, hence 8 outputs, with an increasing delay. The programmability comes from the selection option of one out of 8 different delayed versions of the input signal. The circuit diagram and black box representation of PDE are as follows shown in Figure 3.28 and Figure 3.29 respectively.



**Figure 3.28** Circuit diagram of PDE



**Figure 3.29** Black Box Representation of PDE

### 3.4.7. LOADABLE SHIFT REGISTER

The shift register is one of the basic modules of multiplier and divider. It is also used stand alone as an ALU function. In this thesis two different shift register designs have been implemented.

The first one is similar to conventional synchronous shift register. Four one bit registers are connected serially, connecting the output and input of the neighboring registers to each other. While the idea of the synchronous register is to apply a global clock to all the registers and let the data progress in parallel, for an asynchronous shift register, this is no longer the case since there is no such a global clock. The registers cannot be triggered concurrently, since when they are made transparent to data, there is no guarantee for only single bit transfer between them. Until they are closed to data transfer with the second transition on their P input, there may occur more than one data shift operations. The synchronization is achieved by making neighboring stages communicate with each other. The rightmost register gets the output of the register left of it and then acknowledges this operation; this is also a request for the register left of it. The same procedure is repeated by all other registers. Finally when the leftmost register acknowledges the transfer operation, the shift process is done.

This shift register can also be loaded with a new data. Load operation has to be differentiated from shift operation. However because of the serial connection of the registers load operation is also achieved like a shift operation, with a difference; the registers did not acquire the output of the previous register, but the load input, sequentially. For the input differentiation of the registers for load and shift operation

a 2:1 multiplexer is put in front of each register. One input of the multiplexer is the output of the previous register, and the other is the loadable bit. For the select input of the multiplexers a specific module has been designed, which produces a “1” output for load transitions, and a “0” output for shift operations (the design of this module, named as *my\_module\_hf*, is described in the next section). The output of this module is used as the select input of the multiplexer. Before shift or load operation starts the inputs to the registers must be available. Therefore a delay element is put in front of the first registers request input, so that the necessary time is given for the settlements of both select input and hence the data. The acknowledgements of shift and load operations are also differentiated, using a SELECT element. The *select* input of this module is the same as the select input of the multiplexers, and the *event* input is the acknowledgement signal of the last register. If the most significant bit (MSB) of the input data is connected to the leftmost register, this is a *shift right* register; and if the MSB of the input data is connected to the rightmost register, then this is a *shift left* register. The schematic and black box representations of this type of shift register are shown in Figure and Figure 3.31 respectively.

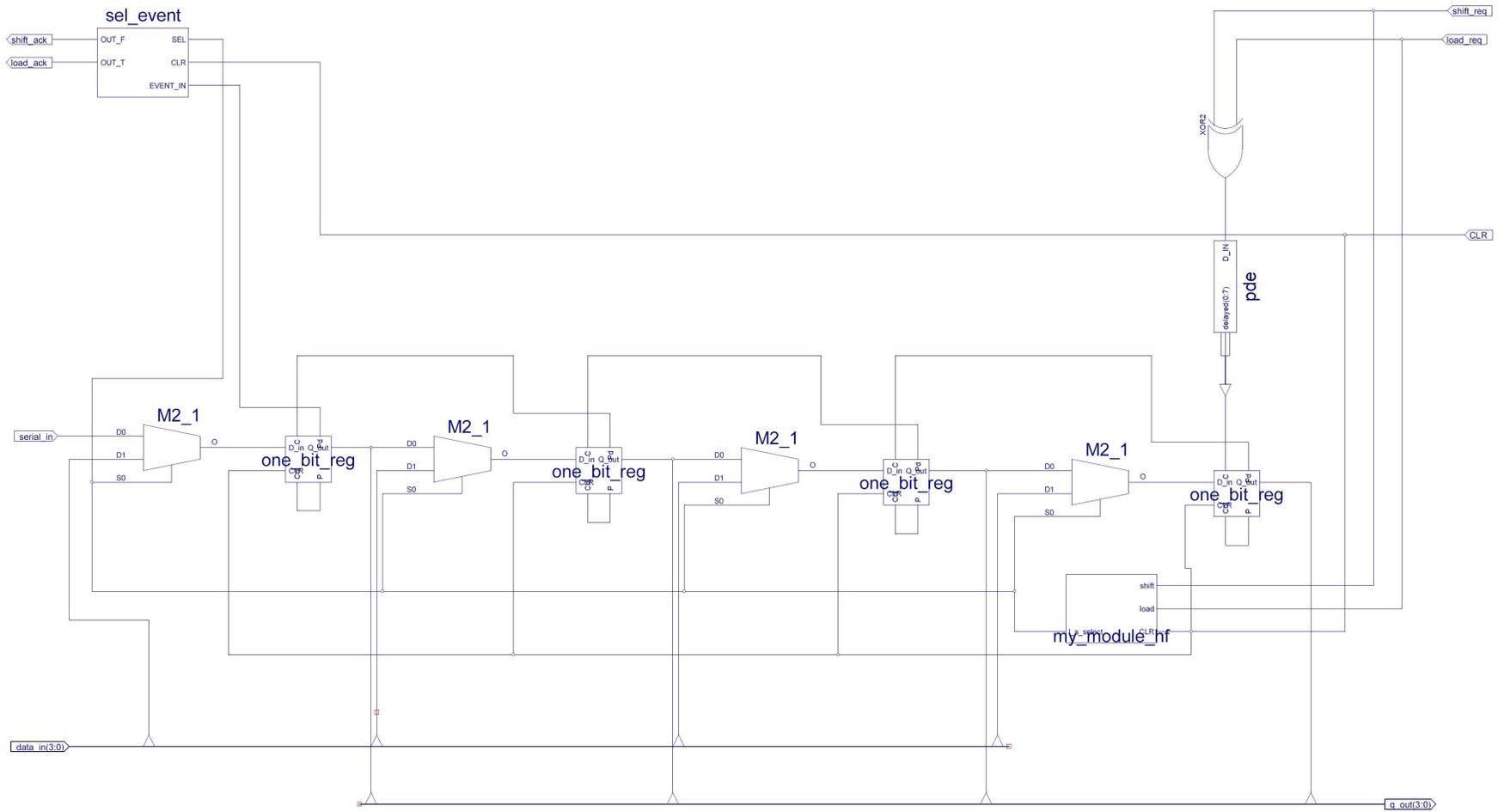
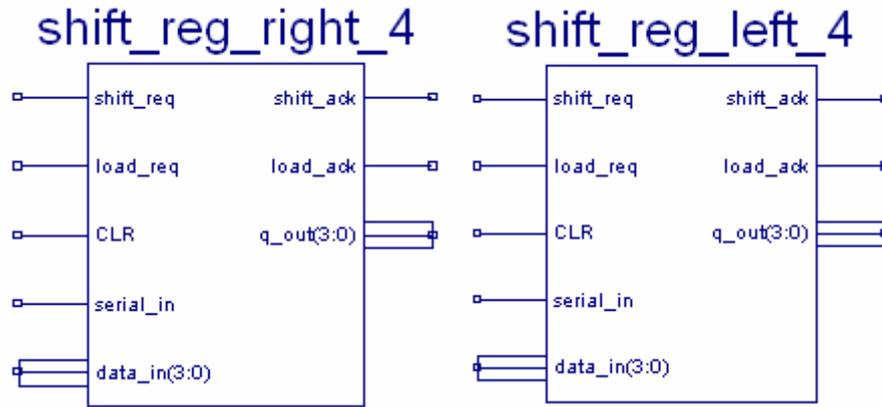


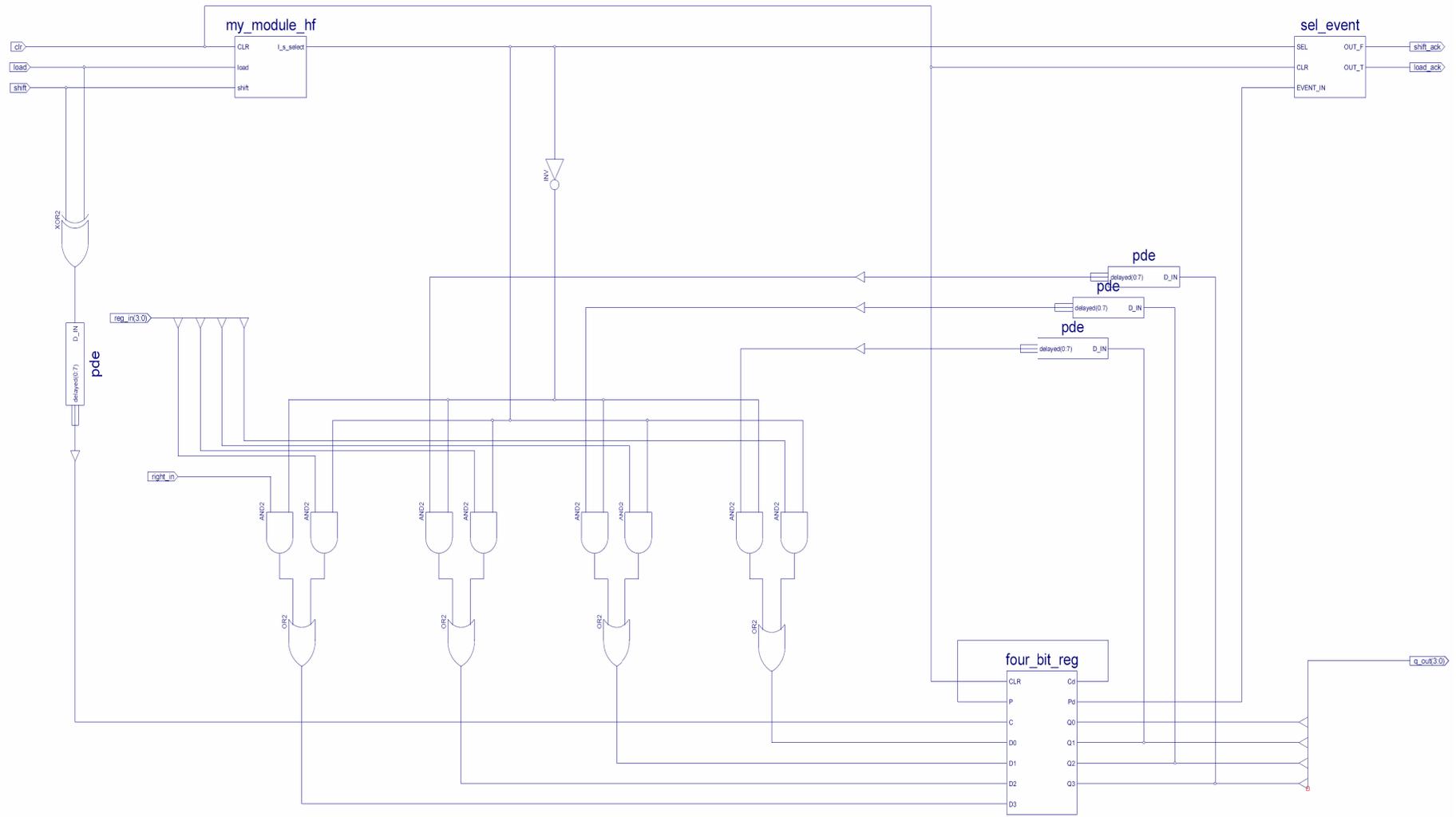
Figure 3.30 Circuit diagram of loadable shift register (type 1)



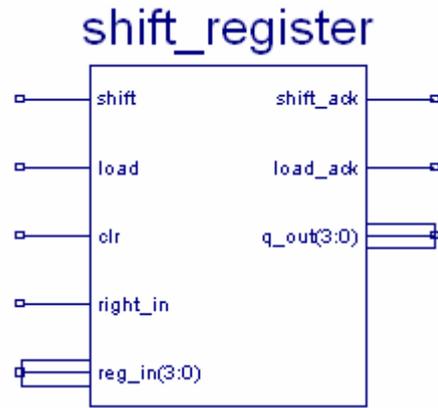
**Figure 3.31** Black Box Representations of loadable shift register (type 1)

The shift register introduced above has a major drawback, *latency*. This latency arises from the propagation delays of acknowledge signals through the blocks of registers. As the size of the shift register increases the latency will increase as well. Moreover, load operation is done like shift operation, exposed to same latency problem as shift operation. The second type design proposes a solution to the latency problem.

In the second type of design the load and shift operations are performed parallel, hence the time spent on any operation does not depend on the register length. The selection of the operation (load or shift), and acknowledgement generation is done like in the previous type of design. The data, which will be loaded to the registers according to the selected operation, are also differentiated using 2:1 multiplexers (multiplexers have been implemented explicitly). The difference is on the connections of the data bits, which will be loaded to the registers in the shift operation. The output of the 4-bit register is fed-back to the input. However the problem of assuring only single bit shift at one step is still valid, therefore delay elements are inserted on the feedback lines. The delay value must be greater than the time between the registers being transparent to data and closed again. Hence the communication burden between the neighboring stages is eliminated on the cost of extra delay elements (Figure 3.3 and Figure 3.33). According to simulation results, which will be given detailed in chapter 5, about two times improvement in latency has been achieved with this type of design.



**Figure 3.32** Circuit diagram of loadable shift register (type 2)



**Figure 3.33** Black Box Representation of loadable shift register (type 2)

### 3.4.8. MY\_MODULE\_HF

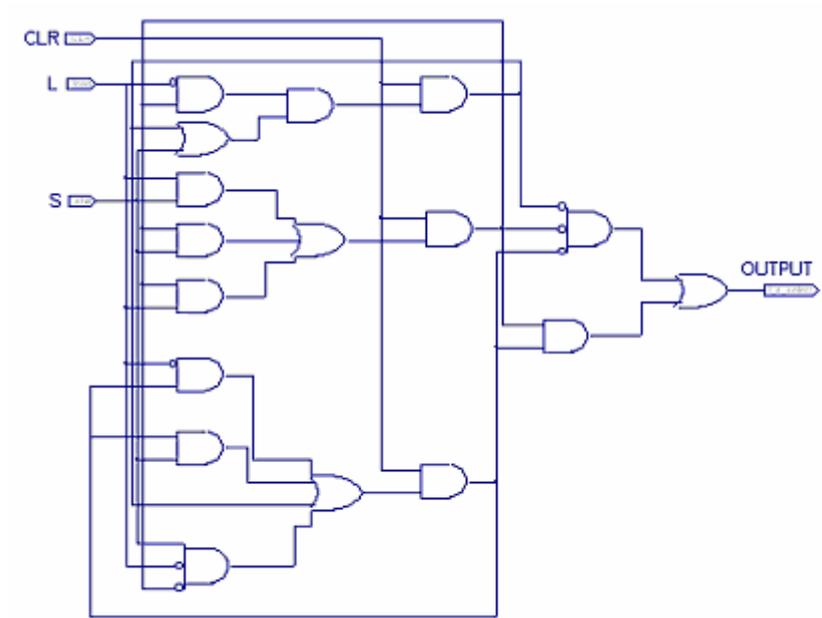
The purpose of this module is to differentiate between two transitions, and produce an output indicating at which of the inputs a transition has occurred. If there is a transition on L input, then a '1' is produced at the output. If there is a transition on S input then a '0' is produced at the output. Actually this element could be added to the basic cell set as well, since it can be used in many applications. For example, in this thesis it is used not only in shift registers, but also used in multiplier, divider and adder/subtractor modules.

Great attention has been given for the design to be hazard-free. The state assignments (Table 3.1) and output function implementations have been done according to fundamental-mode assumptions and the criteria explained above. The adjacent states in the flow table are encoded such that only one bit changes during transitions. The last two rows have been added in order to ensure race-free transition. Also the output function is constructed as a logic covering all prime-implicants (Figure 3.34 and Figure 3.35). The CLR input, which is not shown in flow table, is used for initialization purpose only, and when it is '0', the circuit gives a '1' output regardless of the other inputs.

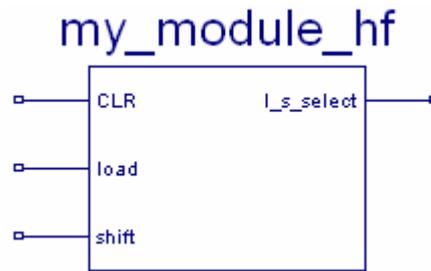
**Table 3.1** State transition table of my\_module\_hf

PS	NS				OUTPUT
	LS	LS	LS	LS	
	00	01	11	10	
000	000	001	010	000	1
001	001	001	011	000	0
010	000	110	010	010	0
011	-	111	011	010	1
111	101	111	011	-	1
101	001	-	-	-	-
110	-	111	-	-	-

PS: Present State      NS:Next State



**Figure 3.34** Circuit diagram of my\_module\_hf



**Figure 3.35** Black Box Representation of my\_module\_hf

### 3.4.9. ADDER/SUBTRACTER

This module is used for addition and subtraction. For both operations it uses basically a conventional adder. For addition, the operands are taken as they are and carry-in of the adder is set to '0'. For subtraction 1's complement of the second operand (here minuend) is taken, and carry-in input is set to '1', so subtrahend is added with the 2's complement of the minuend. Therefore for second input and carry-in input of the adder multiplexers are used. The select inputs of these multiplexers are produced by again my\_module\_hf modules like in the shift registers. Similarly request signals are delayed, so that the necessary time is given for the settlements of both select input and hence the data. The data input are registered before addition/subtraction operation is performed, in order to eliminate false outputs, which can be produced due to changes in the input data during addition/subtraction process. The acknowledgements of the input registers are ANDed via a MULLER-C element. The output of this MULLER-C element is used as request input for the sum and carry-out registers. Again a delay element is inserted between the MULLER-C output and register request inputs, in order to wait the sum and carry-out outputs of the adder to be available. The value of the delay inserted has to be greater than the process time of the adder, which is a combinational logic.

For two different request signals (*add* and *sub*) two different acknowledgement signals (*add\_done*, *sub\_done*) are produced as well. This is accomplished by using a SELECT module whose *select* input is the output of my\_module\_hf and *event* input

is the ANDed (via MULLER-C) acknowledgement signals of the output registers. Figure 3.36 shows the schematic of the ADD/SUB module and Figure 3.37 shows the black box representation of this module.

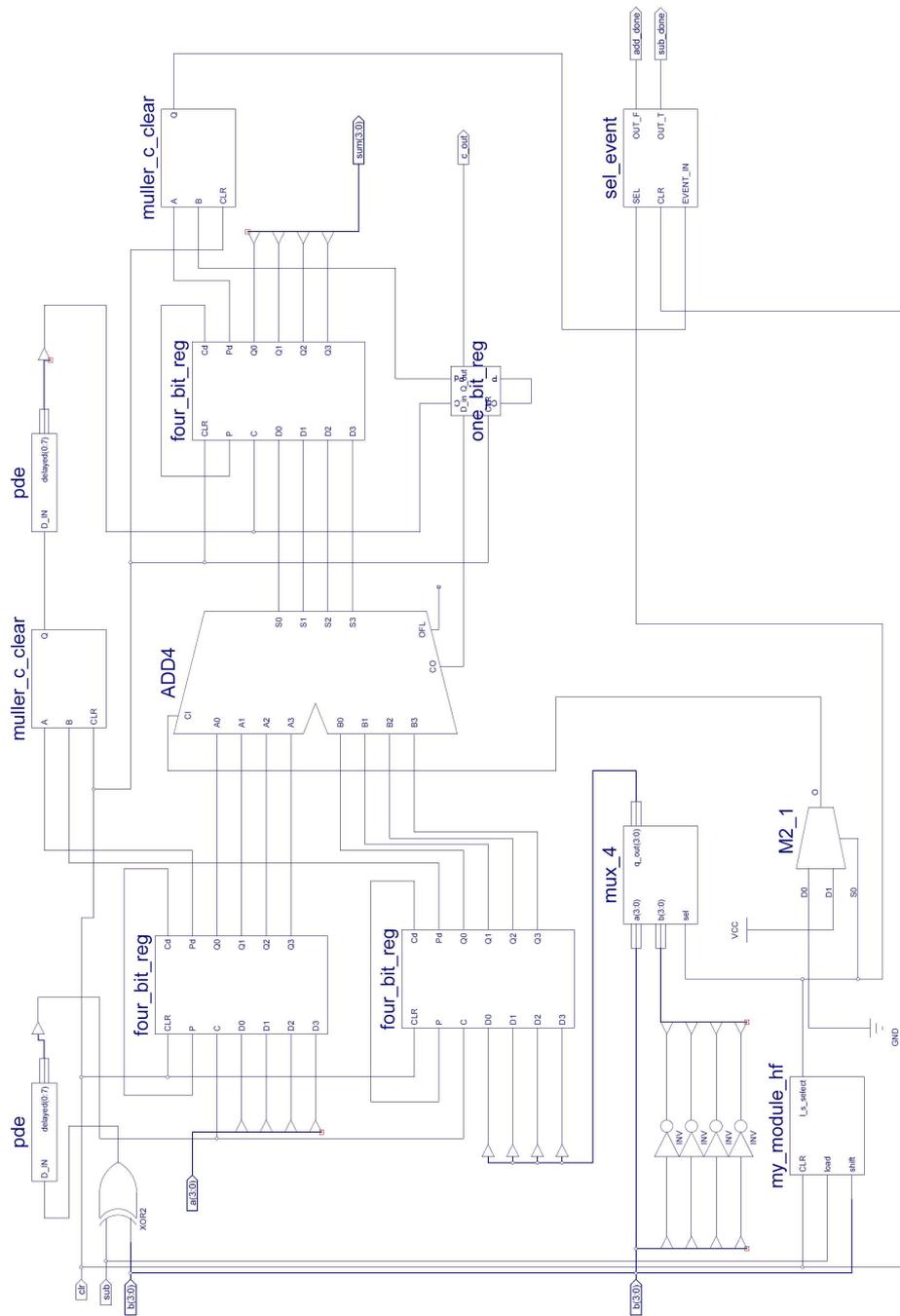
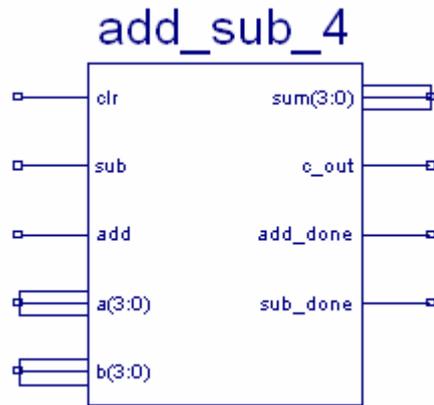


Figure 3.36 Circuit diagram of ADD/SUB



**Figure 3.37** Black Box Representation of ADD/SUB module

### 3.4.10. MULTIPLIER

The multiplier designed in this thesis implements conventional *shift and add* algorithm. This algorithm actually does what people are doing when they multiply two binary numbers with paper and pencil. The conventional process can be illustrated with a numerical example as follows.

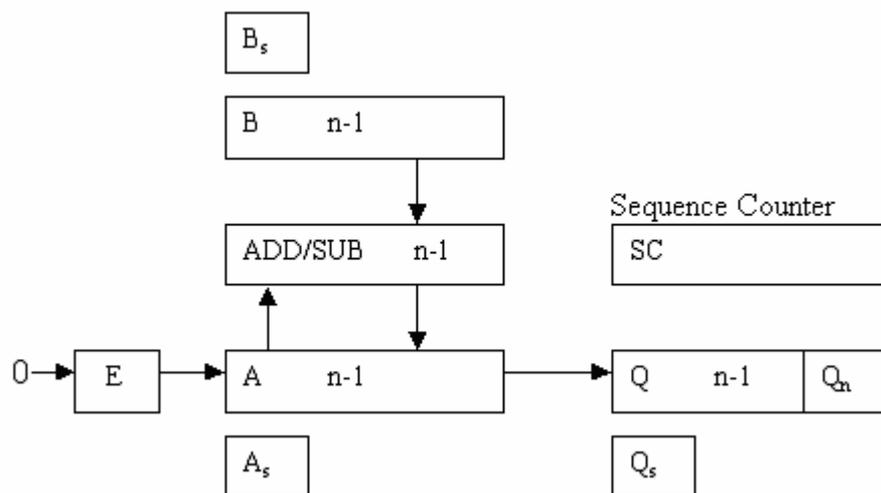
$$\begin{array}{r}
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \hline
 + \phantom{0} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \phantom{+} \phantom{0} \phantom{0} \phantom{0} \phantom{0} \\
 \hline
 0 \phantom{0} \phantom{0} \phantom{0} \phantom{0} \phantom{0}
 \end{array}
 \begin{array}{l}
 \longrightarrow \text{Multiplicand} \\
 \longrightarrow \text{Multiplier} \\
 \\
 \\
 \\
 \longrightarrow \text{Product}
 \end{array}$$

The process consists of looking at successive bits of multiplier, least significant bit (LSB) first. If the multiplier bit is a ‘1’, the multiplicand is copied down, and if ‘0’ zeros are copied down. The numbers copied down in successive lines are shifted one position to the left from the previous number. Finally they are added, and their sum gives the product.

In digital systems this algorithm is performed with a slight change. Instead of storing all shifted multiplicands and adding them at the end of the operation, they are added

at the end of each shift operation producing *partial products*. And also instead of shifting multiplicand left, partial product is shifted right, leaving the partial product and multiplicand in the required relative positions [38]. If a signed-magnitude multiplication is performed, the sign bit is determined aside from this operation. The sign bit of the product is simply found by XORing the sign bits of the multiplicand and multiplier.

The required hardware for n-bit signed magnitude multiplication is as follows shown in Figure 3.38.



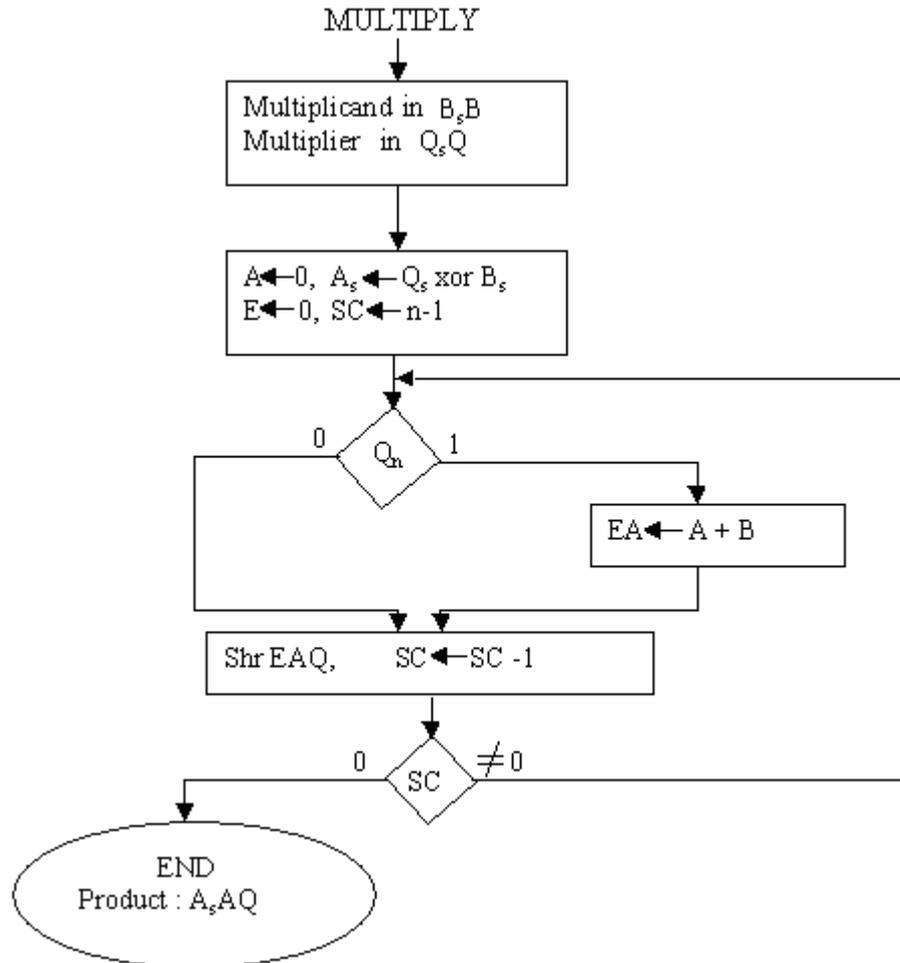
**Figure 3.38** Required Hardware for Signed-Magnitude Multiplication

Multiplication process is performed according to hardware flow chart shown in Figure 3.39. Initially, multiplicand is stored in B register (sign bit in B<sub>s</sub>), and multiplier in Q register (sign bit in Q<sub>s</sub>). The sign of the product is determined just XORing the sign bits of the multiplicand and multiplier. For magnitude multiplication A and E registers are initialized setting them to '0', and the sequence counter is loaded with the number of magnitude bits. After initialization according to the value of the LSB of multiplier (Q register) a shift or an addition and a shift after the addition is performed. For each process, the sequence counter is decremented by 1. As the value of the sequence counter gets '0', the multiplication finishes and the

product is stored in A and Q registers, while most significant part resides in A, least significant part resides in Q. The sign of the product is kept in  $A_s$  register.

The self-timed version of this architecture, implemented in this thesis as four-bit signed-magnitude multiplier, consists of the following components:

- a four-bit register for multiplicand (B),
- two four-bit loadable shift registers for multiplier (Q) and partial product (A),
- four one-bit registers for sign bits ( $B_s$ ,  $A_s$  and  $Q_s$ ) and for E,
- a four-bit adder (it has no infrastructure for subtraction, since there is no need),
- a modulo-4 counter instead of a sequence counter (SC),
- two four-bit registers for registering the final content of A and Q registers (the content of these registers are not visible at the output during the multiplication process),
- basic cell-set elements and delay blocks for control and data handling.

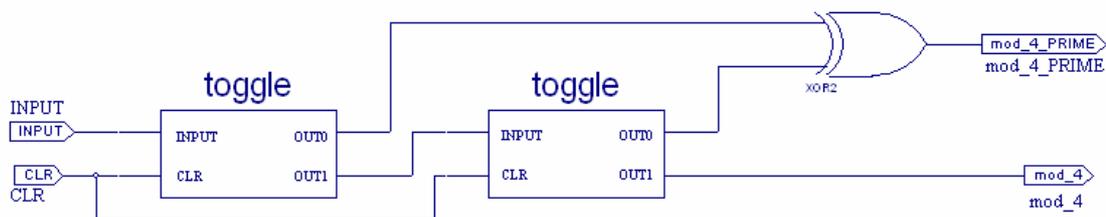


**Figure 3.39** Hardware Flow Chart for Multiplication

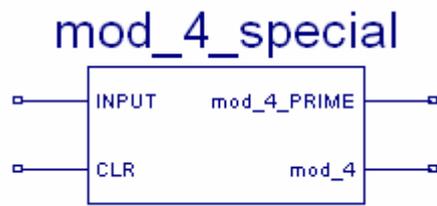
Multiplication begins with a transition on the *start* input. With this transition A, B, Q, E, A<sub>s</sub> and B<sub>s</sub> registers are loaded with initial values. A and E registers are loaded initially with '0's, but during the multiplication process if an addition is performed, A register is loaded with the *sum* output of the adder and E is loaded with the carry-out output of the adder. Moreover E register must take a '0' before a shift operation is performed. Therefore the input data of A and E registers are selected according to the process being performed. For this purpose multiplexers are utilized. The select inputs of the multiplexers are generated by *my\_module\_hf* modules. So the initial load request (*start*) and load requests after additions are differentiated from each other. For E register also the shift operation is differentiated from load operations. The requests which are wanted to be differentiated from each other, arrives both the

load or shift request input pins of the registers and L and S inputs of the my\_module\_hf. The delay elements are inserted on the load request and shift request paths of the registers, in order to wait for data to be available at the output of the multiplexers before the requests reach the registers.

The number of shift and add operations is counted by a special modulo-4 counter instead of a sequence counter. The modulo-4 counter (Figure 3.40 and Figure 3.41) takes the transitions and steers every fourth transition to its mod\_4 output while first, second and third transitions are steered to mod\_4\_PRIME output. This module is triggered after each shift operation. Since a shift occurs regardless of the value of the LSB of Q register, the end of the operation can be determined by simply counting the shift operations. So the shift acknowledge is connected to the input of modulo-4 counter. While the first three acknowledgements are directed to the module which checks the LSB of Q register and determines accordingly whether a shift or addition is done, the fourth transition is sent to the registers which will hold the final content of A<sub>s</sub>, A and Q registers as product output. When these registers acknowledge the storage operation, by combining their acknowledge outputs to a MULLER-C element a *finish* signal is generated to indicate the end of the operation and the product is available at the output. The schematic design of 4-bit signed-magnitude multiplier can be seen in Figure 3.42.



**Figure 3.40** Circuit diagram of special modulo-4 counter



**Figure 3.41** Black Box Representation of special modulo-4 counter

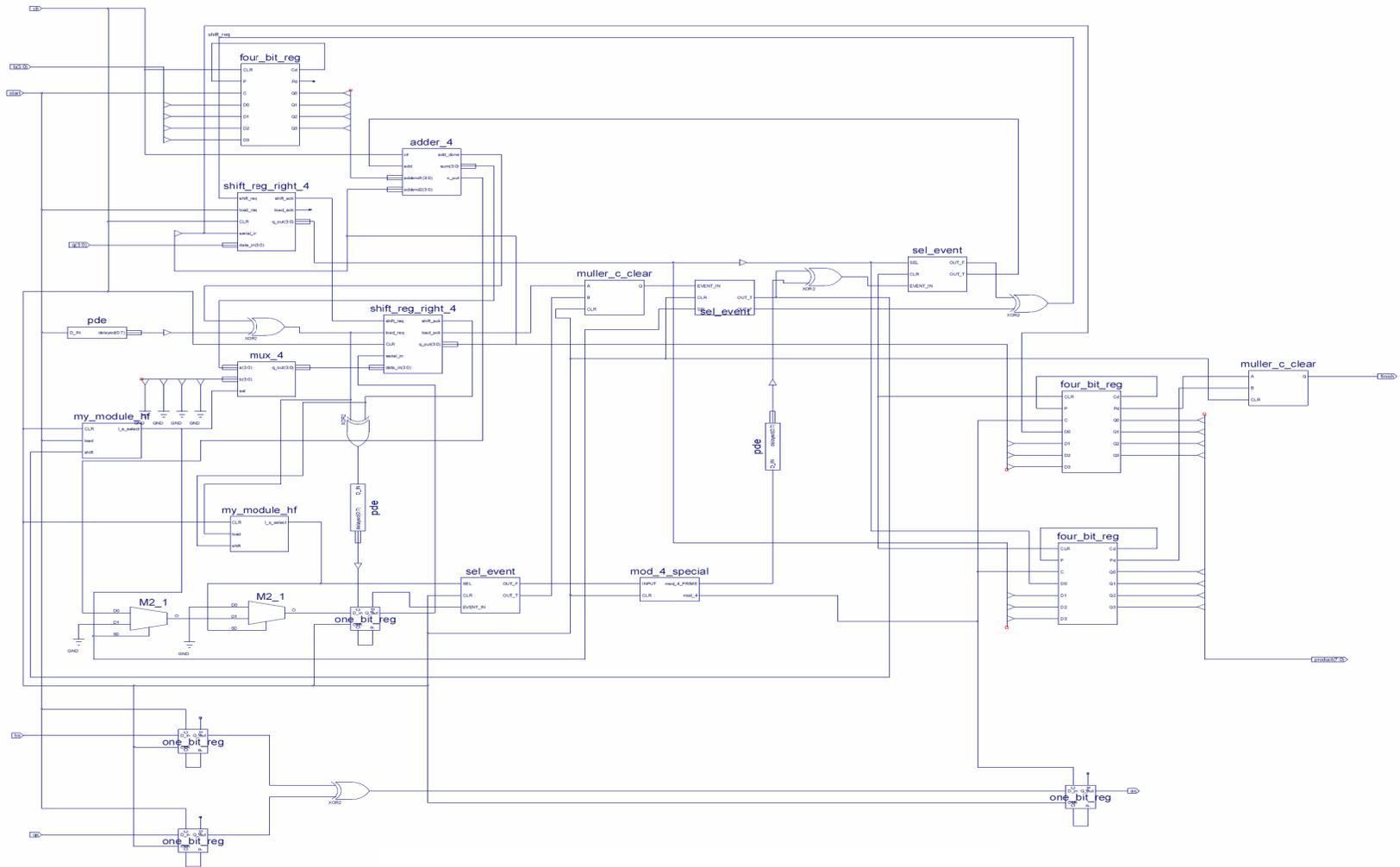
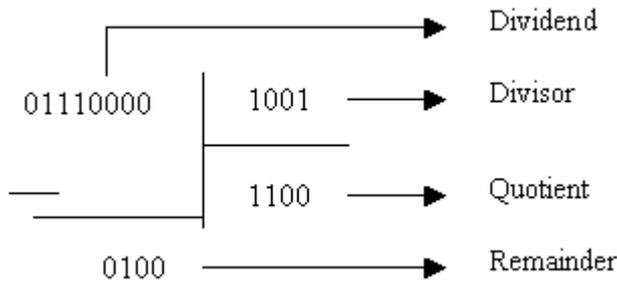


Figure 3.42 4-bit Signed-Magnitude Multiplier

### 3.4.11. DIVIDER

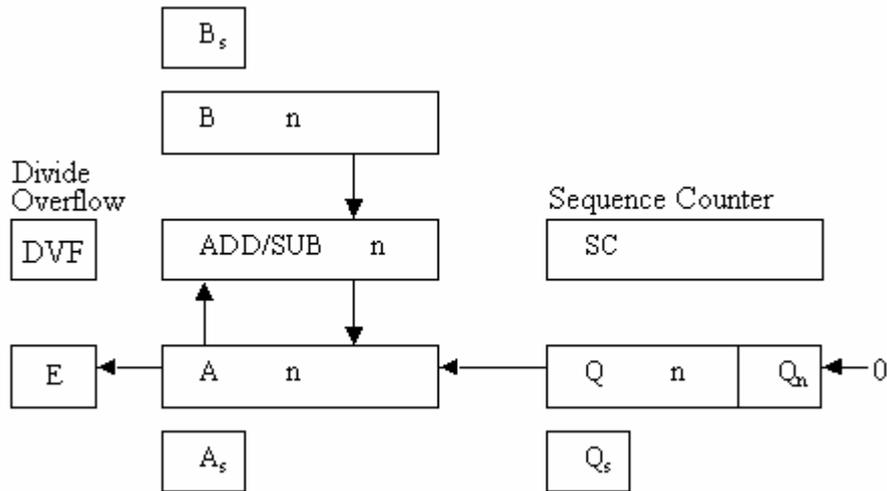
The divider designed in this thesis performs 4-bit signed-magnitude binary numbers division. Like multiplier, the conventional algorithm, what people do when they divide two binary numbers with paper and pencil, has been implemented. The conventional algorithm is simply a process of successive compare, shift and subtract operations. The division process is illustrated by a numerical example as follows:



For a  $2n$ -bit dividend by  $n$  bit divisor case the process starts with comparing most significant  $n$  bits of dividend with divisor. If divisor is greater, then a '0' is put for quotient and the divisor is shifted once to the right (this process can be thought as if adding a '0' in front of the MSB of divisor). Otherwise a '1' is put for quotient and the divisor is subtracted from the part of the dividend with which it is compared. The divisor is shifted again after subtraction. The difference is called a *partial remainder* [38] because the division could have stopped here to obtain a quotient of '1' and a remainder equal to the partial remainder. The process is continued by comparing partial remainder with the divisor. If the partial remainder is greater than or equals the divisor, the quotient bit is equal to '1'. The divisor is then shifted right and subtracted from the partial remainder. If the partial remainder is smaller than the divisor, the quotient bit is '0' and no subtraction is needed. The divisor is shifted once to the right in any case.

In digital systems this algorithm is performed with a slight change. Instead of shifting the divisor to the right, the dividend or partial remainder is shifted to the left, thus leaving the two numbers in the required relative positions. The hardware

required for division, and the hardware flow chart for signed-magnitude division can be seen in Figure 3.43 and Figure 3.44 respectively.



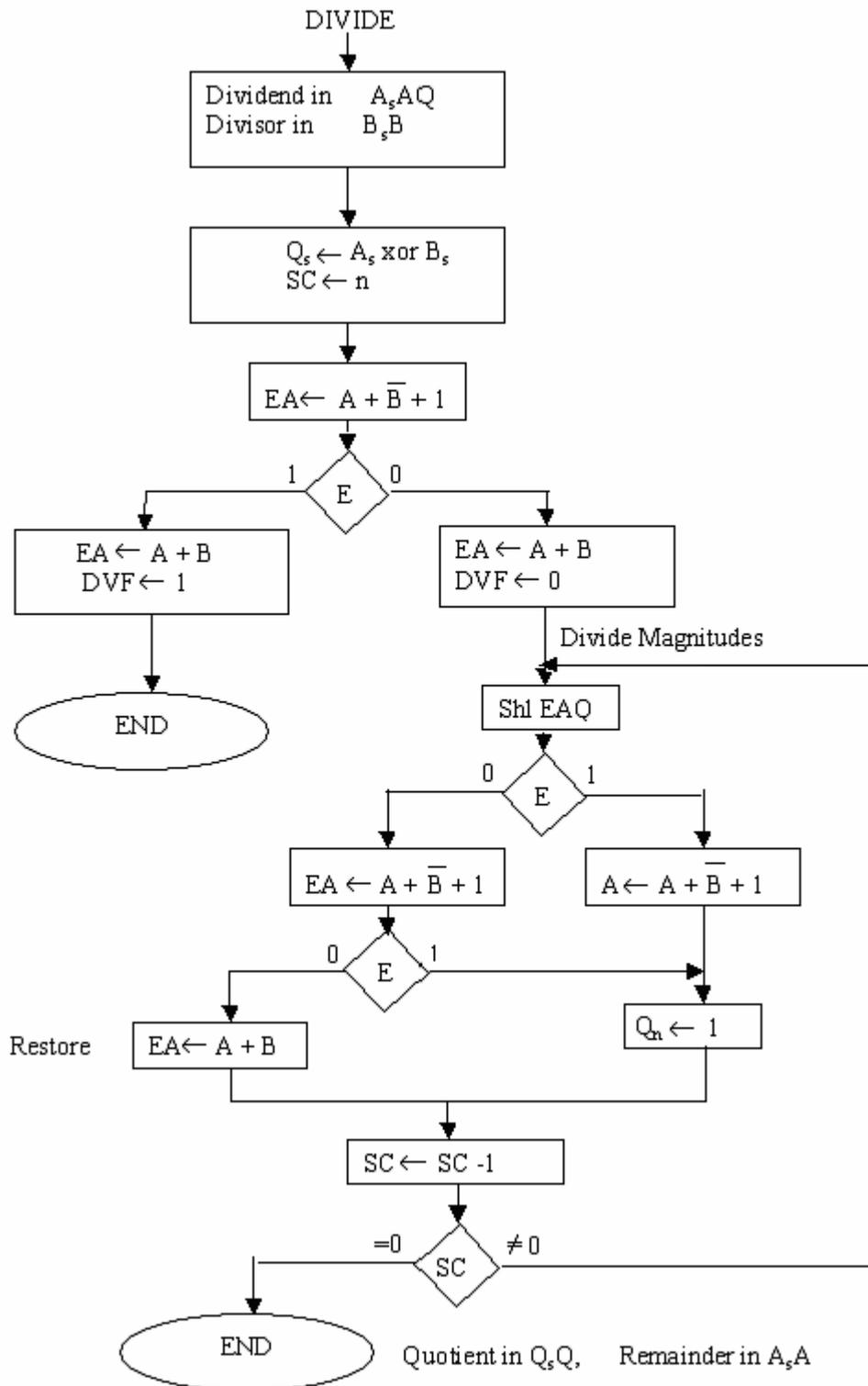
**Figure 3.43** Required Hardware for Signed-Magnitude Division

The dividend is contained in  $A_sAQ$  and the divisor is contained in  $B_sB$ . The sign of the quotient ( $Q_s$ ) is determined by XORing the sign bits of the dividend and divisor. If the sign bits are not counted, the dividend is of length  $2n$  and divisor is of length  $n$ . The register dedicated for quotient ( $Q$ ) is also of length  $n$ . If the higher order half bits of dividend constitute a number greater than or equal to divisor, then *divide overflow* condition occurs. This means the quotient cannot be fit into  $n$ -bit register, it is at least of length  $n+1$ . At the beginning of the operation this condition is checked, and if a divide overflow condition exists, the process is exited by setting the DVF bit. If there is no overflow condition the process is continued by magnitude division.

The division of magnitudes starts by shifting the dividend in  $AQ$  to the left with high-order bit shifted into  $E$ . If the content of  $E$  is '1', then it is obvious that  $EA > B$ , since  $EA$  consists of a '1' followed by  $n$  bits while  $B$  consists of only  $n$  bits. In this case  $B$  is subtracted from  $A$  and a '1' is inserted to  $Q_n$  for quotient bit.

If the shift-left operation inserts a '0' into E, then the contents of the A and B registers are compared by subtracting B from A. The subtraction is done by adding 2's complement of B to A. If the carry-out of the adder is '1', it signifies that  $A \geq B$ ; therefore a '1' is inserted to  $Q_n$ . If E is '0' then it means that  $A < B$ , so in order to restore original number B is added to A. There is no need to set  $Q_n$  to '0', since a '0' is already inserted during the shift operation.

This process is repeated for  $n$  times. The flow control is done by assigning a sequence counter initially to  $n$  and decrementing it by 1 after one shift, compare and subtract cycle. When the content of this counter is '0' then the operation is completed, the remainder is in A, and the quotient is in Q.



**Figure 3.44** Hardware Flow Chart for Signed-Magnitude Division

The self-timed version of this architecture, implemented in this thesis as four-bit signed-magnitude divider, consists of the following components:

- a four-bit register for divisor (B),
- two four-bit loadable shift registers for dividend (Q and A),
- four one-bit registers for sign bits ( $B_s$ ,  $A_s$  and  $Q_s$ ) and for E,
- a four-bit adder/subtractor ,
- a modulo-4 counter instead of a sequence counter (SC),
- two four-bit registers for registering the final content of A and Q registers (the content of these registers are not visible at the output during the division process),
- basic cell-set elements and delay blocks for control and data handling.

Division begins with a transition on the *start* input. With this transition A, B, Q,  $A_s$  and  $B_s$  registers are loaded with initial values. A and Q registers are loaded initially with dividend, but during the division process if an addition or subtraction is performed, A register is loaded with the *sum* output of the add/sub block, and Q is reloaded with its LSB set to '1', if partial remainder is greater than or equals to divisor. Therefore the input data of A and Q registers are selected according to the process being performed. For this purpose multiplexers are utilized. The select inputs of the multiplexers are generated by *my\_module\_hf* modules. So the initial load request (*start*) and load requests after additions are differentiated from each other. The requests which are wanted to be differentiated from each other, arrives both the load or shift request input pins of the registers and L and S inputs of the *my\_module\_hf*. The delay elements are inserted on the load request and shift request paths of the registers, in order to wait for data to be available at the output of the multiplexers before the requests reach the registers.

The number of shift-compare and subtract operations is counted by the same special modulo-4 counter used in multiplier (Figure 3.40). This module is triggered after each *restore* or *set  $Q_n$  to '1'* operation. Since one of these operations occurs at the end of each comparison, the end of the operation can be determined by simply counting the comparison operations. While the first three acknowledgements are

directed to initiate shift-left operation, the fourth transition is sent to the registers which will hold the final content of A, Q and  $Q_s$  registers as remainder and quotient output. When these registers acknowledge the storage operation, by combining their acknowledge outputs to a MULLER-C element a *finish* signal is generated to indicate the end of the operation and the remainder and quotient are available at the output. The schematic design of 4-bit signed-magnitude divider can be seen in Figure 3.45.

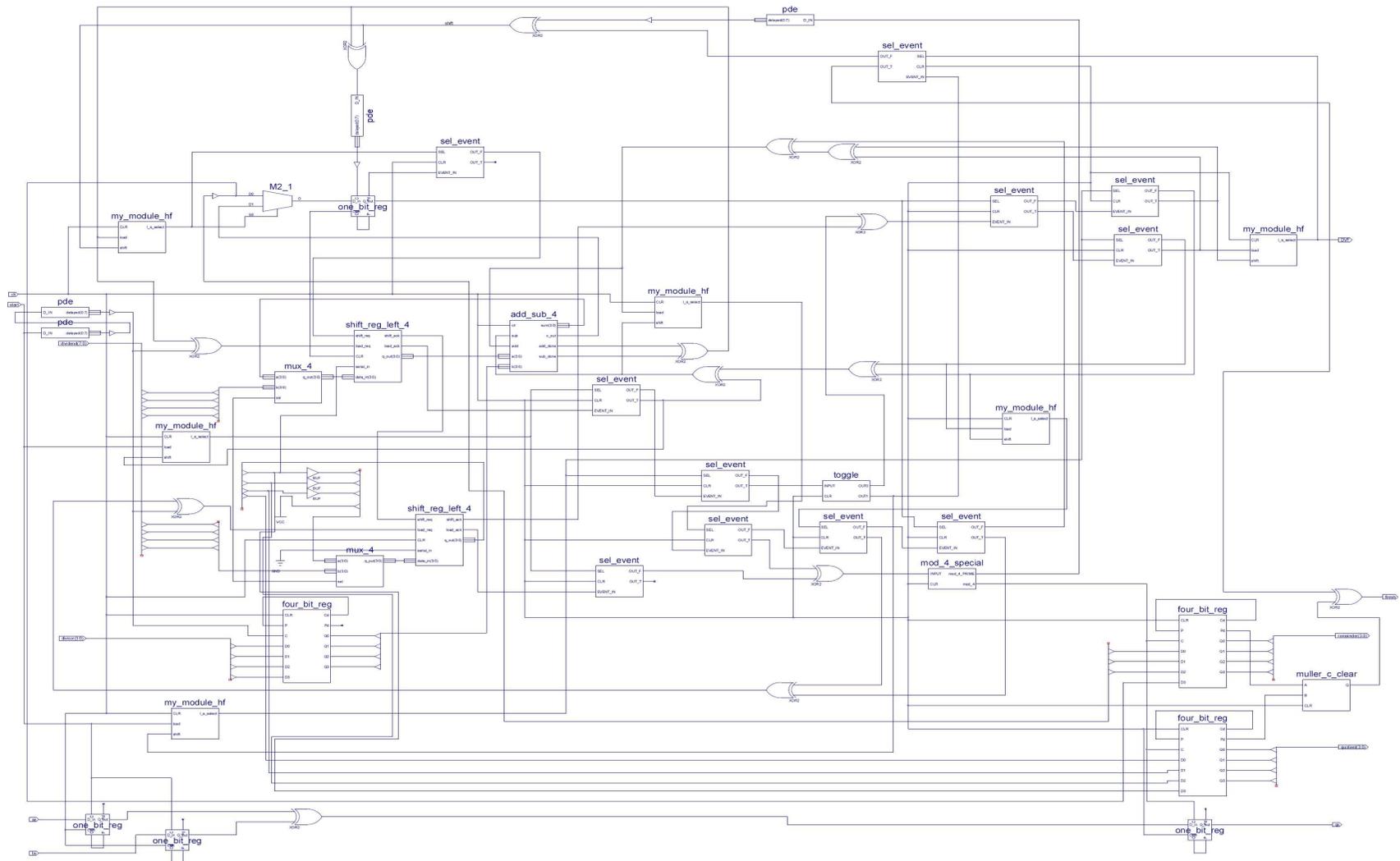


Figure 3.45 Four-bit Signed-Magnitude Divider

### 3.4.12. I/OS OF ALU

The individual functional units described above have been combined in a top module. The top module takes two data input, one of them is of length 8 (REG1) and the other is of length 4 (REG2). According to the function implemented the meaningful bits differ. Table 3.2 shows which bits of REG1 and REG2 are meaningful for which operation. Also for multiplication and division there are two one-bit inputs (*as* and *bs*) that indicate the sign bits of operands. For other operations they are don't cares.

The top module has also *CLR* input, for initialization of the modules, and *START* as the external *REQUEST* input of the ALU.

The function of the ALU is selected through an opcode. The opcode has 5 bits, and the least significant three bits determine whether the ALU will perform AND, OR, COMPLEMENT, ADD, SUBTRACT, MULTIPLY or DIVIDE operation, while the most significant determines whether the output of the operation will be shifted left, shifted right or kept as it is. Table 3.3 gives the opcode decoding.

The outputs of the functional units are decoded in eight-bit *OUTREG* output of the ALU. The sign bits of product and division are also multiplexed with the carry-out bits of adder/subtractor unit in *qs* output. The decoding of *OUTREG* and *qs* is shown in **Table 3.4**. The ALU has also a *DVF* output dedicated for divide overflow condition of divider and a *FINISH* signal as external *ACKNOWLEDGE* of the ALU.

**Table 3.2** Input Decoding

OPERATION	REG1(7:4)	REG1(3:0)	REG2(3:0)
COMPLEMENT	X	X	input(3:0)
ADD	X	augend(3:0)	addend(3:0)
SUBTRACT	X	subtrahend(3:0)	minuend(3:0)
MULTIPLY	X	multiplier(3:0)	multiplcand(3:0)
DIVIDE	dividend(7:4)	dividend(3:0)	divisor(3:0)
AND	X	input1(3:0)	input2(3:0)
OR	X	input1(3:0)	input2(3:0)

**Table 3.3** ALU Function Selection Opcode Decode Table

OPCODE(2:0)	OPERATION	OPCODE (4:3)	OPERATION
000	COMPLEMENT	00	NO SHIFT
001	ADD	01	SHIFT RIGHT
010	SUBTRACT	10	SHIFT LEFT
011	MULTIPLY	11	NOT DEFINED
100	DIVIDE		
101	AND		
110	OR		
111	NOT DEFINED		

**Table 3.4** Output Decoding

OPERATION	OUTREG(7:4)	OUTREG(3:0)	qs
COMPLEMENT	X	output(3:0)	X
ADD	X	sum(3:0)	carry-out
SUBTRACT	X	difference(3:0)	carry-out
MULTIPLY	product(7:4)	product(3:0)	product sign
DIVIDE	quotient(3:0)	remainder(3:0)	quotient sign
AND	X	output(3:0)	X
OR	X	output(3:0)	X

### 3.5. INCREMENTAL DESIGN USING RELATIONALLY PLACED MACROS

As mentioned before, the initial step for designing asynchronous systems is to obtain a hazard-free cell set. Hazard-free circuits can be obtained by meeting firstly the design constraints such as covering all prime implicants in the SOP implementation, encoding adjacent states with adjacent code words etc., and secondly the timing constraints such as feedback delay constraint, and bundled data constraints in self-timed systems. While the design defects are independent of the environment on which the system is constructed, and can be eliminated on paper before starting implementation, the timing problems strongly depend on the design environment, and are mostly handled during implementation stage. Actually eliminating timing problems means adjusting delays properly.

In an FPGA the design can be entered in two different ways, using HDLs (Hardware Description Languages) or schematic entry tool. Two widely used HDLs are Verilog and VHDL (VHSIC HDL), where VHSIC stands for Very High Speed Integrated Circuits. The synthesizers (XST, Exemplar, Precision etc.) produce EDIF (Electronic Design Interchange Format) files from the design entries. EDIF is a standard interface-file specification. EDIF files are used by place-and-route (PAR) tools for mapping the logic into the architectural resources of the FPGA (CLBs, IOBs etc.). PAR tools then determine the locations for these blocks based on their interconnections and finally interconnect the blocks.

The placement and delays depend very much on the performance of the tools used. In this thesis, as mentioned before, Xilinx's ISE (Integrated Software Environment) tool has been utilized. ISE provides text and schematic editors for HDL and schematic design entries; XST (Xilinx Synthesis Technology) as synthesizer, and PAR tools. While PAR tools can implement the designs automatically, they allow the user view and modify the placed design (via Floorplanner) as well as view and modify the physical implementation, including routing (via FPGA Editor).

At the beginning, basic cell set elements have been entered in schematic editor, and placement and routing has been made automatically. The hazard behavior of the units has been checked by making simulations. In the simulations all possible input combinations have been tried. If a hazard is observed, this is mainly a sequential hazard, since there is no possibility for logic-hazards to occur in LUT-base implementations (refer to section 3.2.1). The main reason for sequential hazards is unfavorable routing. Automatic routing may not satisfy the feedback delay to be less than or equal to the sum of the minimal delay in detecting the output change and producing a new input, and the minimal delay on the input line. In this case the delay constraints can be met either by making the routing by hand using FPGA editor, or adding extra delay elements where the delay should be greater than others. In this thesis the second approach has been preferred. The only element at which hazard has been observed after automatic routing was the TOGGLE element. All of the other basic cell set elements were hazard-free. TOGGLE element has also been implemented as hazard-free after inserting two buffers on the data paths. An

important point which must be considered in buffer insertion is that, the nets before and after the buffer must be associated with *KEEP* property set to *TRUE*, so that synthesis tool does not remove the buffer when it optimizes the circuit, since during optimization the synthesis tool appreciates the two nets before and after the buffer equal and finds the buffer as an unnecessary gate between these nets.

After obtaining a complete hazard-free cell set, the next step was to implement self-timed circuits using these elements. The timing problem, which must be handled in the self-timed systems, is bundled-data constraint, i.e., the data must be available before a request arrives to the processing unit. This constraint can be met by delaying control signals for data process time. The control signals are delayed using PDE elements, whose structure is described in section 4.6. PDE is a chain of inverters, and similar to buffers if the nets between inverter gates are not associated with the *KEEP* property set to *TRUE* they are removed by the synthesis tool.

During the design process of self-timed circuits, it has been seen that the basic cell set elements could exhibit hazardous behavior, when they are instantiated in upper level modules, although they were implemented as hazard-free individually. The reason for this situation is that, when they are instantiated in upper blocks, their placement and routing is different than the placement and routing as they were implemented as single blocks. The random behavior of PAR tool also complicates the adjusting delays for bundled data protocol. For each new delay value a new placement is encountered. While a system can operate correctly for a delay value, it may not operate for higher delay values. This is an unexpected case, since for correct operation there is only a lower limit for delay and for delay values higher than the lower limit the system should operate correctly. When increasing the delay the remaining circuit does not keep its placement and routing, and hence the delay assumptions made in one case may fail in another case. The unfavorable effect of unpredictable routing can be decreased extensively, although not fully eliminated, by creating relationally placed macros (RPM) of the design units, and using incremental design techniques.

### 3.5.1. RELATIONALLY PLACED MACROS (RPMS)

An RPM defines the spatial relationship of the primitives that constitute its logic, and after an RPM is created it is indivisible any more. Creating RPMs is helpful in maintaining the delays in a modular, hierarchical design. And since the basic modules are constrained in a predefined area, when they are connected in a higher level, internal routing does not differ very much and extra expense of routing resources is eliminated. As a result the final design takes also less space compared to that not comprised of RPM modules.

The methodology how to create RPMs is explained in an application note [39] published by Xilinx. This methodology cannot be applied to schematic designs. Therefore all schematic entries have been converted to VHDL counterparts. The ISE tool does this process automatically. Before creating RPMs of the modules, their VHDL based implementations have been tested again, because the schematic and VHDL designs differ in routing, the delay calculations made for schematic design may fail for the VHDL design. The delay values have been modified again until being satisfied with the automatic placement of the PAR tool according to simulation results. Finally *hazard-free RPMs* of the basic cell set elements have been obtained. The relational locations of the primitives are written to a file named as *user constraint file* (UCF), and when the RPM is instantiated in an upper module, the content of this file must be copied into the UCF of the upper module, explicitly indicating the hierarchical instance name.

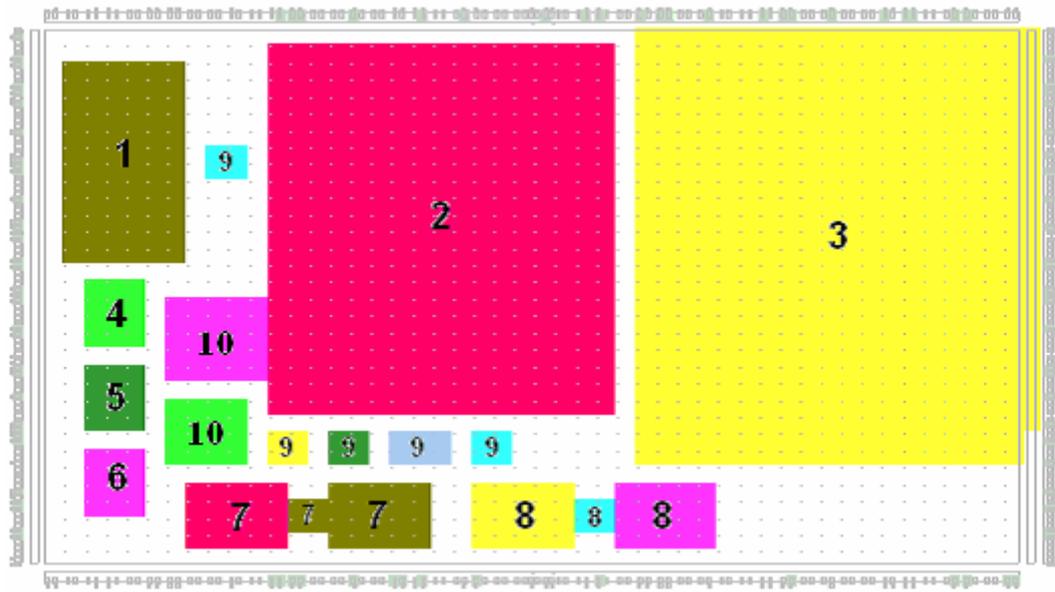
Self-timed circuits can be easily implemented using the RPMs of the constituent elements. The delay assignments can be made more coherently, since the routing is more predictable with RPMs. So, all of the functional units of the ALU, described above, have been implemented using RPMs.

### **3.5.2. INCREMENTAL DESIGN FLOW**

The incremental design flow is a methodology for processing designs in a hierarchical way that reuses results for unchanging portions of the design. The design is partitioned into separate logic groups, which are then constrained with an AREA GROUP constraint. This constraint packs logic together during the mapping process so that each logic group is assigned an area on the device. When a design change is made to one of the logic groups, the incremental design flow ensures that unchanged logic groups are unchanged in the synthesis output. PAR tools re-place and re-route the changed logic within its assigned area, while the unchanged logic groups are guided from the previous implementation. So the timing results (placement and routing) of unchanged logic groups remain stable. Incremental design flow also reduces the implementation runtimes by only re-implementing the changed logic.

Incremental design flow technique is explained in an application note [40] published by Xilinx. In this thesis, this methodology has been followed when combining the functional units of ALU at the top level. Each unit (AND, OR, COMPLEMENT, ADD/SUB, MULTIPLIER, DIVIDER, SHIFT REGISTERS) constitutes a logic group and they have been placed on the assigned areas preserving the placement and routing as they were implemented individually. The logic blocks, which are used to connect these modules, and to control the ALU functions, have also been partitioned into logic blocks. While placing area groups, the logic groups which communicate with each other have been placed next to each other, and the logic groups which use I/Os, have been placed next to I/O blocks of the FPGA. The I/O pin assignments have been done according to the layout of the PCB which has been implemented for hardware realization of the thesis.

On the PCB, there are seven segment displays to demonstrate inputs and outputs of the ALU. The necessary logic for encoding the binary input and output data to seven segment displays in BCD (binary coded decimal) format, has been implemented on the area which is not occupied by the logic groups. This logic is fully combinational and has no effect on the operation of the ALU. The floorplanner view after area groups have been assigned for the logic groups can be seen in Figure 3.46.



1. ADD/SUB
2. MULTIPLIER
3. DIVIDER
4. COMPLEMENT
5. OR
6. AND
7. LOADABLE SHIFT REGISTER (LEFT)
8. LOADABLE SHIFT REGISTER (RIGHT)
9. CONTROL LOGIC AT TOP LEVEL (SELCT, MULLER-C, etc)
10. BINARY TO SEVEN SEGMENT DISPLAY ENCODER LOGIC

**Figure 3.46** Floorplanner view of the logic groups

## CHAPTER 4

### NUMERICAL RESULTS

In an FPGA design, there are two main criteria when evaluating the design; area and operating speed. Area is evaluated in terms of the number of slices occupied by the logic, and operating speed is evaluated in terms of data latency, i.e., the time spent from initiating the process until the data is available at the output. In self-timed circuits data latency can be given as the time between arrival of request and generation of acknowledgement.

In asynchronous sequential circuits the transition delay between any two states are not equal. It depends on the state variables that are excited during the transition. Therefore in self-timed circuits, which consist of sequential elements, the latency between the request and acknowledgement signals does not have a fixed value. For example in *muller-c* element, the response time to change in *a* input takes 7.191 ns, while the response time to change in input *b* takes 7.348 ns.

For multiplication and division the latency depends also on the inputs. In multiplication the addition operation is performed as many times as the number of '1's in multiplier. Hence, the less number of '1's the multiplier has, the shorter the time passes for the multiplication process. In division, if a divide overflow condition exists, the operation is exited at that moment and it is the shortest time spent for the division. In other cases the operation time also depends on the result of the comparisons made. If the partial remainder is less than the divisor, the partial remainder must be restored after the subtraction, which is made for comparison. The restore operation is not performed if partial remainder is greater than divisor. As a result, the latency changes according to input given.

Table 4.1 gives a summary of the area occupied by the modules, which are implemented in this thesis, and minimum and maximum latencies on these modules. The simulation waveforms of the modules can be seen in the Appendix A. The values given in Table 4.1 and the simulation outputs in the appendix part correspond to the results obtained when these modules are implemented individually. The final ALU, comprising these modules, has higher latencies for the given operation, since an extra register operation is performed, according to selected function, and if the output shift function is selected the latency increases even more, since the output of the selected module is registered first, and then shift operation is performed. Table 4.2 shows the latencies of the functional units of the ALU after combining them at the top level.

**Table 4.1** Area and latency results of the self-timed modules

Module	# of slices	Latency* (ns)	
		min	max
MULLER-C	1	7.191	7.348
TOGGLE	4	7.720	10.442
SELECT	2	8.726	8.569
CALL	2	8.761	13.812
OPAQUE LATCH	1	7.398	8.060
ONE-BIT REGISTER	6	27.604	30.080
FOUR-BIT REGISTER	9	24.587	27.786
FOUR-BIT AND	13	18.716	21.492
FOUR-BIT OR	13	18.716	21.492
FOUR-BIT COMPLEMENT	13	13.461	17.065
PDE	16	12.535	27.679
LOADABLE SHIFT REGISTER (TYPE 1)	44	load : 43.784	56.125
		shift : 44.778	57.973
LOADABLE SHIFT REGISTER (TYPE 2)	34	load : 21.025	23.743
		shift : 21.218	23.936
MY_MODULE_HF	2	8.313	8.530
ADD/SUB	81	add : 41.070	48.642
		sub : 41.444	48.208
4x4 MULTIPLIER	232	312.914	494.514
8/4 DIVIDER	328	188.812	1.028.060

\* Latency includes input/output pad delays as well

**Table 4.2** Function latencies of asynchronous ALU (Top level implementation)

Function	Latency (ns)			
	no shift		shift right/left	
	min	max	min	max
COMPLEMENT	49.229	54.509	83.888	86.243
AND	48.756	55.299	83.415	87.033
OR	45.963	51.762	80.622	83.496
ADD	74.832	84.337	109.491	116.071
SUBTRACT	75.530	85.035	110.189	116.769
MULTIPLY	331.000	524.377	365.659	556.111
DIVIDE	232.783	1109.314	266.182	1143.973

To make a comparison a synchronous version of the ALU implemented in this thesis has also been designed on the same target FPGA. The synchronous ALU performs the same algorithms as the asynchronous ALU. Even, it realizes a two-phase handshaking between its modules. Synchronous ALU has been implemented fully by VHDL, and the synthesis and PAR options have been left at default values, i.e., placement and routing have been done fully automatically, without giving any constraint. According to PAR report file generated by ISE, the synchronous ALU can operate at a frequency of 124 MHz. When ALU components are implemented separately, they can operate at higher frequencies, however the operating frequency decreases to the frequency of the slowest module, when they are combined in an upper level. Table 4.3 shows the occupied area and latencies of the modules when they are implemented individually, and Table 4.4 shows the function latencies of the top-level implementation of the synchronous ALU. Both results have been obtained by a simulation with 100 MHz clock. In synchronous ALU the latency for a given function does not depend on the state transitions, since all transitions are quantized with clock period. Of course, the latencies of multiplication and division processes depend on the input values like in the asynchronous ALU, since synchronous ALU

performs the same shift-and-add algorithm for multiplication, and shift-compare-subtract algorithm for division.

**Table 4.3** Area and latency results of the synchronous modules

Module	# of slices	Latency (ns)	
		min	max
FOUR-BIT AND	5	17.094	17.094
FOUR-BIT OR	5	17.097	17.097
FOUR-BIT COMPLEMENT	1	17.092	17.092
LOADABLE SHIFT REGISTER	10	load : 31.586	31.586
		shift : 31.586	31.586
ADD/SUB	13	add : 30.000	30.000
		sub : 30.004	30.004
4x4 MULTIPLIER	23	147.092	227.092
8/4 DIVIDER	38	67.102	347.102

**Table 4.4** Function latencies of synchronous ALU (Top level implementation)

Function	Latency* (ns)			
	no shift		shift right/left	
	min	max	min	max
COMPLEMENT	41.603	41.603	41.603	41.603
AND	41.603	41.603	41.603	41.603
OR	41.603	41.603	41.603	41.603
ADD	61.603	61.603	61.603	61.603
SUB	61.603	61.603	61.603	61.603
MULTIPLY	171.603	251.603	171.603	251.603
DIVIDE	91.603	371.603	91.603	371.603

\* Latency includes input/output pad delays as well (at 100MHz)

According to simulation results synchronous and asynchronous modules show similar performance for small-scaled circuit applications, such as AND, OR and COMPLEMENT, when they are implemented individually. Even, asynchronous shift register (Type 2) seems to be faster than its synchronous counterpart. However, the synchronous modules are implemented similar to the asynchronous modules, and thus have extra logic, which increases the latency. The two-phase handshaking protocol has been applied to synchronous modules as well. They start with the operation as the request arrives, and they produce an acknowledgement signal after the data is available at their output. This is not a usual operation flow for synchronous circuits. Normally AND, OR, COMPLEMENT, SHIFT, ADDITION/SUBTRACTION operations can be done within a clock period, and in this case the latency will take no more than 10 ns. for an operation frequency at 100 MHz. The effect of usual operation of these functions can be seen in the data latencies of the multiplier and divider. Synchronous multiplier and divider perform almost two times faster than asynchronous ones. The main reason for this is that shift, add/sub operations take less time in synchronous modules, and these operations consist the majority of the operations performed in multiplication and division algorithms.

Aside from latency, the slice utilization is better in synchronous modules. The main reason for this is that FPGA architecture and synthesis tools are more suitable for synchronous designs. While in a synchronous design the flip-flop in a CLB can be used for data storage of the LUT output in the same CLB, in asynchronous design 6 extra slices are consumed for registering one-bit data (refer to Table 4.1). Moreover, basic control modules for two-phase handshaking, and delay elements used for satisfying bundled-data constraint, result in extra slice consumption. Another reason for asynchronous circuits using more slices is that, for initialization of the asynchronous circuits extra gates are used, while in synchronous circuits dedicated RESET and SET inputs of the flip-flops are used for initialization and thus no extra logic is generated for this purpose.

All the design files can be found in the CD enclosed in an envelope in Appendix C. There are three folders in CD. *tez\_schematic* folder contains the schematic entries of

the basic cell set elements and ALU components described in chapter 3, *tez\_async\_alu* folder contains the VHDL versions of the schematic files and top module combination of the asynchronous ALU designed with incremental design technique. Finally *tez\_sync\_alu* folder contains the synchronous version of the ALU implemented in this thesis. When the *ISE project files* contained in these folders are opened with an ISE 6.3 program, all the design files and testbench files corresponding to VHDL and schematic modules can be observed in a hierarchical order. The testbench files can be run with a Modelsim program as well.

## CHAPTER 5

### HARDWARE IMPLEMENTATION

The asynchronous ALU implemented in this thesis has also been realized on hardware. For this purpose a PCB has been designed. The PCB consists of the target FPGA (Xilinx Virtex XCV300) and peripheral elements. The peripheral elements are as follows:

- Power Terminals: The power is given through these terminals. A 5V voltage must be supplied to the board, and the supply should be capable of providing 2A current as well.
- A Switching Voltage Regulator (SVR) (PT6941C): On the board three different voltage levels are used. These are 5V, 3.3V and 2.5V. SVR converts 5V to 2.5V and 3.3V.
- An EEPROM (XC18V02): It is used to keep the configuration file of the FPGA. When the card is given power, the data in the EEPROM is transferred to the FPGA, and then FPGA performs the operation until the power is off.
- A connector for JTAG interface: The configuration file is downloaded to the EEPROM through this connector.
- Buffers (74LVT16245): They are used to isolate I/Os of FPGA from external environment.
- Switches: They are used to set the input data, opcode and START signal to initiate the operation.
- Push buttons: There are two push buttons on the board. One of them is used to reset the FPGA, i.e., reload the configuration data, and the other is used to initialize the ALU by giving a CLR signal.
- Debounce circuit (MAX6818): This circuit is used to eliminate bouncing on CLR and START signals. For two-phase signaling it is very important to

have clear transitions especially on request signal, which is here the START signal.

- LEDS: All input and output signals are demonstrated with LEDS.
- Seven-segment displays: There are nine seven-segment displays, five of them are used to demonstrate input data, and the rest four are used to demonstrate output data in BCD format. Most of the power is consumed on these displays. Transistors have been utilized in order to supply necessary current to illuminate the LEDs of these seven-segment displays.
- A clock generator: This circuit provides a 50 MHz clock and has been placed for the case of implementing synchronous ALU as well on the same board. However it has no function when the asynchronous ALU configuration file is downloaded.

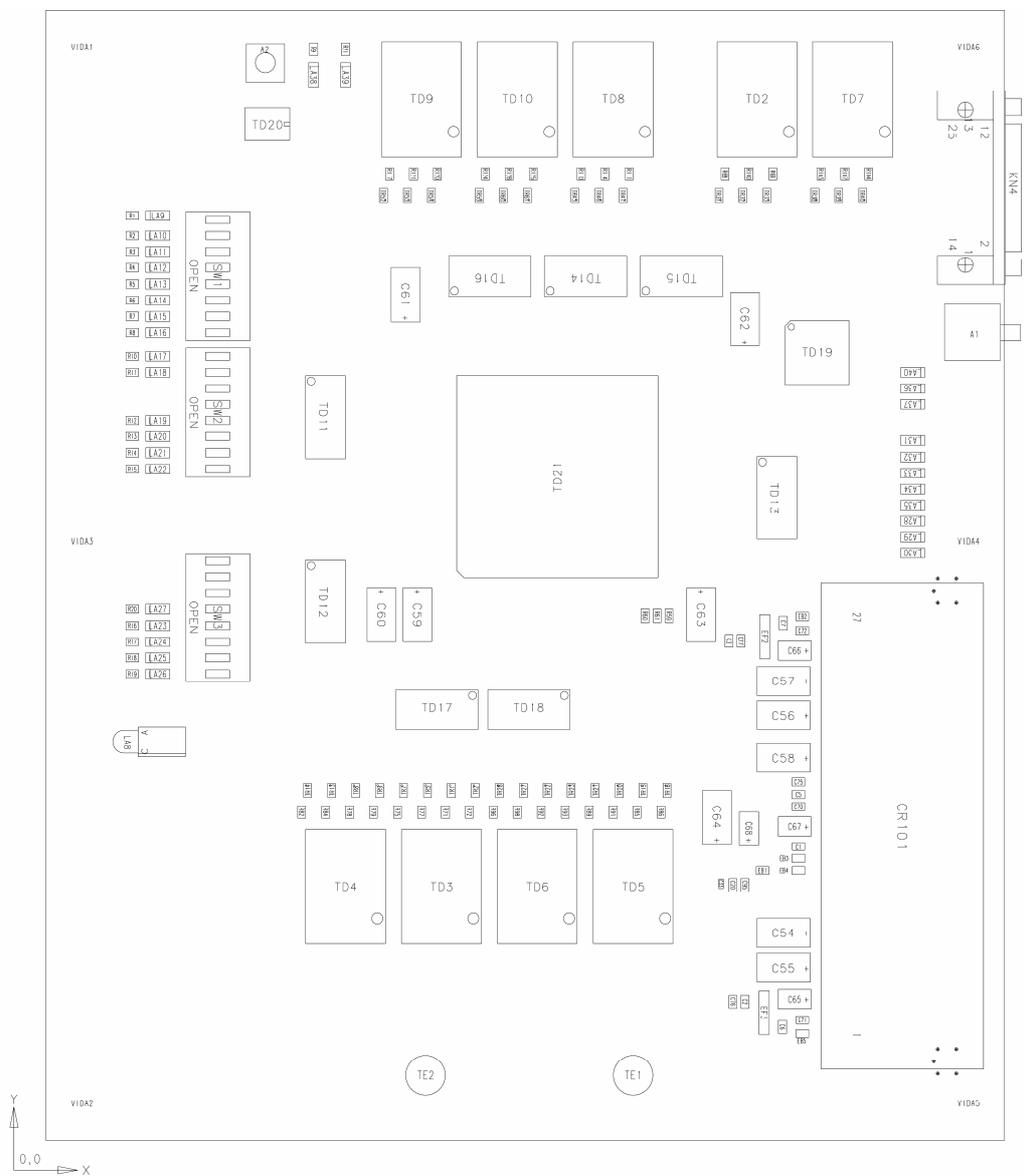
The schematics of the PCB can be seen in Appendix B. Figure 5.1 shows the top view layout of the board and Table 5.1 shows the location references of the main components on the topside of the board.

## **5.1. OPERATION MANUAL**

Figure 5.2 shows the top view of the board with the components placed on it. In this section the direction references are given according to this view of the board.

When the power is given to the board the FPGA will be loaded with the configuration data stored on the EEPROM. Before starting with any operation the START signal must be taken to '0' state, and CLR push-button must be pushed, i.e., set to '0' for a while to initialize the ALU. After initialization operation is completed the input data and function can be selected through the switches. There is a table on the board, which describes the operations implemented according to the selected opcode. The I/O decoding tables was given in chapter 3, section 3.12. When the input data is set their BCD format view can be seen on the seven-segment displays placed on the upper side of the board. The left-most three displays show the REG1 content, while the right-most two displays shows the REG2 content. The operation is initiated by changing the state of the START signal (if '0' set to '1'; if '1' set to '0').

This will generate the necessary request signal for the selected function the output will be displayed both on the output LEDs, residing on the right of the board, and on the seven-segment displays placed on the bottom of the board. For division, the left-most two displays show the quotient and the other two displays shows the remainder. A sample division operation can be seen in Figure 5.3. For multiplication the left-most display is don't cared, and remaining three displays show the product. For other operations the left-most two displays are don't cared, and the result is showed on the right-most two displays.



**Table 5.1** Location references of the main integrated circuits of the PCB

Integrated Circuit	Location reference
FPGA	TD21
EEPROM	TD19
BUFFERS	TD11, TD12, TD13, TD14, TD15, TD16, TD17, TD18
SWITCHES	SW1, SW2, SW3
7-SEGMENT DISPLAYS	TD2, TD3, TD4, TD5, TD6, TD7, TD8, TD9,TD10
SWITCHING VOLTAGE REGULATOR	CR101
POWER TERMINALS	TE1, TE2
DEBOUNCE CIRCUIT	TD20
JTAG INTERFACE CONNECTOR	KN4
PUSH BUTTONS	A1, A2



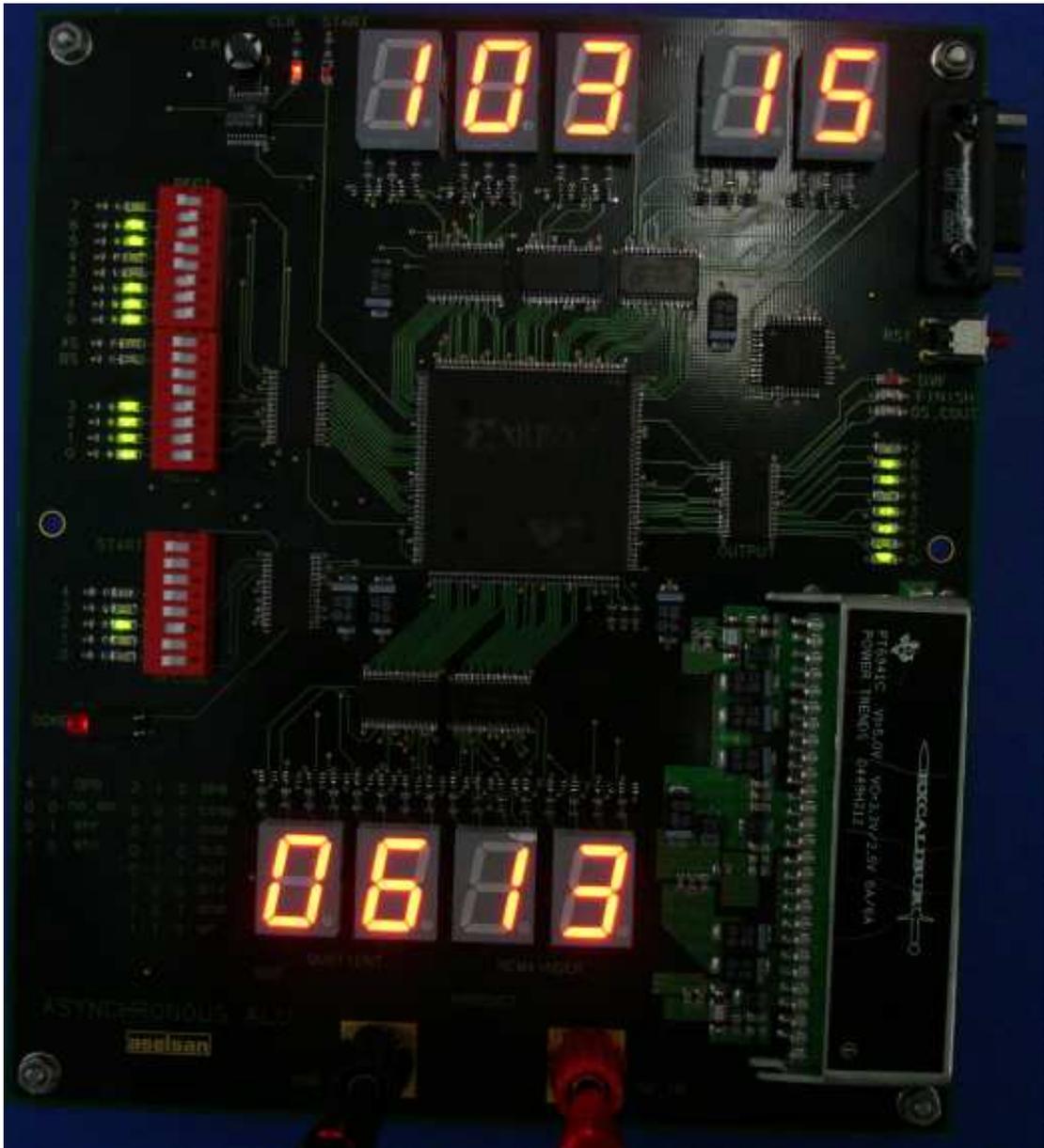


Figure 5.3 A sample operation (103/15, quotient: 6, remainder:13)

## CHAPTER 6

### CONCLUSION

In this thesis an approach for designing asynchronous circuits in commercial FPGAs has been proposed. Also the performance of the asynchronous systems designed in FPGAs have been investigated in terms of logic slices occupied and data latencies by implementing a sample design which is an ALU. The area and speed performance of the asynchronous ALU has been compared with a synchronous ALU having the same functionality as the asynchronous one as well.

The first thing, which must be done before starting with an asynchronous circuit design, is to characterize the hazard behavior of the environment on which the system will be implemented. In this thesis the environment is a Xilinx Virtex series FPGA, XCV300. Xilinx FPGAs are based on LUTs and LUTs have different timing characteristics than simple gates like AND, OR, NAND etc. In this thesis hazard analysis of both gate-level and LUT-based implementations have been investigated. Xilinx's LUT-based FPGAs offer logic hazard-free implementations, but function hazards cannot be eliminated.

The asynchronous ALU designed in this thesis has been implemented in the style of micropipelines. Two-phase transition signaling has been used for control circuits, and bundled-data protocol has been used to handle data timing. For two-phase handshaking protocol a basic cell set has been implemented first. This cell set is hazard-free provided that they satisfy the feedback delay constraint. If the implementation consumes only one logic block of the FPGA, this constraint is satisfied automatically, however if an element is implemented on more than one logic blocks, the delay constraints may not be satisfied automatically by the synthesis tools, and some delay elements need to be inserted. The timing behaviors of the hazard-free cell set elements are kept in upper level instantiations by generating

relationally placed macro (RPM) modules of these elements. Another timing constraint which must be met in self-timed circuits is the bundling constraint, i.e., data must be available before the request arrives. This is also handled by inserting delay elements (chain of inverters) in the paths of control signals. A module satisfying bundling constraint when implemented individually, however, may not keep this property when instantiated in upper blocks, since the placement of the module may be very different when it is instantiated in upper levels than its individual implementation. To prevent this condition incremental design technique can be utilized. In this technique the timing results of the modules remain stable when they are used or combined in upper levels.

When compared the area and speed performances of the asynchronous and synchronous ALUs, the synchronous one has advantages over the asynchronous one. Synchronous design is faster and consumes less FPGA resources. This is mainly due to being commercial FPGAs and FPGA design tools mostly dedicated to synchronous designs. Basic asynchronous design elements are not available in FPGAs and for the design of those elements extra logic blocks are consumed. This increases both the number of logic blocks utilized and hence the latency of the signal propagating through these sources.

This research has showed that commercial FPGAs are not very suitable for asynchronous circuit design. While a synchronous design verified on paper could possibly function correctly when implemented on a FPGA, the asynchronous circuit may not function properly since it may not satisfy the timing constraints after place and route process. Therefore asynchronous circuit design takes more time than the synchronous counterpart. The designer should apply special techniques to keep timing constraints and should assure proper operation for all possible input combinations. The time spent for an asynchronous design even is not worthy, since at the end the design is not advantageous over the synchronous one. The only expected advantage of the asynchronous circuit was that the asynchronous design is still modular. Different modules designed by different designers on the same FPGA could operate correctly when they are combined using incremental design technique.

## REFERENCES

- [1] C. J. Myers, *Asynchronous Circuit Design* : John Wiley & Sons, Inc, 2001
- [2] Stephen H. Unger, *Hazards, Critical Races, and Metastability*, IEEE Transactions on Computers, Vol. 44, No. 6, pp. 754-768, June 1995.
- [3] D. A. Huffman, *The Synthesis of Sequential Switching Circuits*, Journal of the Franklin Institute, March/April 1954.
- [4] D. E. Muller and W. S. Bartky, *A Theory of Asynchronous Circuits*, In Proc. International Symposium on the Theory of Switching, pp. 204-243, Cambridge, MA, April 1959. Harvard University Press.
- [5] Scott Hauck, *Asynchronous Design Methodologies : An Overview*, IEEE Proceedings, Vol. 83 Issue 1, pp. 69-93, January 1995.
- [6] L. A. Hollar, *Direct Implementation of Asynchronous Control Units*, IEEE Transactions on Computers, Vol. C-31, No. 12, pp. 1133-1141, Dec. 1982.
- [7] S. M. Nowick, D. L. Dill, *Automatic Synthesis of Locally-Clocked Asynchronous State Machines*, in Proceedings of ICCAD, pp. 318-321, 1991.
- [8] S. M. Nowick, D. L. Dill, *Synthesis of Asynchronous State Machines Using a Local Clock*, in Proceedings of ICCAD, pp. 192-197, 1991.
- [9] K. Yun, D. Dill, *Automatic Synthesis of 3D Asynchronous State Machines*, in Proceedings of ICCAD, pp. 576-580, 1992.

- [10] K. Yun, D. Dill, S. M. Nowick, *Synthesis of 3D Asynchronous State Machines*, in Proceedings of ICCAD, pp. 346-350, 1992.
- [11] A. J. Martin, *The Limitations to Delay-Insensitivity in Asynchronous Circuits*, in Proceedings of the 1990 MIT Conference on Advanced Research in VLSI, pp.263-278, 1990
- [12] C. E. Molnar, T. P. Fang, F. U. Rosenberger, *Synthesis of Delay-Insensitive Modules*, in Proceedings of the 1985 Chapel Hill Conference on Advanced Research in VLSI, pp 67-86, 1985
- [13] T. Murata, *Petri Nets :Properties, Analysis and Applications*, Proceedings of the IEEE, Vol. 77, No. 4, pp. 541-580, 1989.
- [14] E. Brunvand, R. F. Sproull, *Translating Concurrent Programs into Delay-Insensitive Circuits*, in Proceedings of ICCAD, pp. 262-265, 1989.
- [15] J. C. Ebergen, *Translating Programs into Delay-Insensitive Circuits*, Center of Mathematics and Computer Science, Amsterdam, CWI Tract 56, 1989.
- [16] J. C. Ebergen, *A Formal Approach to Designing Delay-Insensitive Circuits*, Distributed Computing, Vol. 5, No. 33, pp. 107-119, July 1991.
- [17] A. J. Martin, *Programming in VLSI : From Communicating Processes to Delay-Insensitive Circuits*, in UT Year of Programming Institute on Concurrent Programming, C. A. R. Hoare, Ed. MA: Addison Wesley, pp. 1-64, 1989.
- [18] T. A. Chu, C. K. C. Leung, T. S. Wanuga, *A Design Methodology for Concurrent VLSI Systems*, in Proceedings of ICCAD, pp. 407-410, 1985.
- [19] T. A. Chu, *Synthesis of Self-Timed Circuits from Graph-Theoretic Specifications*, M.I.T. Tech. Report MIT/LCS/TR-393, June 1987.

- [20] M. A. Kishinevsky, A. Y. Kondratyev, A. R. Taubin, V. I. Varshavsky, *On Self-Timed Behavior Verification*, in Proceedings of TAU'92, March 1992.
- [21] Ivan E. Sutherland, *Micropipelines*, Communication of ACM, Vol. 32, No. 6, June 1989.
- [22] E. Brunvand, *Using FPGAs to Implement Self-Timed Systems*, Journal of VLSI Signal Processing, Vol. 6, pp. 173-190, 1993, Special Issue on FPGAs.
- [23] K. Maheswaran, *Implementing Self-Timed Circuits in Field Programmable Gate Arrays*, MS Thesis, UC Davis, 1995.
- [24] S. W. Moore, P. Robinson, *Rapid Prototyping of Self-Timed Circuits*, University of Cambridge, in Proceedings of ICCD'98, 5-7 October in Austin Texas.
- [25] Q. T. Ho, J.-B. Rigaud, L. Fesquet, M. Renaudin, R. Rolland, *Implementing Asynchronous Circuits on LUT Based FPGAs*, in Proceedings of 12th Conference on Field Programmable Logic Applications, September 2002.
- [26] A. V. D. Duc, J.-B. Rigaud, A. Rezzag, A. Sirianni, J. Fragoso, L. Fesquet, M. Renaudin, *TAST*, ACiD Workshop, Munich, Germany, January 2002.
- [27] S. Hauck, S. Burns, G. Borriello, C. Ebeling, *A FPGA for Implementing Asynchronous Circuits*, IEEE Design and Test of Computers, Vol. 11, No. 3, pp. 60-69, 1994.
- [28] B. Gao, *A Globally Asynchronous Locally Synchronous Configurable Logic Array Architecture for Algorithm Embeddings*, PhD thesis, University of Edinburgh, December 1996.
- [29] R. Payne, *Self-Timed Field Programmable Gate Array Architectures*, PhD thesis, University of Edinburgh, 1997.

- [30] J. Teifel, R. Manohar, *Programmable Asynchronous Pipeline Arrays*, in Proceedings of 13th Int. Conference on Field Programmable Logic and Applications, pp. 345-354, Lisbon, Portugal, September 2003.
- [31] N. Huot, H. Dubreuil, L. Fesquet, M. Renaudin, *FPGA Architecture for Multi-Style Asynchronous Logic*, in Proceedings of Design, Automation and Test in Europe, 2005.
- [32] E. Brunvand, W. F. Richardson, *The NSR Processor Prototype*, Technical Report UUCS--92--029, University of Utah, August 1992.
- [33] F. Prosser, D. Winkel, E. Brunvand, *A Comparison of modular Self-Timed Design Styles*, University of UTAH, 1995.
- [34] Virtex 2.5V Field Programmable Gate Arrays, Complete Data Sheet, v.2.5, April 2, 2001.
- [35] McCluskey E.J., *Introduction to the Theory of Switching Circuits*, Mc-Graw Hill, New York, 1965.
- [36] E. B. Eichelberger, *Hazard Detection in Combinational and Sequential Switching Circuits*, IBM Journal of Research and Development, No. 9, pp. 90-99, March 1965.
- [37] K. Y. Yun and D. L. Dill, *Automatic Synthesis of Extended Burst-Mode Circuits I: Specification and Hazard-Free Implementation*, IEEE Transactions on Computer-Aided Design, Vol. 18, No. 2, pp. 101-117, February 1999.
- [38] M. Morris Mano, *Computer System Architecture*, Third Edition, Prentice Hall, 1993.

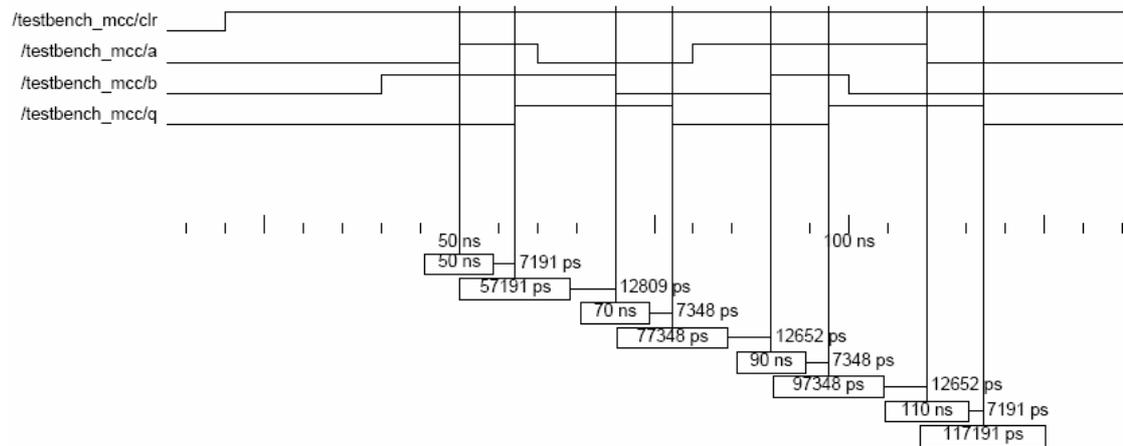
[39] Xilinx Application Note 422 (Ver 2.0), *Creating RPMs Using 6.2i Floorplanner*, Xilinx, March 10, 2004.

[40] Xilinx Application Note 418 (Ver 1.2), *Xilinx 5.1i Incremental Design Flow*, Xilinx, August 25, 2003.

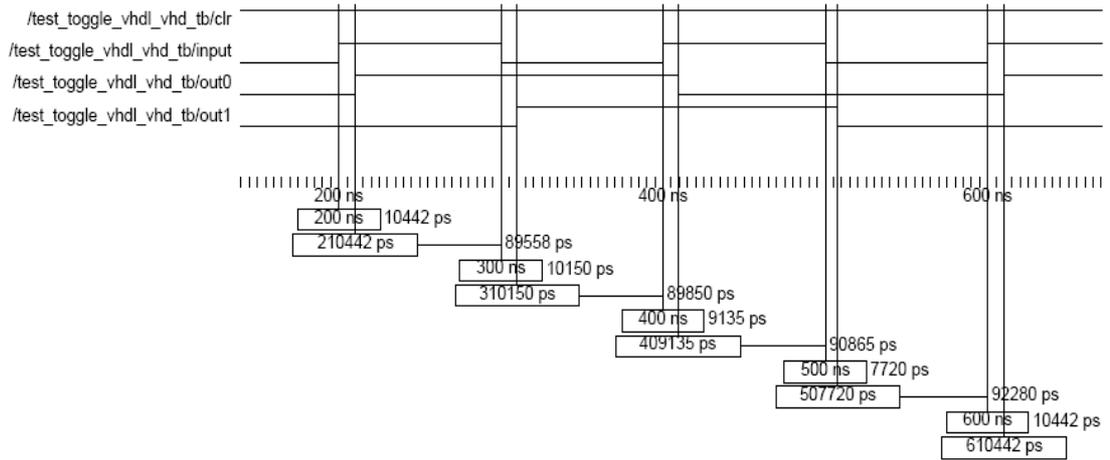
## APPENDIX A

### A. SIMULATION WAVEFORMS OF ASYNCHRONOUS MODULES

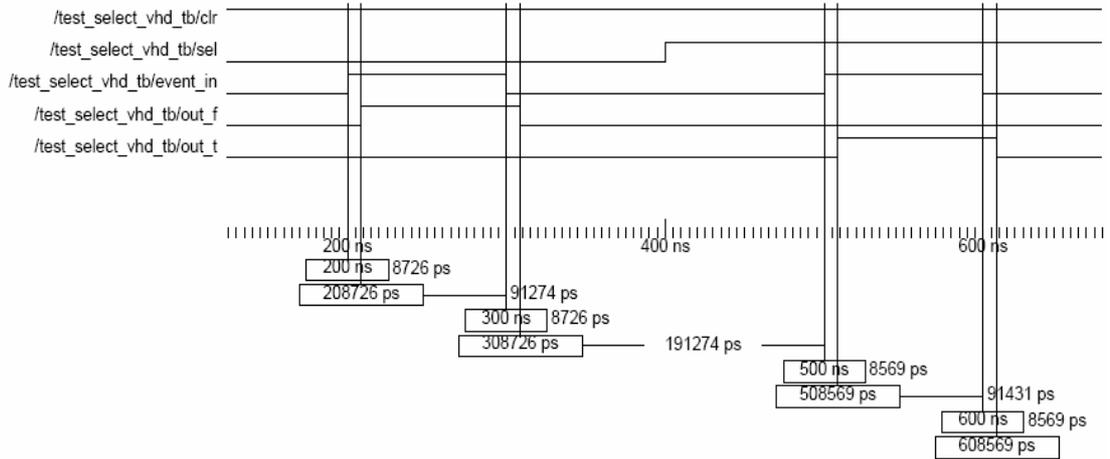
In the following waveforms, the declaration given in front of each signal represents the name of the testbench file (between two slashes) and the port name of the unit under test. The vertical bars are time cursors. The simulation time where the cursors exist is shown in the squares under the corresponding cursor. The time difference between two consecutive cursors is given near the second cursor for each cursor pair.



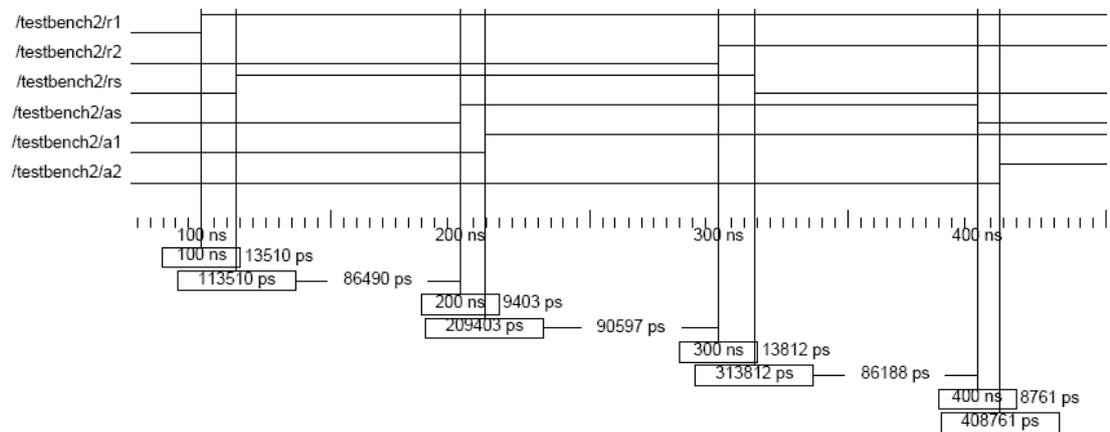
**Figure A.1.** Simulation Waveform for Muller-C (1 slice)



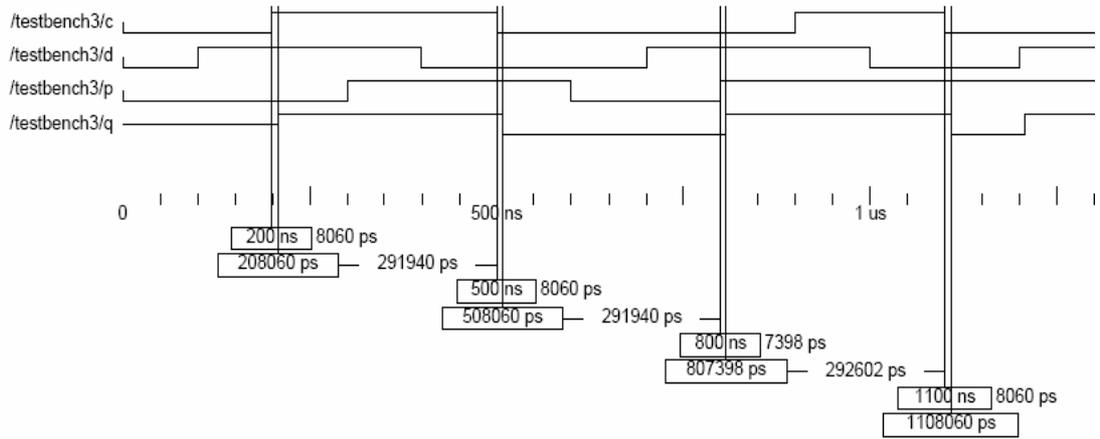
**Figure A.2.** Simulation Waveform for TOGGLE (4 slices)



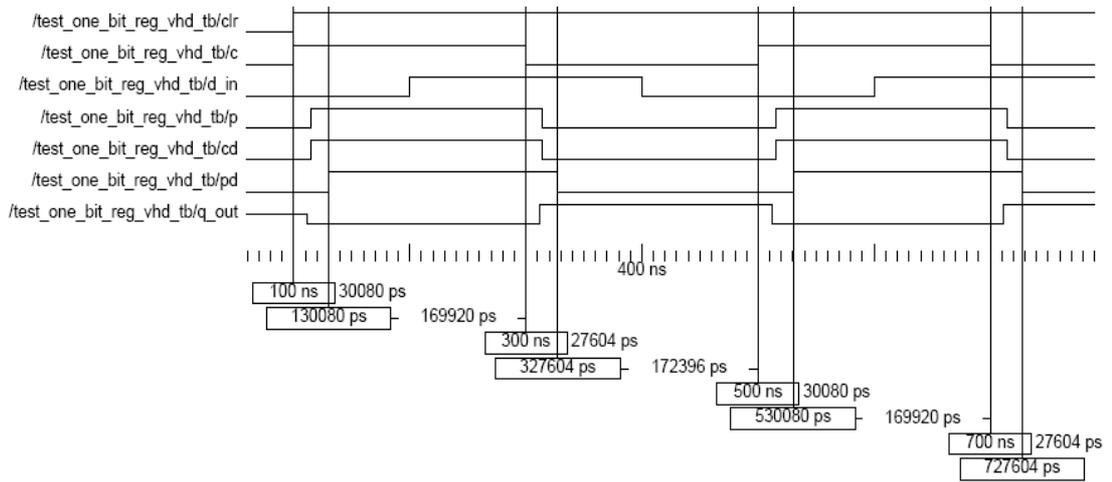
**Figure A.3.** Simulation Waveform for SELECT (2 slices)



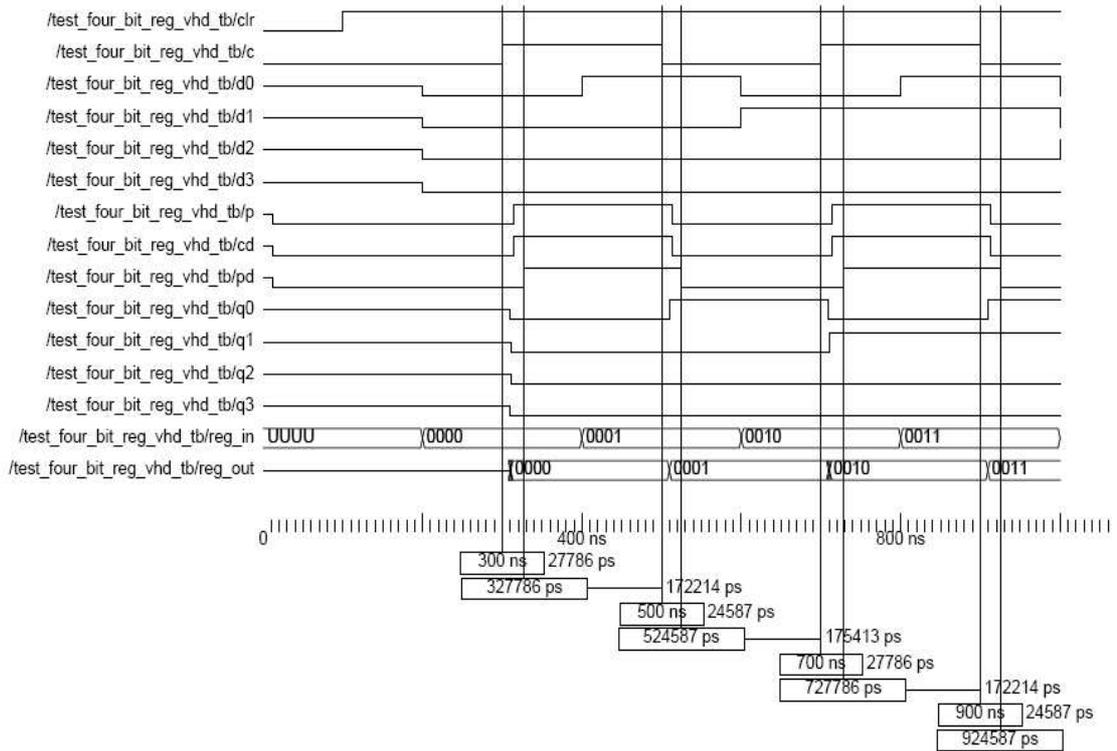
**Figure A.4.** Simulation Waveform for CALL (2 slices)



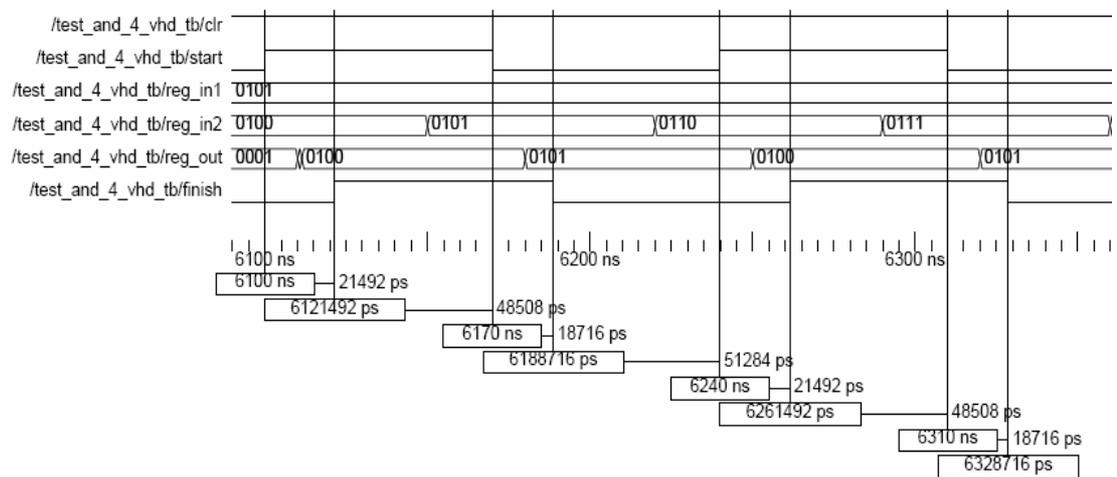
**Figure A.5.** Simulation Waveform for OPAQUE LATCH (1 slice)



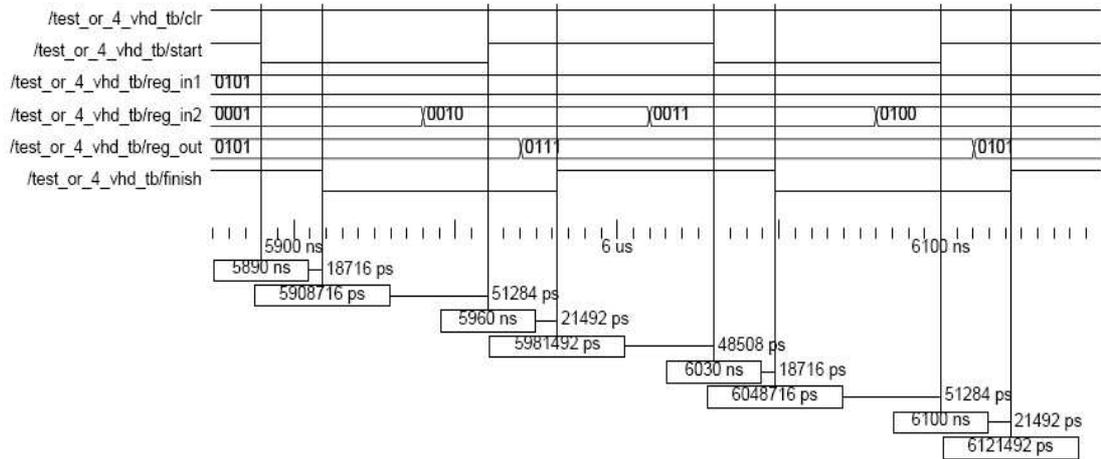
**Figure A.6.** Simulation Waveform for ONE-BIT REGISTER (6 slices)



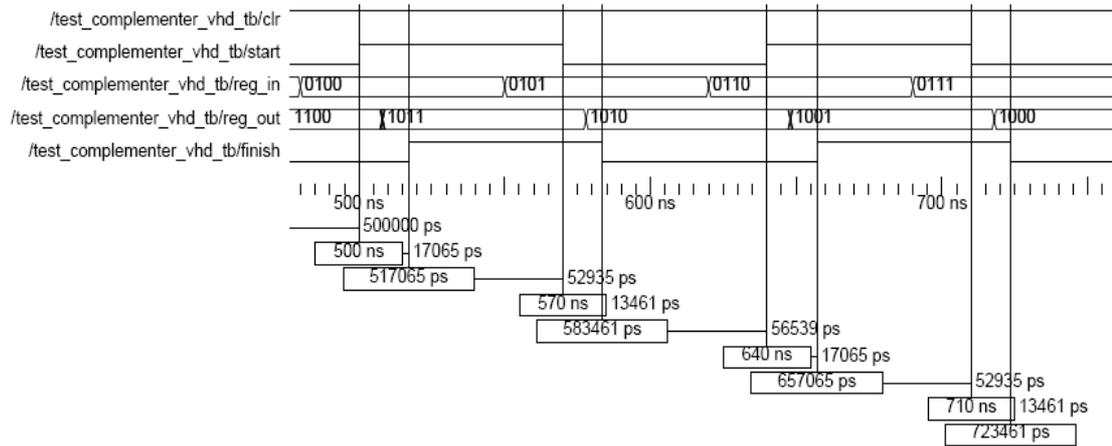
**Figure A.7.** Simulation Waveform for FOUR-BIT REGISTER (9 slices)



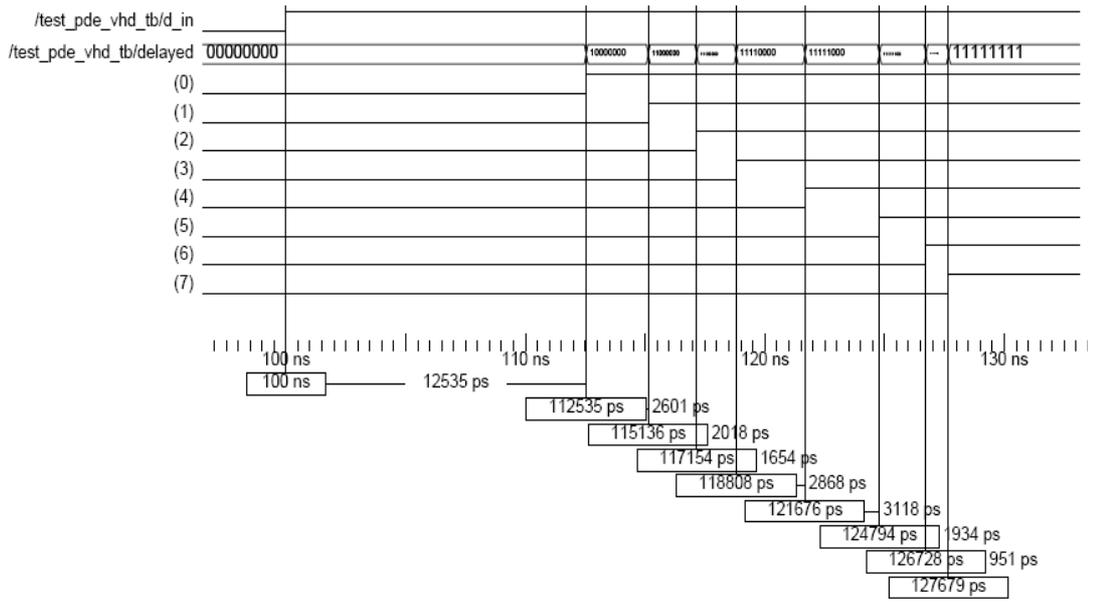
**Figure A.8.** Simulation Waveform for FOUR-BIT AND (13 slices)



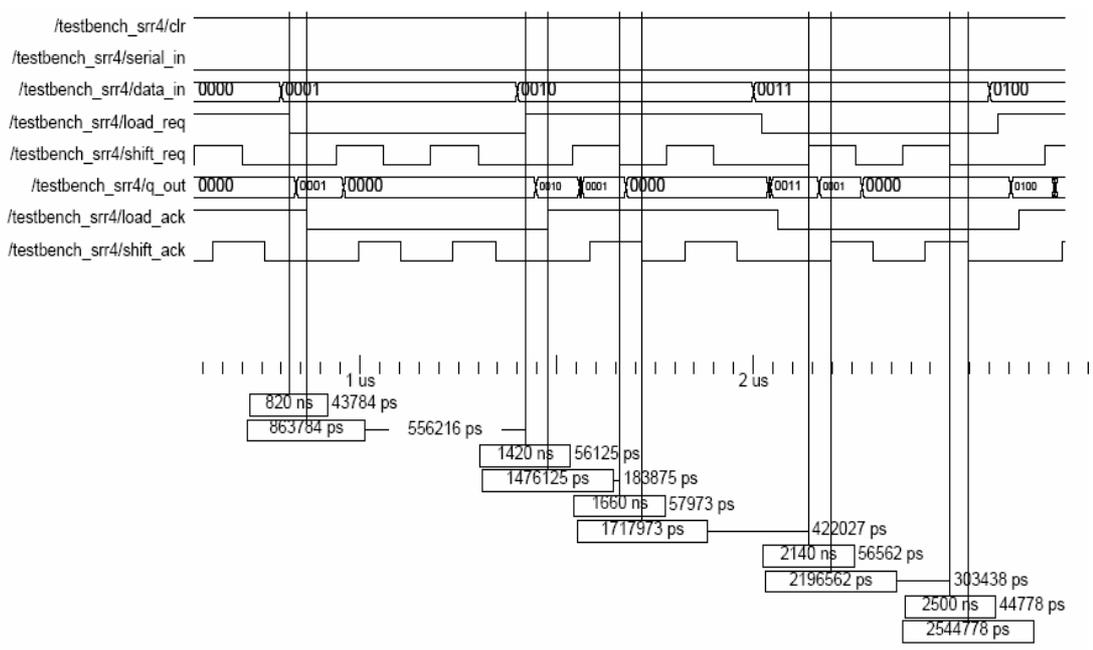
**Figure A.9.** Simulation Waveform for FOUR-BIT OR (13 slices)



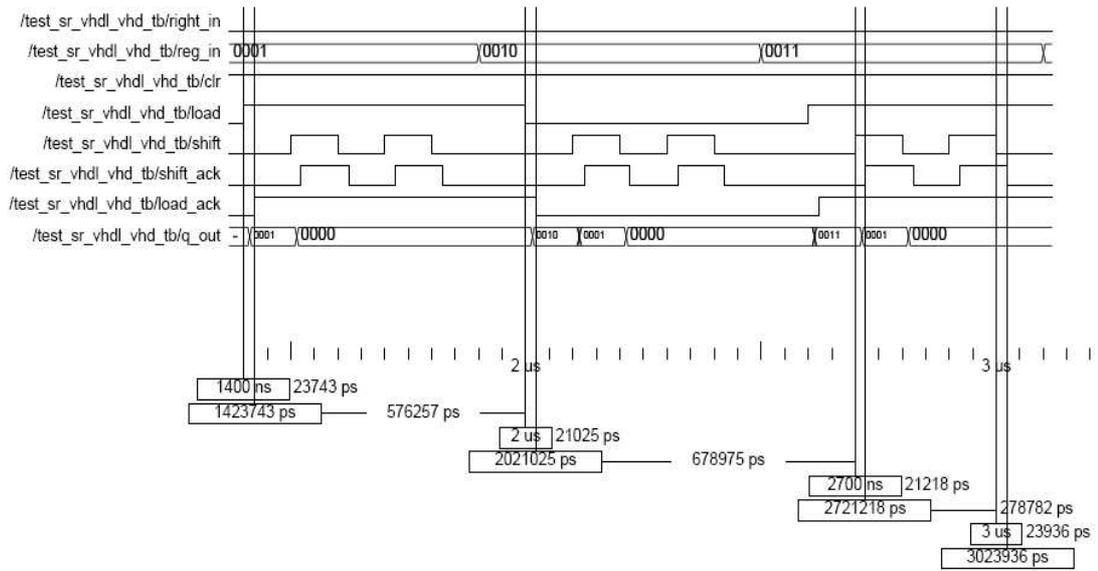
**Figure A.10.** Simulation Waveform for FOUR-BIT COMPLEMENT (13 slices)



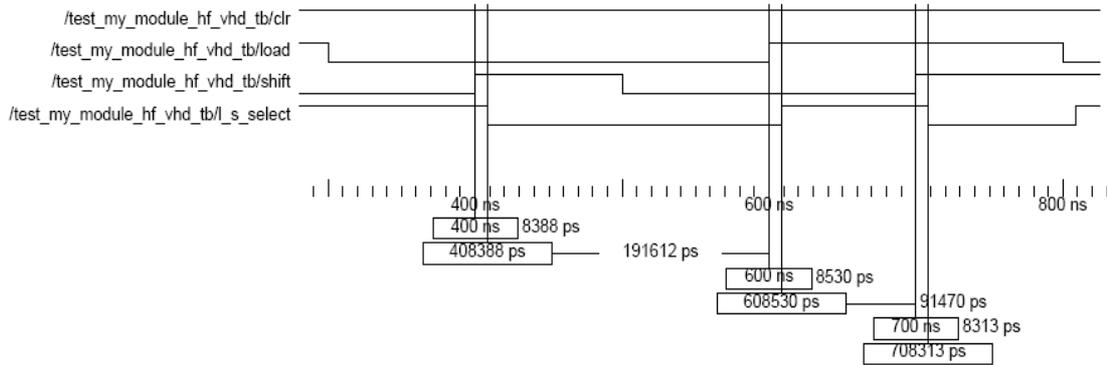
**Figure A.11.** Simulation Waveform for PDE (16 slices)



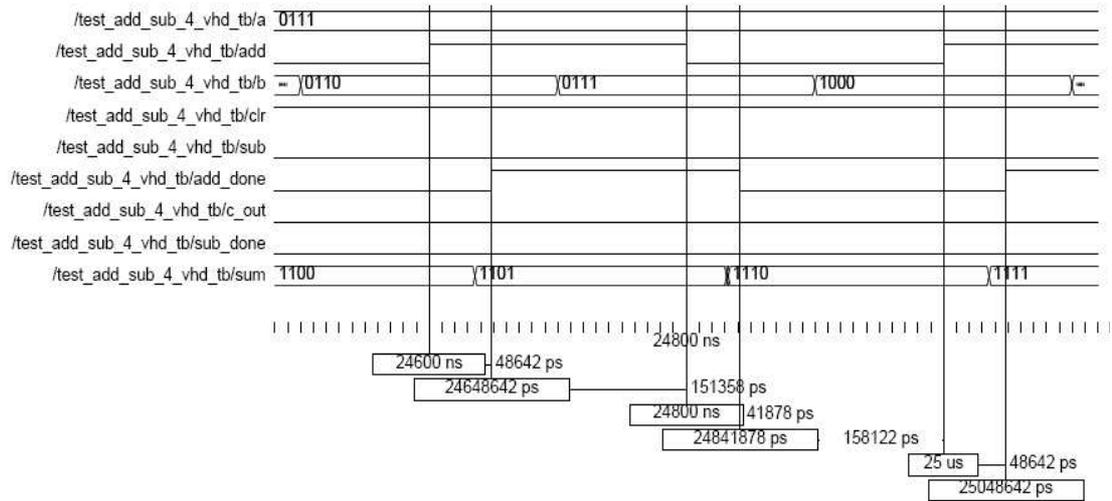
**Figure A.12.** Simulation Waveform for LOADABLE SHIFT REGISTER (Type 1)  
(44 slices)



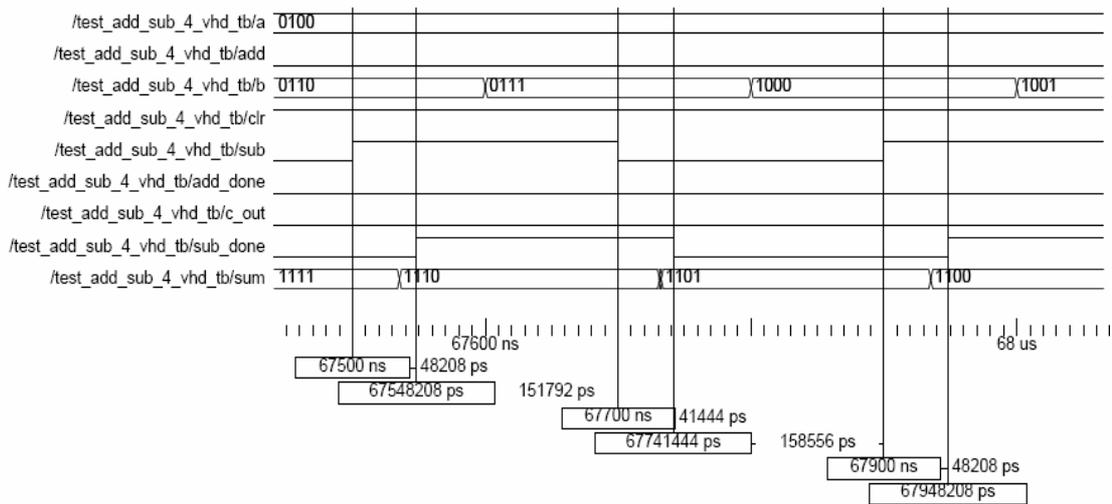
**Figure A.13.** Simulation Waveform for LOADABLE SHIFT REGISTER (Type 2)  
(34 slices)



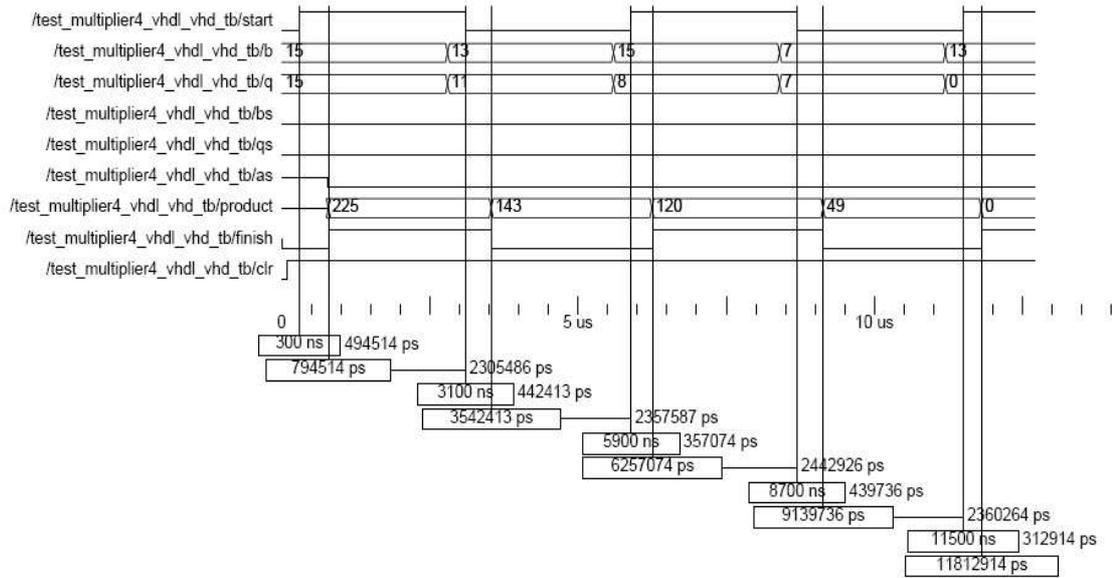
**Figure A.14.** Simulation Waveform for MY\_MODULE\_HF (2 slices)



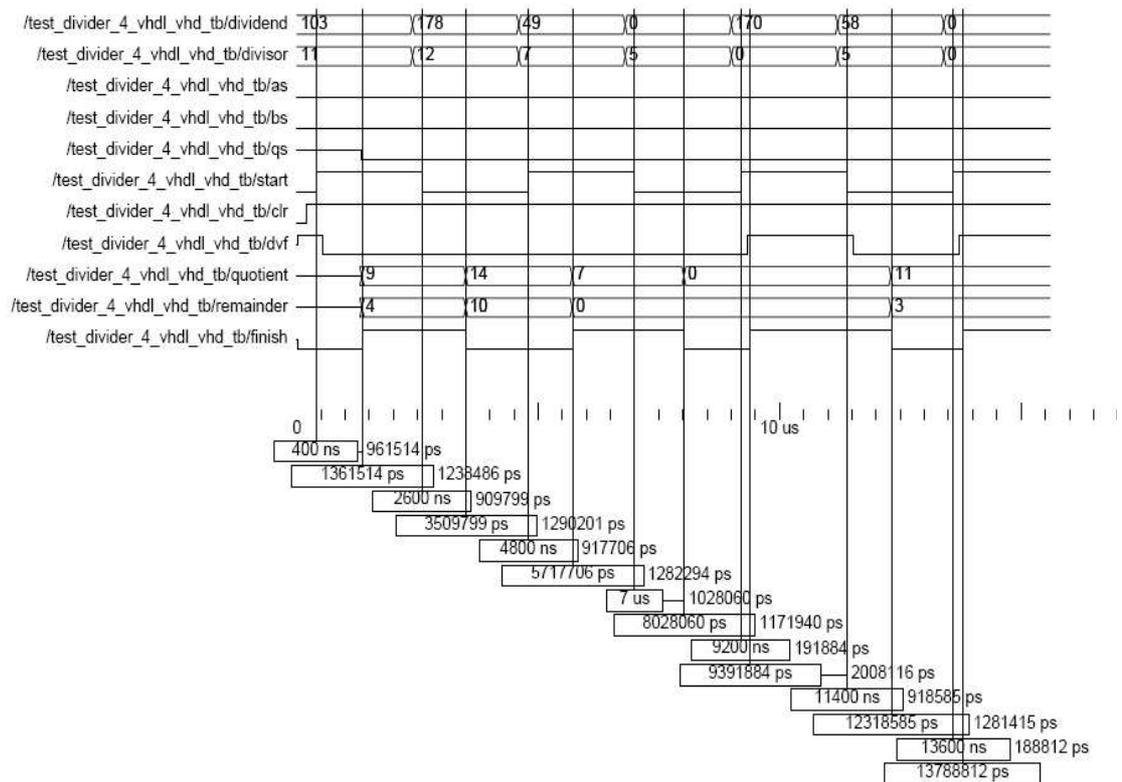
**Figure A.15.** Simulation Waveform for ADD/SUB (addition) (81 slices)



**Figure A.16.** Simulation Waveform for ADD/SUB (subtraction) (81 slices)



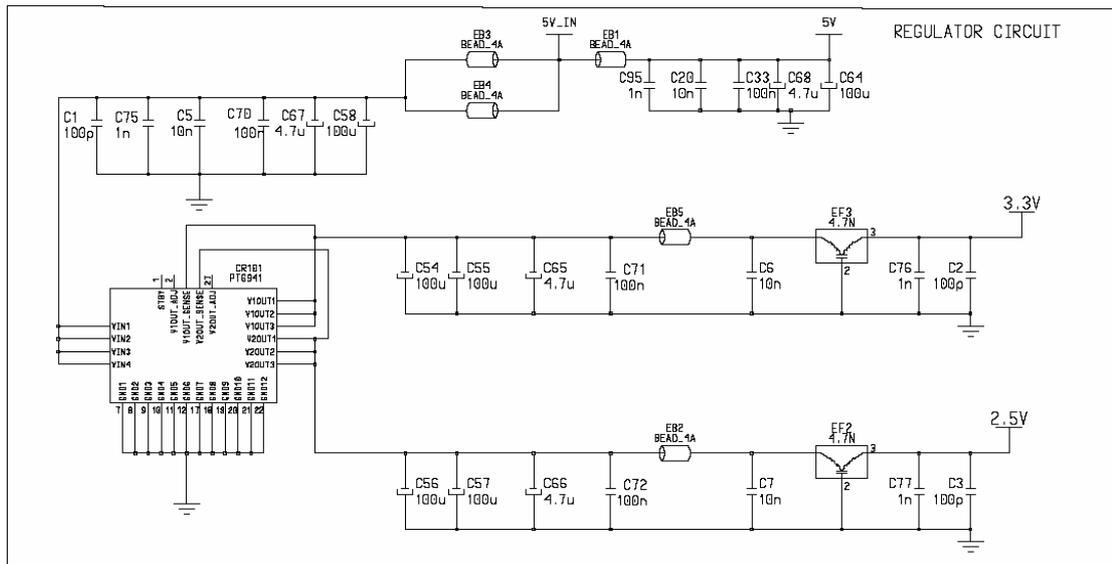
**Figure A.17.** Simulation Waveform for MULTIPLIER (232 slices)



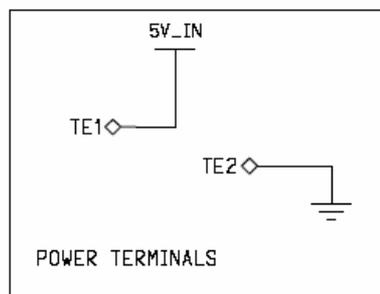
**Figure A.18.** Simulation Waveform for DIVIDER (328 slices)

## APPENDIX B

### B. CIRCUIT SCHEMATICS OF THE IMPLEMENTED PCB



**Figure B.1** Regulator Circuit



**Figure B.2** Power Terminals

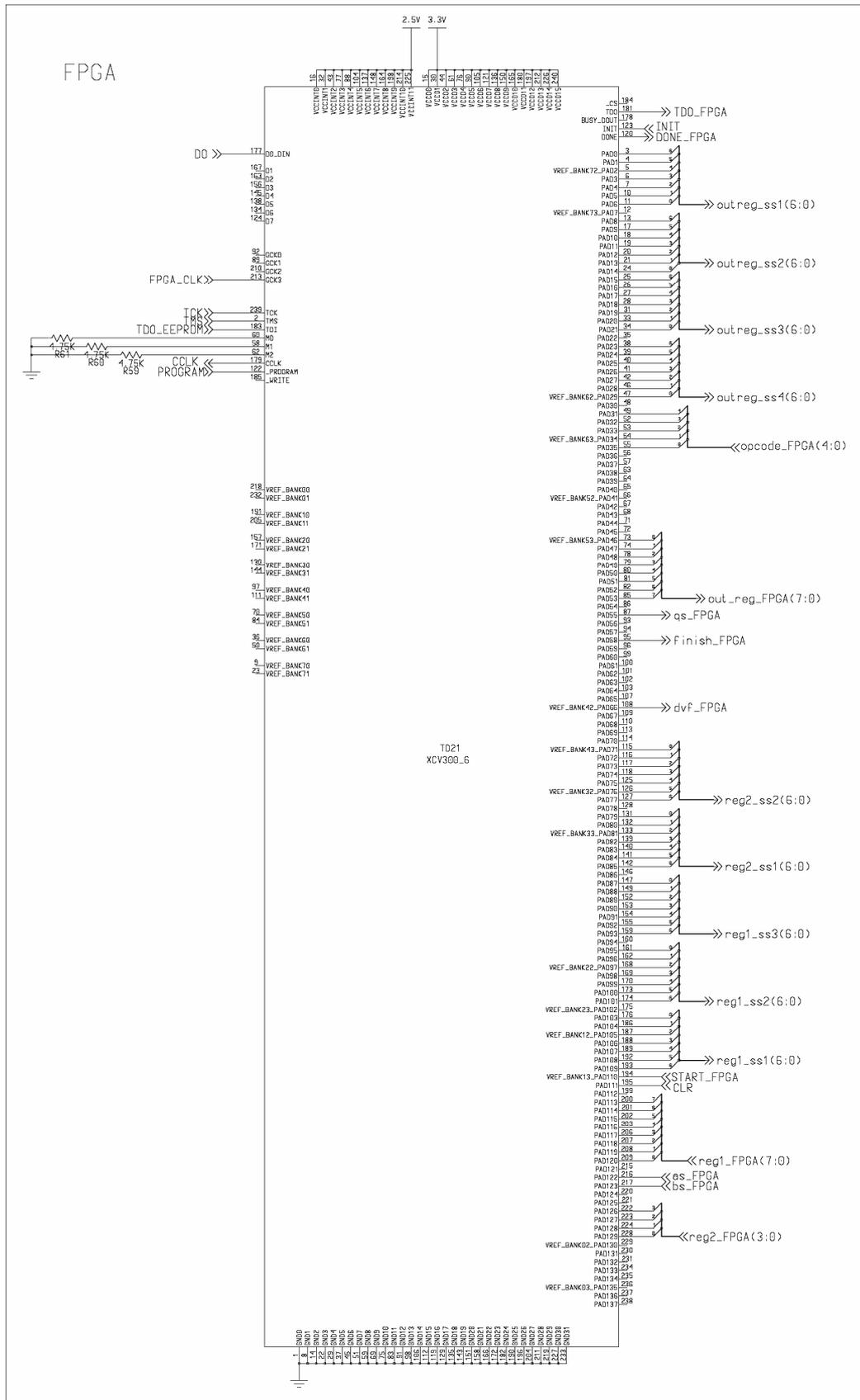


Figure B.3 FPGA

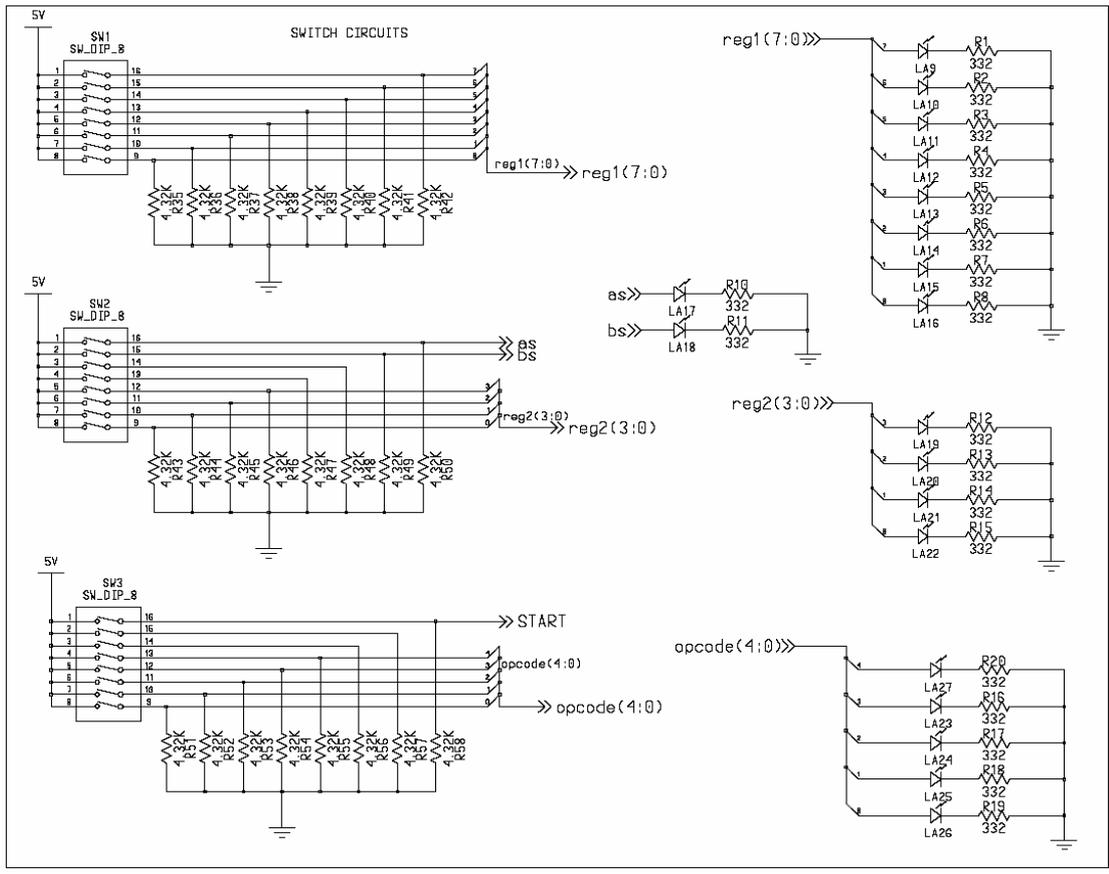


Figure B.4 Input Switches and LEDs

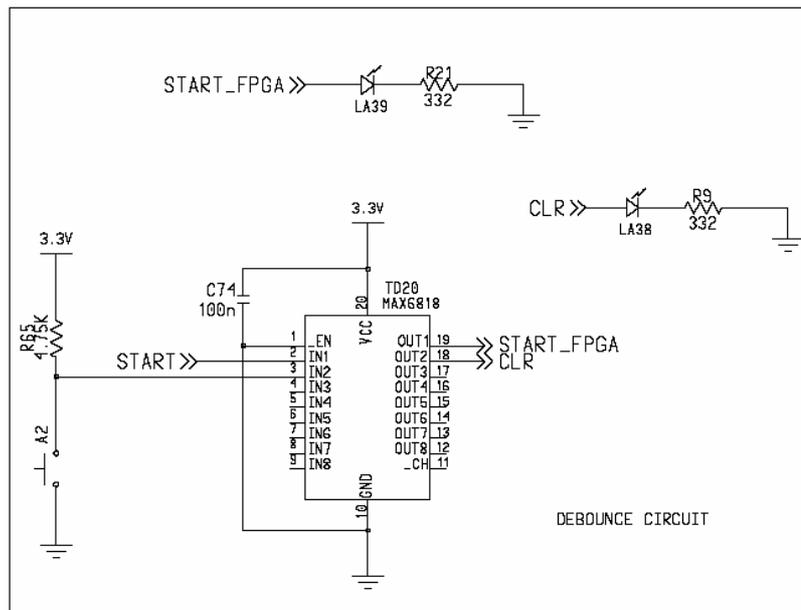


Figure B.5 Debounce Circuit

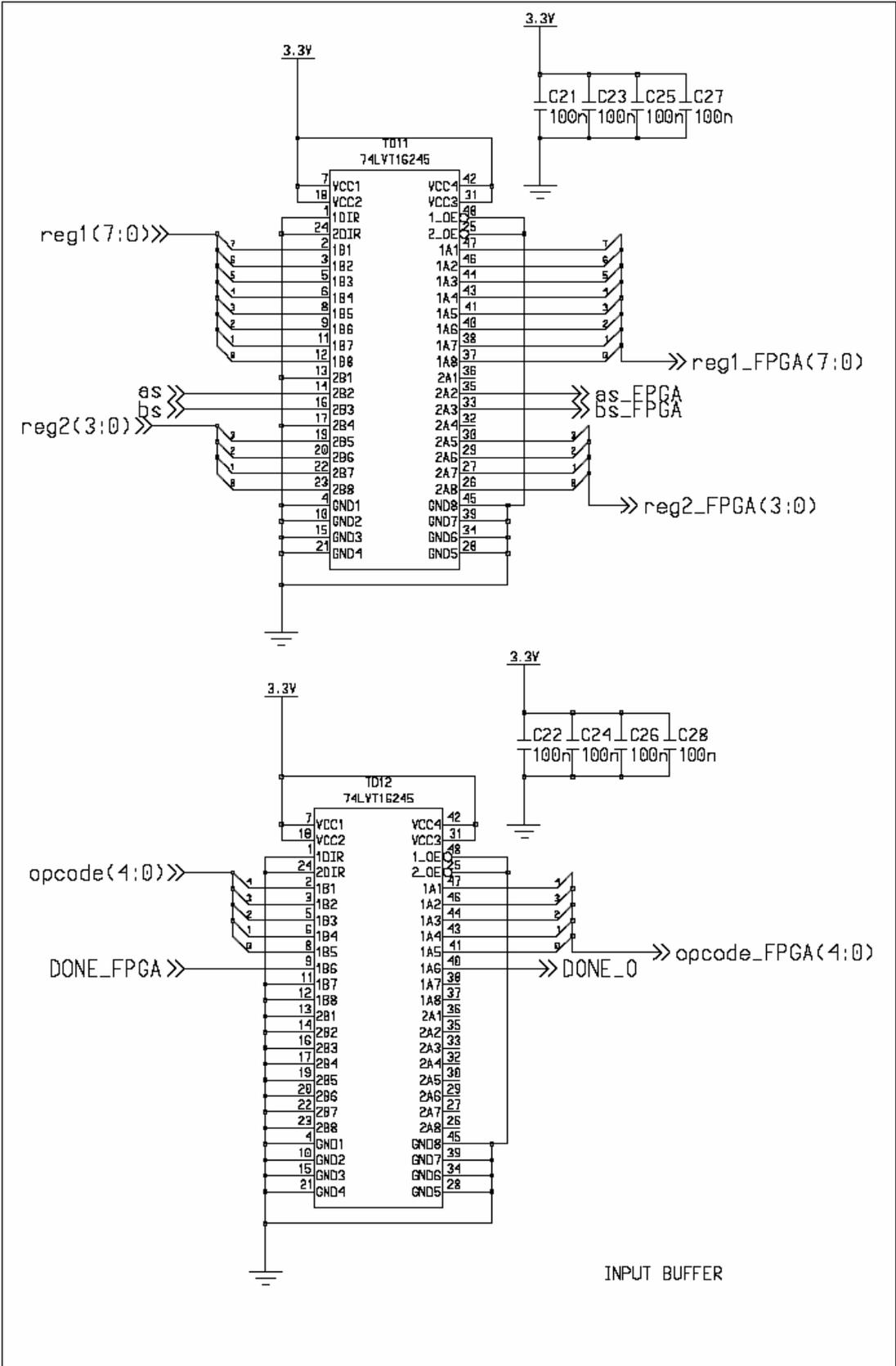
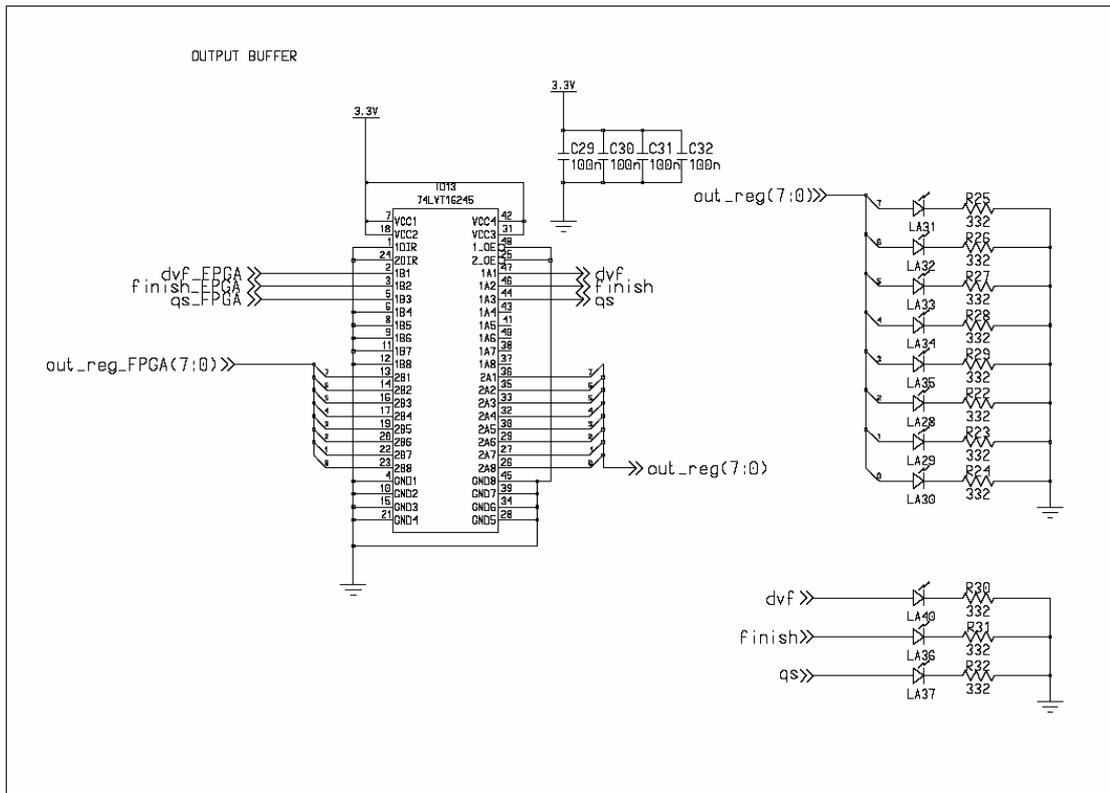
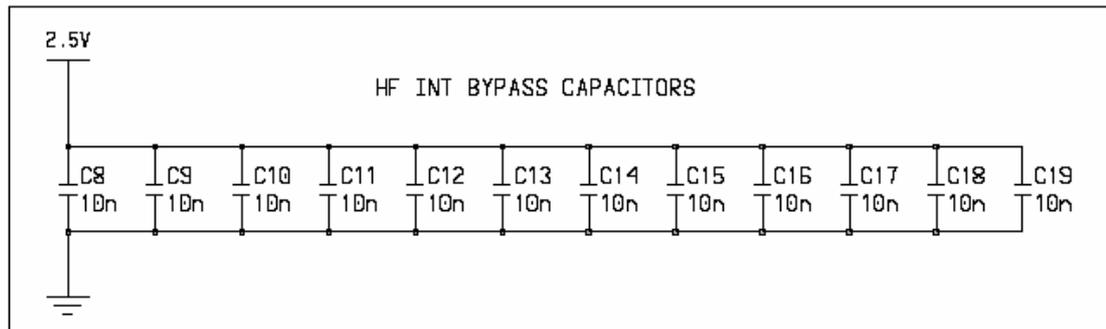


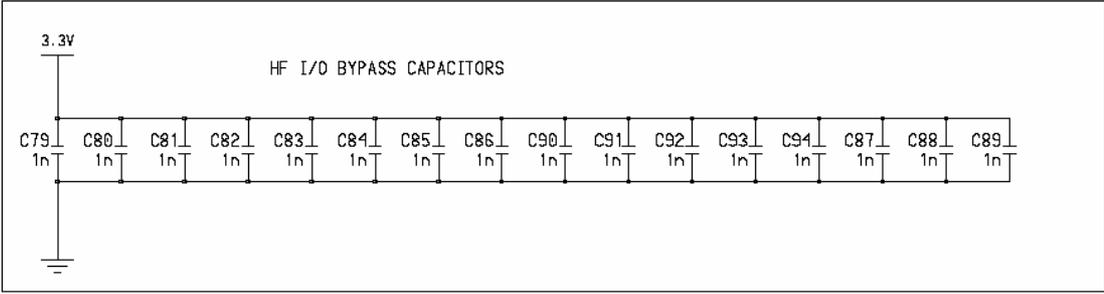
Figure B.6 Input Buffers



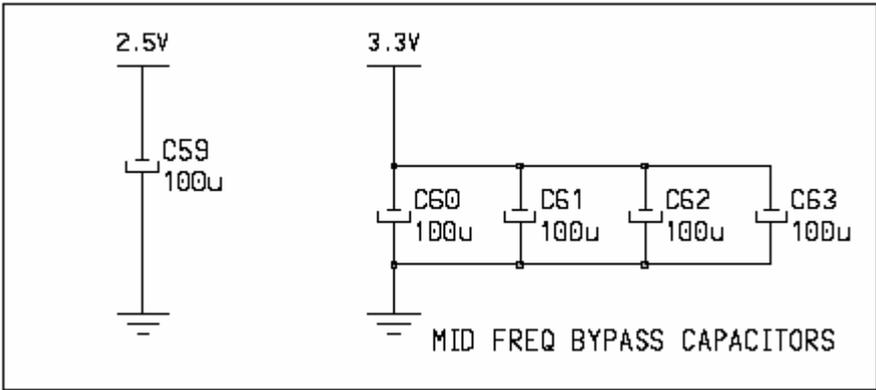
**Figure B.7** Output Buffer and LEDs



**Figure B. 8** High Frequency Integrated Circuit Bypass Capacitors



**Figure B.9** High Frequency I/O Bypass Capacitors



**Figure B.10** Mid-frequency Bypass Capacitors

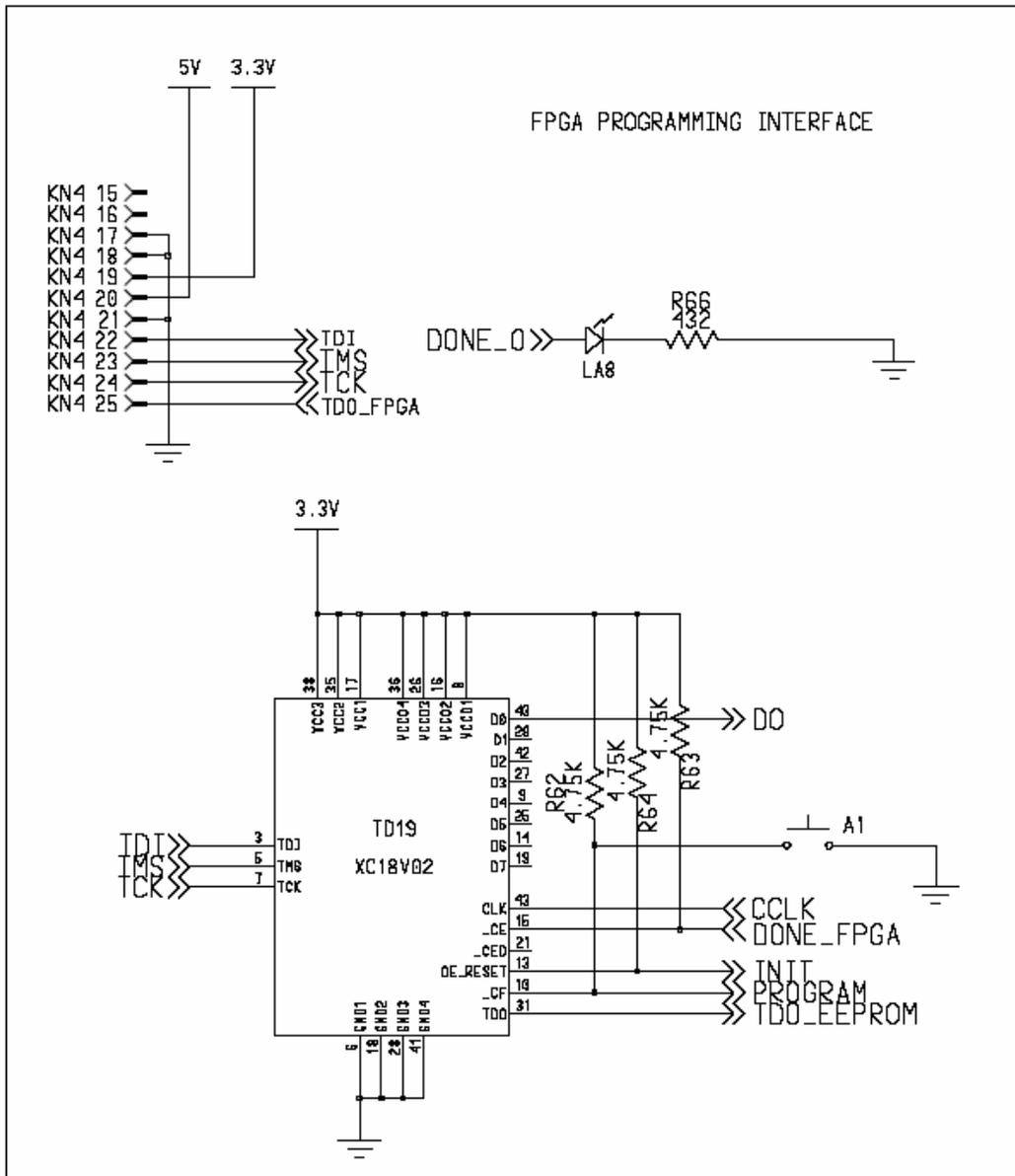
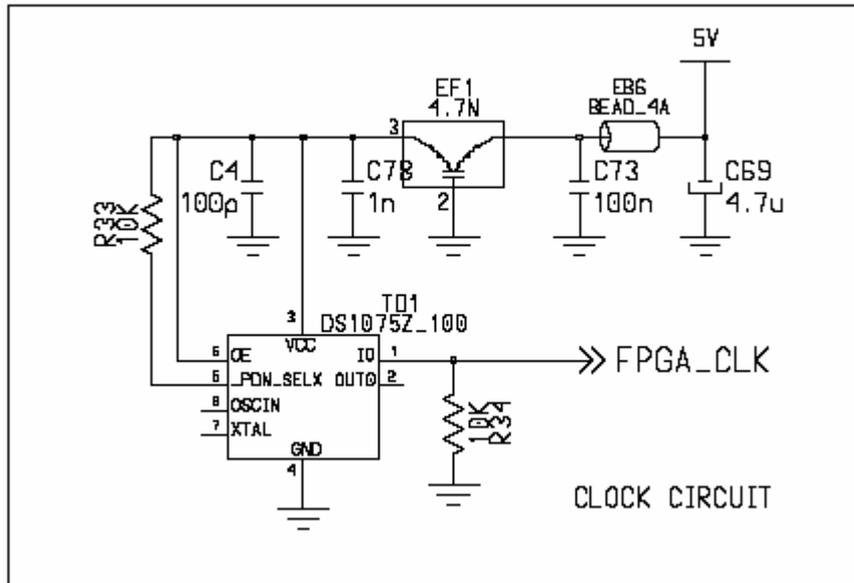


Figure B.11 FPGA Programming Interface



**Figure B.12** Clock Circuit for Synchronous Operation Option

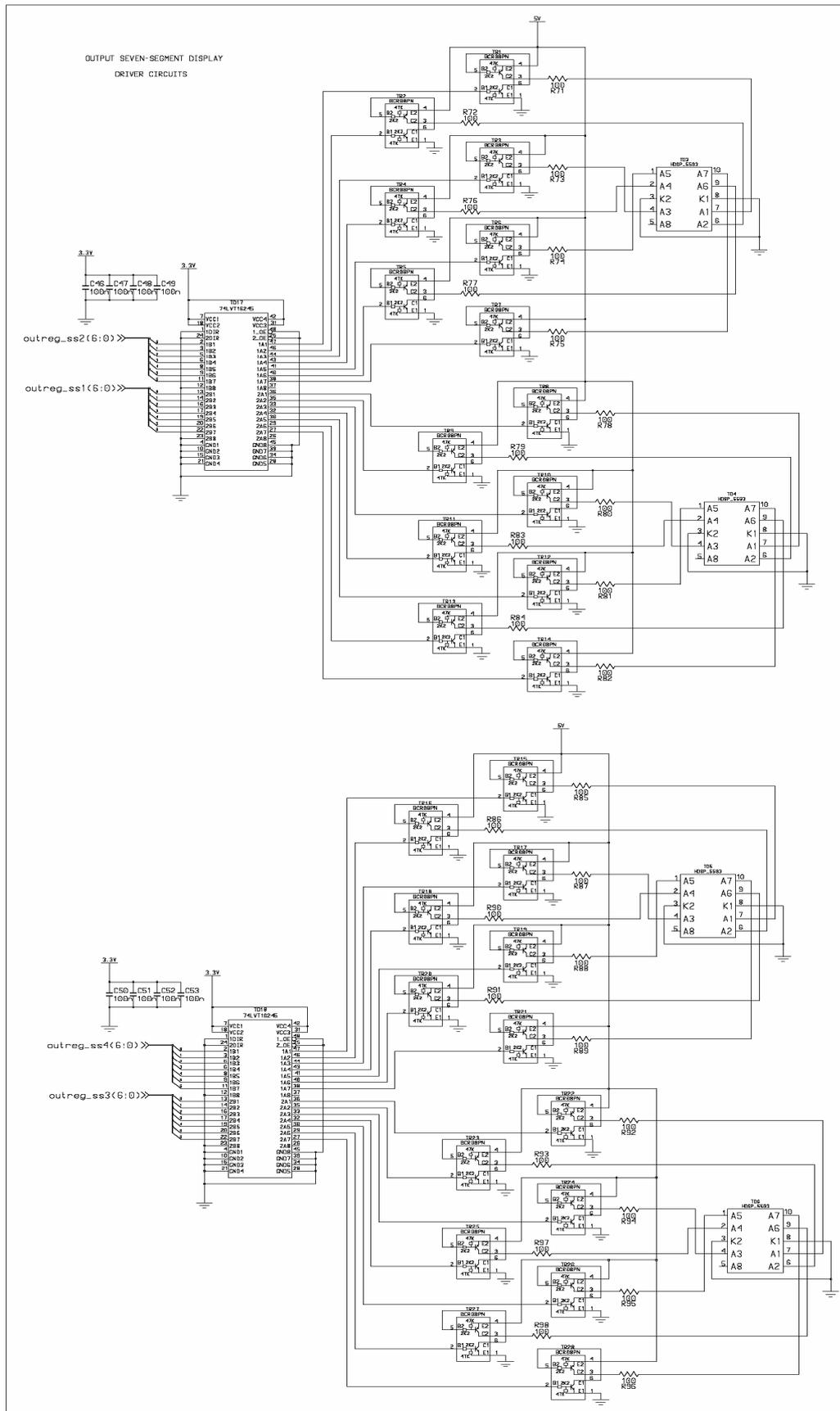
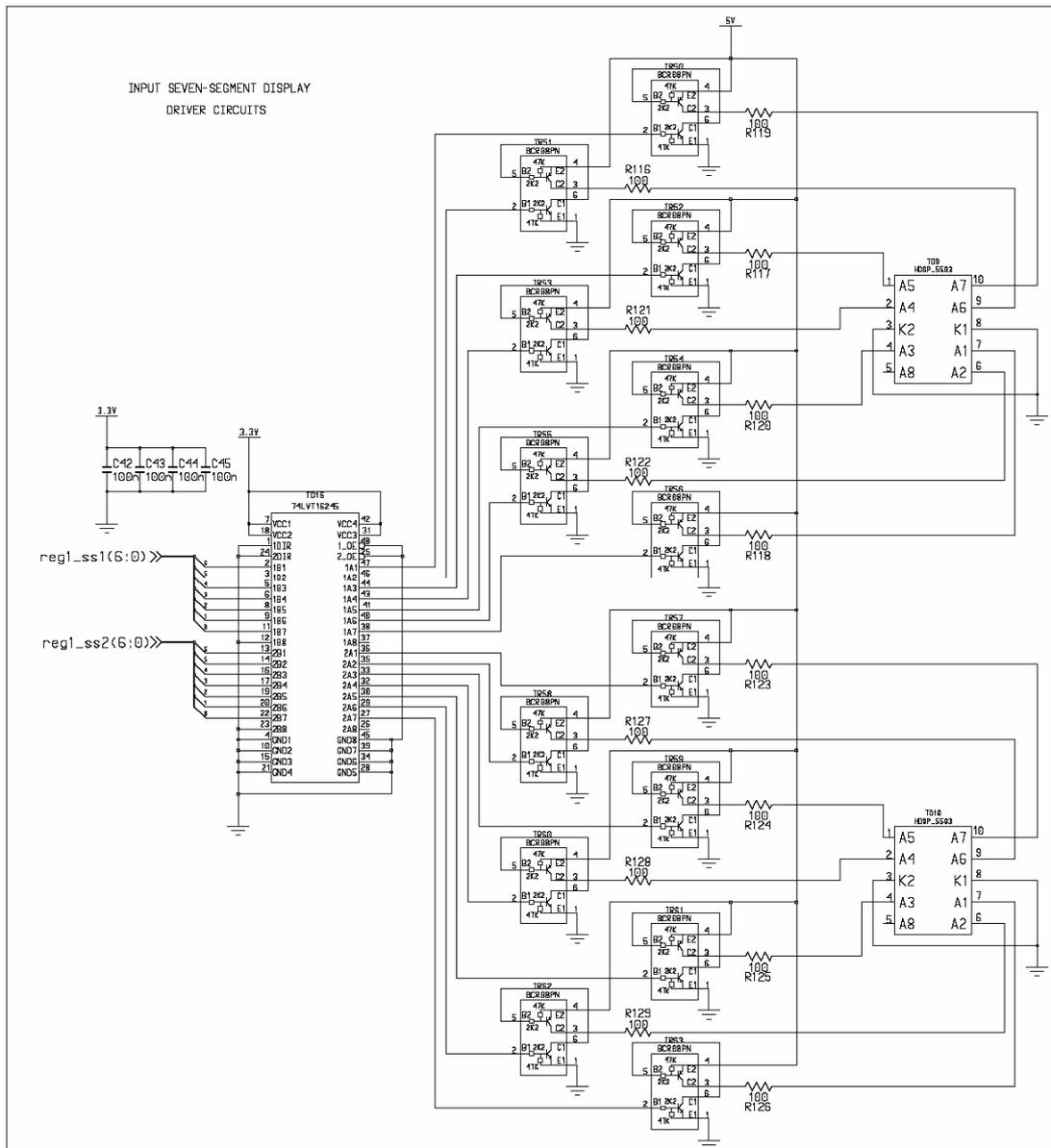


Figure B.13 Output Seven-Segment Displays and Driver Circuits



**Figure B.14** Input Seven-Segment Displays and Driver Circuits

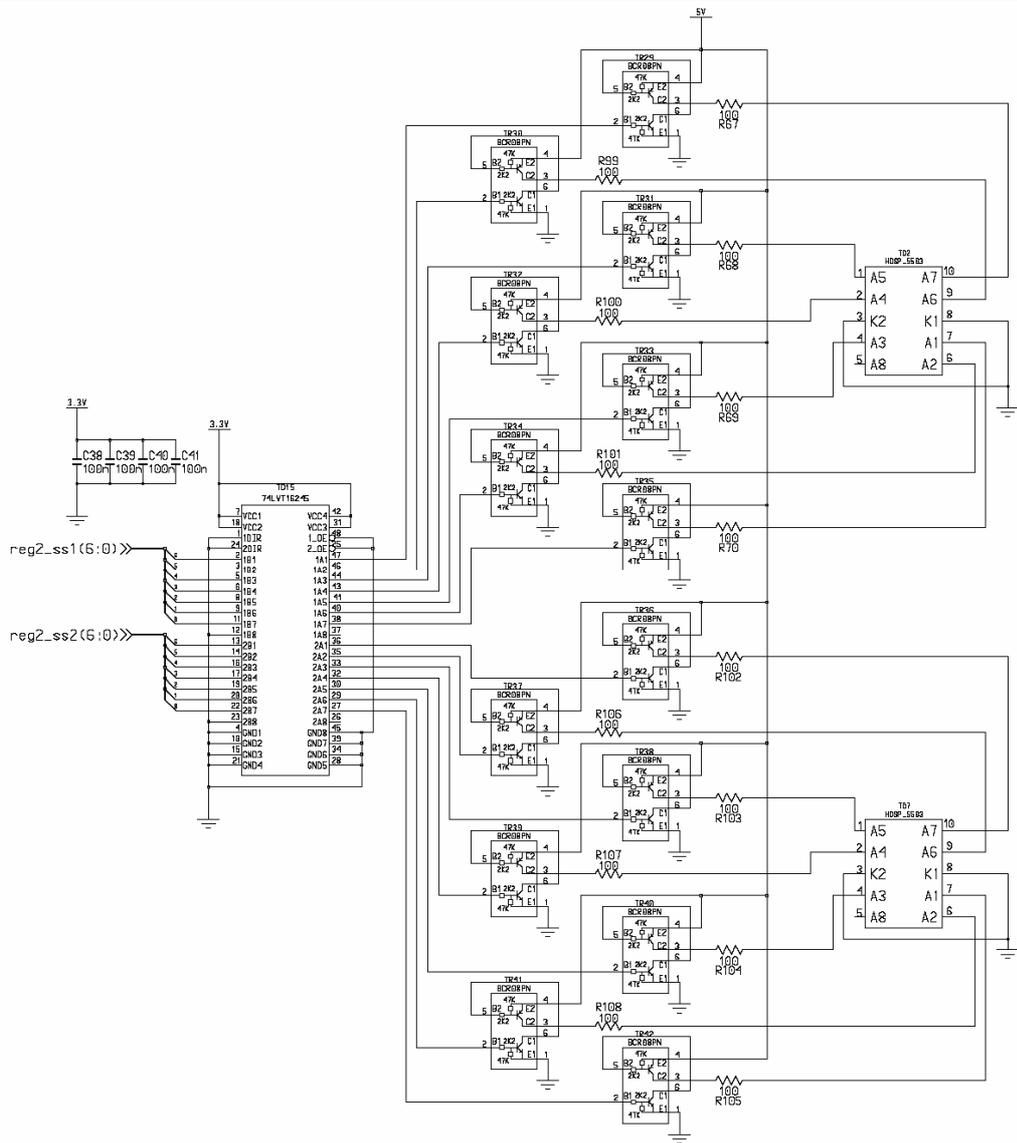


Figure B.14 (continued)

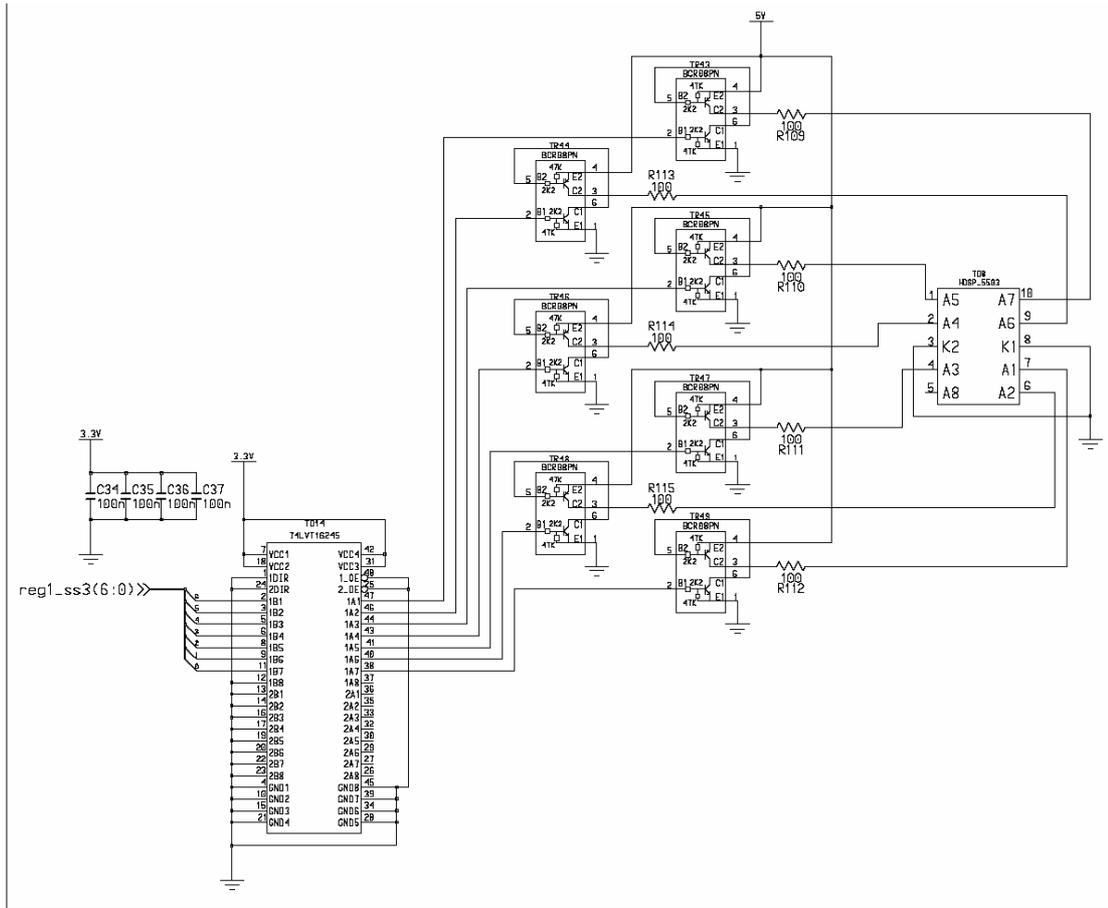


Figure B.14 (continued)

## **APPENDIX C**

### **C. DESIGN FILES**